



Standard Practice for Sampling a Stream of Product by Variables Indexed by AQL¹

This standard is issued under the fixed designation E2762; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon (ϵ) indicates an editorial change since the last revision or reapproval.

1. Scope

1.1 *Purpose*—This practice establishes lot or batch sampling plans and procedures for inspection by variables using MIL-STD-414 as a basis for sampling a steady stream of lots indexed by AQL.

1.2 This practice provides the sampling plans of MIL-STD-414 in ASTM format for use by ASTM committees and others. It recognizes the continuing usage of MIL-STD-414 in industries supported by ASTM. Most of the original text in MIL-STD-414 is preserved in Sections 6 – 9 of this practice.

1.3 The values stated in inch-pound units are to be regarded as standard. No other units of measurement are included in this standard.

1.4 *This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.*

2. Referenced Documents

2.1 ASTM Standards:²

E456 Terminology Relating to Quality and Statistics

E2234 Practice for Sampling a Stream of Product by Attributes Indexed by AQL

E2586 Practice for Calculating and Using Basic Statistics

2.2 Other Standards:³

MIL-STD-414 Sampling Procedures and Tables for Inspection by Variables for Percent Defective

MIL-STD-105E Sampling Procedures and Tables for In-

¹ This practice is under the jurisdiction of ASTM Committee E11 on Quality and Statistics and is the direct responsibility of Subcommittee E11.30 on Statistical Quality Control.

Current edition approved April 1, 2014. Published May 2014. Originally approved in 2010. Last previous edition approved in 2010 as E2762 – 10. DOI 10.1520/E2762-10.

² For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For Annual Book of ASTM Standards volume information, refer to the standard's Document Summary page on the ASTM website.

³ Available from Standardization Documents Order Desk, DODSSP, Bldg. 4, Section D, 700 Robbins Ave., Philadelphia, PA 19111-5098, http://dodssp.daps.dla.mil.

spection by Attributes

3. Terminology

3.1 Definitions:

3.1.1 For a more extensive list of terms in E11 standards, see Terminology E456.

3.1.2 *acceptance quality limit (AQL), n*—quality limit that is the worst tolerable process average when a continuing series of lots is submitted for acceptance sampling. **E2234**

3.1.2.1 *Discussion*—This definition supersedes that given in MIL-STD-105E and MIL-STD-414.

3.1.3 *classification of defects, n*—the enumeration of possible defects of the unit of product classified according to their seriousness, that is, critical, major, or minor defect. **E2234**

3.1.4 *critical defect, n*—a defect that judgment and experience indicate would result in hazardous or unsafe conditions for individuals using, maintaining, or depending upon the product, or a defect that judgment and experience indicate is likely to prevent performance of the function of a major end item. **E2234**

3.1.5 *defect, n*—any nonconformance of the unit of product with specified requirements. **E2234**

3.1.6 *inspection, n*—the process of measuring, examining, testing, or otherwise comparing the unit of product with the requirements. **E2234**

3.1.7 *inspection by variables, n*—inspection wherein the unit of product is measured on a continuous scale with respect to a given requirement or set of requirements.

3.1.8 *inspection lot, n*—a collection of units of product produced under conditions that are considered uniform and from which a sample is drawn and inspected. **E2234**

3.1.9 *major defect, n*—a defect, other than critical, that is likely to result in failure, or to reduce materially the usability of the unit of product for its intended purpose. **E2234**

3.1.10 *minor defect, n*—a defect that is not likely to reduce materially the usability of the unit of product for its intended purpose, or is a departure from established standards having little bearing on the effective use or operation of the unit. **E2234**

3.1.11 *operating characteristic*, n —probability of acceptance using a specified acceptance sampling plan, as a function of parameters describing quality of the lot. **E2234**

3.1.12 *sample*, n —a group of observations, test results, taken from a large collection of observations, test results, which serves to provide information that may be used as a basis for making a decision concerning the larger collection. **E2586**

3.1.12.1 *Discussion*—A sample consists of one or more units of product drawn from an inspection lot, the units of the sample being selected at random without regard to their quality. The number of units of product in the sample is the sample size.

4. Summary of Practice

4.1 The main body of this practice is divided into four sections. Section 6 (Section A in MIL-STD-414) describes general procedures of the sampling plans. Sections 7 and 8 (Sections B and C in MIL-STD-414) describe specific procedures and applications of the sampling plans when variability is unknown. In Section 7 (Section B in MIL-STD-414) the estimate of lot standard deviation is used as the basis for an estimate of the unknown variability, and in Section 8 (Section C in MIL-STD-414) the average range of the sample is used. Section 9 (Section D in MIL-STD-414) describes the plans when variability is known.

4.2 Each of Sections 7, 8, and 9 is divided into three parts: (I) Sampling Plans for the Single Specification Limit Case, (II) Sampling Plans for the Double Specification Limit Case, and (III) Procedures for Estimation of Process Average and Criteria for Tightened and Reduced Inspection. For the single specification limit case, the acceptability criterion is given in two forms: Form 1 and Form 2. Either of the forms may be used, since they are identical as to sample size and decision for lot acceptability or rejectability. In deciding whether to use Form 1 or Form 2, the following point should be borne in mind. Form 1 provides the lot acceptability criterion without estimating lot percent defective. The Form 2 lot acceptability criterion requires estimates of lot percent defective. These estimates also are required for estimation of the process average.

4.3 Operating Characteristic Curves in Table A-3 (see Fig. A1.3) show the relationship between quality and percent of lots expected to be acceptable for the quality characteristic inspected. As stated, these Operating Characteristic Curves are based on the assumption that measurements are selected at random from a normal distribution.

4.4 The corresponding sampling plans in Sections 7, 8, and 9 were matched as closely as possible under a system of fixed sample size with respect to their Operating Characteristic Curves. Operating Characteristic Curves in Table A-3 (see Fig. A1.3) have been computed for the sampling plans based on the estimate of lot standard deviation of unknown variability. They are equally applicable for sampling plans based on the average range of the sample of unknown variability and those based on known variability.

4.5 Certain characteristics concerning the sampling plans in Sections 7 and 8 and those in Section 9 should be noted. Plans based on the estimate of unknown variability require fewer

sample units for comparable assurance when the estimate of lot standard deviation is used than when the average range of the sample is used; on the other hand, plans using the average range of the sample require simpler computations. Plans using known variability require considerably fewer sample units for comparable assurance than either of the plans when variability is unknown; however, the requirement of variability is a stringent one. The user is advised to consult his technical agency before applying sampling plans using known variability.

4.6 Table B-8 (see Fig. A1.11) provides values of the factor F to compute the maximum standard deviation MSD. The MSD serves as a guide for the magnitude of the estimate of lot standard deviation when using plans for the double specification limit case, based on the estimate of lot standard deviation of unknown variability. Similarly, Table C-8 (see Fig. A1.19) provides values of the factor f to compute the maximum average range MAR. The MAR serves as a guide for the magnitude of the average range of the sample when using plans for the double specification limit case, based on the average range of the sample of unknown variability. The estimate of lot standard deviation or average range of the sample, if it is less than the MSD or MAR respectively, helps to insure, but does not guarantee, lot acceptability.

4.7 All symbols and their definitions are given in Annex A1 for their applicable section. An illustration of the computations and procedures used in the sampling plans is given in the examples of Parts I and II of the applicable section. The computations involve simple arithmetic operations such as addition, subtraction, multiplication, and division of numbers, or at most, the taking of a square root of a number. The user should become familiar with the general procedures of Section 6, and refer to the applicable section for detailed instructions regarding specific procedures, computations, and tables for the sampling plans.

5. Significance and Use

5.1 This practice was prepared to meet a growing need for the use of standard sampling plans for inspection by variables in customer procurement, supply and storage, and maintenance inspection operations. The variables sampling plans apply to a single quality characteristic which can be measured on a continuous scale, and for which quality is expressed in terms of percent defective. The theory underlying the development of the variables sampling plans, including the operating characteristic curves, assumes that measurements of the quality characteristic are independent, identically distributed normal random variables.

5.2 In comparison with attributes sampling plans, variables sampling plans have the advantage of usually resulting in considerable savings in sample size for comparable assurance as to the correctness of decisions in judging a single quality characteristic, or for the same sample size, greater assurance is obtained using variables plans. Attributes sampling plans have the advantage of greater simplicity, of being applicable to either single or multiple quality characteristics, and of requiring no knowledge about the distribution of the continuous measurements of any of the quality characteristics.

5.3 It is important to note that variables sampling plans are not to be used indiscriminately, simply because it is possible to obtain variables measurement data. In considering applications where the normality or independence assumptions may be questioned, the user is advised to consult his technical agency to determine the feasibility of application.

5.4 *Application*—Sampling plans designated in this publication are applicable, but not limited, to inspection of the following: (1) end items, (2) components and raw materials, (3) operations or services, (4) materials in process, (5) supplies in storage, (6) maintenance operations, (7) data or records, and (8) administrative procedures.

6. General Description of Sampling Plans

6.1 Scope:

6.1.1 *Purpose*—This practice establishes sampling plans and procedures for inspection by variables for use in customer procurement, supply and storage, and maintenance inspection operations. When applicable this practice shall be referenced in the specification, contract, or inspection instructions, and the provisions set forth herein shall govern.

6.1.2 *Inspection*—Inspection is the process of measuring, examining, testing, gaging, or otherwise comparing the “unit of product” (see 6.1.4) with the applicable requirements.

6.1.3 *Inspection by Variables*—Inspection by variables is inspection wherein a specified quality characteristic (see 6.1.5) on a unit of product is measured on a continuous scale, such as pounds, inches, feet per second, etc., and a measurement is recorded.

6.1.4 *Unit of Product*—The unit of product is the entity of product inspected in order to determine its measurable quality characteristic. This may be a single article, a pair, a set, a component of a product, or the end product itself. The unit of product may or may not be the same as the unit of purchase, supply, production, or shipment.

6.1.5 *Quality Characteristic*—The quality characteristic for variables inspection is that characteristic of a unit of product that is actually measured to determine conformance with a given requirement.

6.1.6 *Specification Limits*—The specification limit(s) is the requirement that a quality characteristic should meet. This requirement may be expressed as an upper specification limit; or a lower specification limit, called herein a single specification limit; or both upper and lower specification limits, called herein a double specification limit.

6.1.7 *Sampling Plans*—A sampling plan is a procedure which specifies the number of units of product from a lot which are to be inspected, and the criterion for acceptability of the lot. Sampling plans designated in this practice are applicable to the inspection of a single quality characteristic of a unit of product. These plans may be used whether procurement inspection is performed at the plant of a prime contractor, subcontractor or vendor, or at destination, and also may be used when appropriate in supply and storage, and maintenance inspection operations.

6.2 Classification of Defects:

6.2.1 *Method of Classifying Defects*—A classification of defects is the enumeration of defects of the unit of product

classified according to their importance. A defect is a deviation of the unit of product from requirements of the specifications, drawings, purchase descriptions, and any changes thereto in the contract or order. Defects normally belong to one of the following classes; however, defects may be placed in other classes.

6.2.1.1 *Critical Defects*—A critical defect is one that judgment and experience indicate could result in hazardous or unsafe conditions for individuals using or maintaining the product; or, for major end items units of product, such as ships, aircraft, or tanks, a defect that could prevent performance of their tactical function.

6.2.1.2 *Major Defects*—A major defect is a defect, other than critical, that could result in failure, or materially reduce the usability of the unit of product for its intended purpose.

6.2.1.3 *Minor Defects*—A minor defect is one that does not materially reduce the usability of the unit of product for its intended purpose, or is a departure from established standards having no significant bearing on the effective use or operation of the unit.

6.3 Percent Defective:

6.3.1 *Expression of Nonconformance*—The extent of nonconformance of product that shall be expressed in terms of percent defective.

6.3.2 *Percent Defective*—The percent defective for a quality characteristic of a given lot of product is the number of units of product defective for that characteristic divided by the total number of units of product and multiplied by one hundred. Expressed as an equation:

$$\text{Percent defective} = \frac{\text{number of defectives} \times 100}{\text{number of units}} \quad (1)$$

6.4 Acceptance Quality Level:

6.4.1 *Acceptance Quality Level*—The acceptance quality level (AQL) is a nominal value expressed in terms of percent defective specified for a single quality characteristic. Certain numerical values of AQL ranging from 0.04 to 15.00 percent are shown in Table A-1 (see Fig. A1.1). When a range of AQL values is specified, it shall be treated as if it were equal to the value of AQL for which sampling plans are furnished and which is included within the AQL range. When the specified AQL is a particular value other than those for which sampling plans are furnished, the AQL, which is to be used in applying the provisions of this practice, shall be as shown in Table A-1 (see Fig. A1.1).

6.4.1.1 The term “acceptable” was changed to “acceptance” after publication of MIL-STD-105E, so where possible this term has been edited in the case of direct references to the AQL value. The notable exceptions are the original tables in Annex A1 which show the original wording as they appeared in MIL-STD-105E.

6.4.2 *Specifying AQL’s*—The particular AQL value to be used for a single quality characteristic of a given product must be specified. In the case of a double specification limit, either an AQL value is specified for the total percent defective outside of both upper and lower specification limits, or two AQL values are specified, one for the upper limit and another for the lower limit.

6.5 Submittal of Product:

6.5.1 *Lot*—The term “lot” shall mean “inspection lot,” that is, a collection of units of product from which a sample is drawn and inspected to determine compliance with the acceptability criterion.

6.5.1.1 *Formation of Lots*—Each lot shall, as far as is practicable, consist of units of product of a single type, grade, class, size, or composition manufactured under essentially the same conditions.

6.5.2 *Lot Size*—The lot size is the number of units of product in a lot, and may differ from the quantity designated in the contract or order as a lot for production, shipment, or other purposes.

6.6 Lot Acceptability:

6.6.1 *Acceptability Criterion*—The acceptability of a lot of material submitted for inspection shall be determined by use of one of the sampling plans associated with a specified value of the AQL(s). This practice provides sampling plans based on known and unknown variability. In the latter case, two alternative methods are provided, one based on the estimate of lot standard deviation and the other on the average range of the sample. These are referred to as the standard deviation method and the range method. For the case of a single specification limit, the acceptability criterion is given in two forms. These are identified as Form 1 and Form 2.

6.6.2 *Choice of Sampling Plans*—Sampling plans and procedures are provided in Section 7 if variability is unknown and the standard deviation method is used, in Section 8 if variability is unknown and the range method is used, and in Section 9 if variability is known. Unless otherwise specified, unknown variability, standard deviation method sampling plans, and the acceptability criterion of Form 2 (for the single specification limit case) shall be used.

6.7 Sample Selection:

6.7.1 *Determination of Sample Size*—The sample size is the number of units of product drawn from a lot. Relative sample sizes are designated by code letters. The sample size code letter depends on the inspection level and the lot size. There are five inspection levels: I, II, III, IV, and V. Unless otherwise specified, inspection level IV shall be used. The sample size code letter applicable to the specified inspection level and for lots of given size shall be obtained from Table A-2 (see Fig. A1.2).

NOTE 1—*Special Reservation for Critical Characteristics*—The customer reserves the right to inspect every unit submitted by the supplier for critical characteristics, and to reject the remainder of the lot immediately after a defect is found. The customer also reserves the right to sample for critical defects every lot submitted by the supplier, and to reject any lot if a sample drawn there from is found to contain one or more critical defects.

6.7.2 *Drawing of Samples*—A sample is one or more units of product drawn from a lot. Units of the sample shall be selected without regard to their quality.

6.8 Estimation of Process Average and Severity of Inspection:

6.8.1 Procedures for estimating the process average and criteria for tightened and reduced inspection based on the inspection results of preceding lots are provided in Part III of Sections 7, 8, and 9.

6.9 Special Procedure for Application of Mixed Variables-Attributes Sampling Plans:

6.9.1 *Applicability*—A mixed variables and attributes sampling plan may be used under either of the two following conditions:

NOTE 2—No Operating Characteristic Curves are provided for the mixed variables-attribute sampling plans herein and that those in Table A-1 (see Fig. A1.1) are not applicable.

6.9.1.1 *Condition A*—Ample evidence exists that the product submitted for inspection is selected by the supplier to meet the specification limit(s) by a screening process from a larger quantity of product which is not being produced within the specification limit(s).

6.9.1.2 *Condition B*—Other conditions exist that warrant the use of a variables-attributes sampling plan.

6.9.2 Definitions:

6.9.2.1 *Inspection by Attributes*—Inspection by attributes is inspection wherein the unit of product is classified simply as defective or nondefective with respect to a given requirement or set of requirements.

6.9.2.2 *Mixed Variables*—Attributes Inspection. Mixed variables-attributes inspection is inspection of a sample by attributes, in addition to inspection by variables already made of a previous sample, before a decision as to acceptability or rejectability of a lot can be made.

6.9.3 *Selection of Sampling Plans*—The mixed variables-attributes sampling plan shall be selected in accordance with the following:

6.9.3.1 Select the variables sampling plan in accordance with Section 7, 8, or 9.

6.9.3.2 Select the attributes sampling plan from Practice E2234, 6.9, using a single sampling plan and tightened inspection. The same AQL value(s) shall be used for the attributes sampling plan as used for the variables plan of 6.9.3.1. (Additional sample items may be drawn, as necessary, to satisfy the requirements for sample size of the attributes sampling plan. Count as a defective each sample item falling outside of specification limit(s).)

6.9.4 *Determination of Acceptability*—A lot meets the acceptability criterion if one of the following conditions is satisfied:

6.9.4.1 *Condition A*—The lot complies with the appropriate variables acceptability criterion of Section 7, 8, or 9.

6.9.4.2 *Condition B*—The lot complies with the acceptability criterion of Practice E2234, 6.10.

6.9.4.3 If Condition A is not satisfied, proceed in accordance with the attributes sampling plan to meet Condition B.

6.9.4.4 If Condition B is not satisfied, the lot does not meet the acceptability criterion.

6.9.5 *Severity of Inspection*—The procedures for severity of inspection referred to in 6.8 are not applicable for mixed variables-attributes inspection.

NOTE 3—When customer drawings, specifications, or other data are used for any purpose other than in connection with a definitely related customer procurement operation, the customer thereby incurs no responsibility or any obligation whatsoever; and the fact that the customer may have formulated, furnished, or in any way supplied the said drawings, specifications, or other data is not to be regarded by implication or otherwise as in any manner licensing the holder or any other person or

corporation, or conveying any rights or permission to manufacture, use, or sell any patented invention that may in any way be related thereto.

7. Variability Unknown—Standard Deviation Method

Part I—Single Specification Limit

7.1 Sampling Plan for Single Specification Limit—This part of the practice describes the procedures for use with plans for a single specification limit when variability of the lot with respect to the quality characteristic is unknown and the standard deviation method is used. The acceptability criterion is given in two equivalent forms. These are identified as Form 1 and Form 2.

7.1.1 Use of Sampling Plans—To determine whether the lot meets the acceptability criterion with respect to a particular quality characteristic and AQL value, the applicable sampling plan shall be used in accordance with the provisions of Section 6, General Description of Sampling Plans, and those in this part of the practice.

7.1.2 Drawing of Samples—All samples shall be drawn in accordance with 6.7.2.

7.1.3 Determination of Sample Size Code Letter—The sample size code letter shall be selected from Table A-2 (see Fig. A1.2) in accordance with 6.7.1.

7.2 Selecting the Sampling Plan When Form 1 is Used:

7.2.1 Master Sampling Tables—The master sampling tables for plans based on variability unknown for a single specification limit when using the standard deviation method are Tables B-1 and B-2 (see Figs. A1.4 and A1.5). Table B-1 is used for normal and tightened inspection and Table B-2 for reduced inspection.

7.2.2 Obtaining the Sampling Plan—The sampling plan consists of a sample size and an associated acceptability constant.⁴ The sampling plan is obtained from Master Table B-1 or B-2 (see Figs. A1.4 and A1.5).

7.2.2.1 Sample Size—The sample size n is shown in the master table corresponding to each sample size code letter.

7.2.2.2 Acceptability Constant—The acceptability constant, k , corresponding to the sample size mentioned in 7.2.2.1, is indicated in the column of the master table corresponding to the applicable AQL value. Table B-1 (see Fig. A1.4) is entered from the top for normal inspection and from the bottom for tightened inspection. Sampling plans for reduced inspection are provided in Table B-2 (see Fig. A1.5).

7.3 Lot-by-lot Acceptability Procedures When Form 1 is Used (see Example 7-1 (Fig. 1) for a complete example of this procedure):

7.3.1 Acceptability Criterion—The degree of conformance of a quality characteristic with respect to a single specification limit shall be judged by the quantity $(U - \bar{X})/s$ or $(\bar{X} - L)/s$.

7.3.2 Computation—The following quantity shall be computed: $(U - \bar{X})/s$ or $(\bar{X} - L)/s$ depending on whether the specification limit is an upper or lower limit,

where:

U = the upper specification limit,
 L = the lower specification limit,
 \bar{X} = the sample mean, and
 s = the estimate of lot standard deviation.

7.3.3 Acceptability Criterion—Compare the quantity $(U - \bar{X})/s$ or $(\bar{X} - L)/s$ with the acceptability constant k . If $(U - \bar{X})/s$ or $(\bar{X} - L)/s$ is equal to or greater than k , the lot meets the acceptability criterion; if $(U - \bar{X})/s$ or $(\bar{X} - L)/s$ is less than k or negative, then the lot does not meet the acceptability criterion.

7.4 Summary for Operation of Sampling Plan When Form 1 is Used:

7.4.1 The following steps summarize the procedures to be followed:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and inspection level.

(2) Obtain plan from Master Table B-1 or B-2 (see Figs. A1.4 and A1.5) by selecting the sample size n and the acceptability constant k .

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic for each unit of the sample.

(4) Compute the sample mean \bar{X} and estimate of lot standard deviation s , and also compute the quantity $(U - \bar{X})/s$ for an upper specification limit U or the quantity $(\bar{X} - L)/s$ for a lower specification limit L .

(5) If the quantity $(U - \bar{X})/s$ or $(\bar{X} - L)/s$ is equal to or greater than k , the lot meets the acceptability criterion; if $(U - \bar{X})/s$ or $(\bar{X} - L)/s$ is less than k or negative, then the lot does not meet the acceptability criterion.

7.5 Selecting the Sampling Plans When Form 2 is Used:

7.5.1 Master Sampling Tables—The master sampling tables for plans based on variability unknown for a single specification limit when using the standard deviation method are Tables B-3 and B-4 (see Figs. A1.6 and A1.7) of Part II. Table B-3 is used for normal and tightened inspection and Table B-4 for reduced inspection.

7.5.2 Obtaining the Sampling Plan—The sampling plan consists of a sample size and an associated maximum allowable percent defective. The sampling plan is obtained from Master Table B-3 or B-4 (see Figs. A1.6 and A1.7).

7.5.2.1 Sample Size—The sample size n is shown in the master table corresponding to each sample size code letter.

7.5.2.2 Maximum Allowable Percent Defective—The maximum allowable percent defective M for sample estimates corresponding to the sample size mentioned in 7.5.2.1 is indicated in the column of the master table corresponding to the applicable AQL value. Table B-3 (see Fig. A1.6) is entered from the top for normal inspection and from the bottom for tightened inspection. Sampling plans for reduced inspection are provided in Table B-4 (see Fig. A1.7).

7.6 Lot-by-lot Acceptability Procedures When Form 2 is Used (see Example 7-2 (Fig. 2) for a complete example of this procedure):

7.6.1 Acceptability Criterion—The degree of conformance of a quality characteristic with respect to a single specification

⁴ See Section 7 Definitions in Annex A1 for definitions of all symbols used in the sampling plans based on variability unknown-standard deviation method.

EXAMPLE 7-1
 Example of Calculations
 Single Specification Limit-Form 1
 Variability Unknown - Standard Deviation Method

Example The maximum temperature of operation for a certain device is specified as 209°F. A lot of 40 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 1% is to be used. From Tables A-2 and B-1 it is seen that a sample of size 5 is required. Suppose the measurements obtained are as follows: 197°, 188°, 184°, 205°, and 201°; and compliance with the acceptability criterion is to be determined.

Line	<u>Information Needed</u>	<u>Value Obtained</u>	<u>Explanation</u>
1	Sample Size: n	5	
2	Sum of Measurements: $\sum X$	975	
3	Sum of Squared Measurements: $\sum X^2$	190,435	
4	Correction Factor (CF): $(\sum X)^2/n$	190,125	$(975)^2/5$
5	Corrected Sum of Squares (SS): $\sum X^2 - CF$	310	$190,435 - 190,125$
6	Variance (V): SS/(n-1)	77.5	$310/4$
7	Estimate of Lot Standard Deviation s: \sqrt{V}	8.81	$\sqrt{77.5}$
8	Sample Mean \bar{X} : $\sum X/n$	195	$975/5$
9	Specification Limit (Upper): U	209	
10	The quantity: $(U - \bar{X})/s$	1.59	$(209 - 195)/8.81$
11	Acceptability Constant: k	1.53	See Table B-1
12	Acceptability Criterion: Compare $(U - \bar{X})/s$ with k	1.59 > 1.53	See Section 7.3.3

The lot meets the acceptability criterion, since $(U - \bar{X})/s$ is greater than k.

NOTE: If a single lower specification limit L is given, then compute the quantity $(\bar{X} - L)/s$ in line 10 and compare it with k; the lot meets the acceptability criterion, if $(\bar{X} - L)/s$ is equal to or greater than k.

FIG. 1 Example 7-1

limit shall be judged by the percent of nonconforming product outside the upper or lower specification limit. The percentage of nonconforming product is estimated by entering Table B-5 (see Fig. A1.8) with the quality index and the sample size.

7.6.2 Computation of Quality Index—The Quality index $Q_U = (U - \bar{X})/s$ shall be computed if the specification limit is an upper limit U, or $Q_L = (\bar{X} - L)/s$ if it is a lower limit L. The quantities, \bar{X} and s, are the sample mean and estimate of lot standard deviation, respectively.

7.6.3 Estimate of Percent Defective in Lot—The quality of a lot shall be expressed by p_U , the estimated percent defective in the lot above the upper specification limit, or by p_L , the estimated percent defective below the lower specification limit. The estimated percent defective p_U or p_L is obtained by entering Table B-5 (see Fig. A1.8) with Q_U or Q_L and the appropriate sample size.

7.6.4 Acceptability Criterion—Compare the estimated lot percent defective p_U or p_L with the maximum allowable percent defective M. If p_U or p_L is equal to or less than M, the lot meets the acceptability criterion; if p_U or p_L is greater than M or if Q_U or Q_L is negative, then the lot does not meet the acceptability criterion.

7.7 Summary for Operation of Sampling Plan When Form 2 is Used:

7.7.1 The following steps summarize the procedures to be followed:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and the inspection level.

(2) Obtain plan from Master Table B-3 or B-4 (see Figs. A1.6 and A1.7) by selecting the sample size n and the maximum allowable percent defective M.

EXAMPLE 7-2
Example of Calculations
Single Specification Limit-Form 2
Variability Unknown - Standard Deviation Method

Example The maximum temperature of operation for a certain device is specified as 209°F. A lot of 40 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 1 % is to be used. From Tables A-2 and B-1 it is seen that a sample of size 5 is required. Suppose the measurements obtained are as follows: 197°, 188°, 184°, 205°, and 201°; and compliance with the acceptability criterion is to be determined.

<u>Line</u>	<u>Information Needed</u>	<u>Value Obtained</u>	<u>Explanation</u>
1	Sample Size: n	5	
2	Sum of Measurements: $\sum X$	975	
3	Sum of Squared Measurements: $\sum X^2$	190 435	
4	Correction Factor (CF): $(\sum X)^2/n$	190 125	$(975)^2/5$
5	Corrected Sum of Squares (SS): $\sum X^2 - CF$	310	$190\ 435 - 190\ 125$
6	Variance (V): SS/(n-1)	77.5	$310/4$
7	Estimate of Lot Standard Deviation s: \sqrt{V}	8.81	$\sqrt{77.5}$
8	Sample Mean \bar{X} : $\sum X/n$	195	$975/5$
9	Specification Limit (Upper): U	209	
10	Quality Index: $Q_U = (U - \bar{X})/s$	1.59	$(209 - 195)/8.81$
11	Est. of Lot Percent Def.: p_U	2.19 %	See Table B-5
12	Max. Allowable Percent Def.: M	3.32 %	See Table B-3
13	Acceptability Criterion: Compare p_U with M	2.19 % < 3.32 %	See Section 7.6.4

The lot meets the acceptability criterion, since p_U is less than M.

NOTE: If a single lower specification limit L is given, then compute the quality index $Q_L = (\bar{X} - L)/s$ in line 10 and obtain the estimate of lot percent defective p_L . Compare p_L with M; the lot meets the acceptability criterion, if p_L is equal to or less than M.

FIG. 2 Example 7-2

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic on each unit of the sample.

(4) Compute the sample mean \bar{X} and the estimate of lot standard deviation s.

(5) Compute the quality index $Q_U = (U - \bar{X})/s$ if an upper specification limit U is specified, or $Q_L = (\bar{X} - L)/s$ if a lower specification limit L is specified.

(6) Determine the estimated lot percent defective p_U or p_L from Table B-5 (see Fig. A1.8).

(7) If the estimated lot percent defective p_U or p_L is equal to or less than the maximum allowable percent defective M, the lot meets the acceptability criterion; if p_U or p_L is greater than M or if Q_U or Q_L is negative, then the lot does not meet the acceptability criterion.

Part II—Double Specification Limit

7.8 Sampling Plan for Double Specification Limit—This part of the practice describes the procedures for use with plans for a double specification limit when variability of the lot with respect to the quality characteristic is unknown and the standard deviation method is used.

7.8.1 Use of Sampling Plans—To determine whether the lot meets the acceptability criterion with respect to a particular quality characteristic and AQL value(s) the applicable sampling plan shall be used in accordance with the provisions of Section 6, General Description of Sampling Plans, and those in this part of the practice.

7.9 Selecting the Sampling Plan—A sampling plan for each AQL value shall be selected from Table B-3 or B-4 (see Figs. A1.6 and A1.7) as follows:

7.9.1 Determination of Sample Size Code Letter—The sample size code letter shall be selected from Table A-2 (see Fig. A1.2) in accordance with **6.7.1**.

7.9.2 Master Sampling Tables—The master sampling tables for plans based on variability unknown for a double specification limit when using the standard deviation method are Tables B-3 and B-4 (see Figs. A1.6 and A1.7). Table B-3 is used for normal and tightened inspection and Table B-4 for reduced inspection.

7.9.3 Obtaining Sampling Plan—A sampling plan consists of a sample size and the associated maximum allowable percent defective(s). The sampling plan to be applied in inspection shall be obtained from Master Table B-3 or B-4 (see Figs. A1.6 and A1.7).

7.9.3.1 Sample Size—The sample size n is shown in the master tables corresponding to each sample size code letter.

7.9.3.2 Maximum Allowable Percent Defective—The maximum allowable percent defective for sample estimates of percent defective for the lower, upper, or both specification limits combined, corresponding to the sample size mentioned in **7.9.3.1**, is shown in the column of the master table corresponding to the applicable AQL value(s). If different AQL's are assigned to each specification limit, designate the maximum allowable percent defective by M_L for the lower limit, and by M_U for the upper limit. If one AQL is assigned to both limits combined, designate the maximum allowable percent defective by M . Table B-3 (see Fig. A1.6) is entered from the top for normal inspection and from the bottom for tightened inspection. Sampling plans for reduced inspection are provided in Table B-4 (see Fig. A1.7).

7.10 Drawing of Samples:

7.10.1 Samples shall be selected in accordance with **6.7.2**.

7.11 Lot-by-lot Acceptability Procedures:

7.11.1 Acceptability Criterion—The degree of conformance of a quality characteristic with respect to a double specification limit shall be judged by the percent of nonconforming product. The percentage of nonconforming product is estimated by entering Table B-5 (see Fig. A1.8) with the quality index and the sample size.

7.11.2 Computation of Quality Indices—The quality indices $Q_U = (U - \bar{X})/s$ and $Q_L = (\bar{X} - L)/s$ shall be computed,

where:

U = the upper specification limit,
 L = the lower specification limit,
 \bar{X} = the sample mean, and
 s = the estimate of lot standard deviation.

7.11.3 Percent Defective in the Lot—The quality of a lot shall be expressed in terms of the lot percent defective. Its estimate will be designated by p_L , p_U , or p . The estimate p_U indicates conformance with respect to the upper specification limit, p_L with respect to the lower specification limit, and p for both specification limits combined. The estimates p_L and p_U shall be determined by entering Table B-5 (see Fig. A1.8), respectively, with Q_L and Q_U and the sample size. The estimate

p shall be determined by adding the corresponding estimated percent defectives p_L and p_U found in the table.

7.12 Acceptability Criterion and Summary for Operation of Sampling Plans:

7.12.1 One AQL Value for both Upper and Lower Specification Limit Combined:

7.12.1.1 Acceptability Criterion (see Example 7-3 (**Fig. 3**) for a complete example of this procedure): Compare the estimated lot percent defective $p = p_U + p_L$ with the maximum allowable percent defective M . If p is equal to or less than M , the lot meets the acceptability criterion; if p is greater than M or if either Q_U or Q_L or both are negative, then the lot does not meet the acceptability criterion.

7.12.1.2 Summary for Operation of Sampling Plan—In cases where a single AQL value is established for the upper and lower specification limit combined for a single quality characteristic, the following steps summarize the procedures to be used:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and the inspection level.

(2) Select plan from Master Table B-3 or B-4 (see Figs. A1.6 and A1.7). Obtain the sample size n and the maximum allowable percent defective M .

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic on each unit of the sample.

(4) Compute the sample mean \bar{X} and estimate of lot standard deviation s .

(5) Compute the quality indices $Q_U = (U - \bar{X})/s$ and $Q_L = (\bar{X} - L)/s$.

(6) Determine the estimated lot percent defective $p = p_U + p_L$ from Table B-5 (see Fig. A1.8).

(7) If the estimated lot percent defective p is equal to or less than the maximum allowable percent defective M , the lot meets the acceptability criterion; if p is greater than M or if either Q_U or Q_L or both are negative, then the lot does not meet the acceptability criterion.

7.12.2 Different AQL Values for Upper and Lower Specification Limit:

7.12.2.1 Acceptability Criteria (see Example 7-4 (**Fig. 4**) for a complete example of this procedure)—Compare the estimated lot percent defectives p_L and p_U with the corresponding maximum allowable percent defectives M_L and M_U ; also compare $p = p_L + p_U$ with the larger of M_L and M_U . If p_L is equal to or less than M_L , p_U is equal to or less than M_U , and p is equal to or less than the larger of M_L and M_U , the lot meets the acceptability criteria; otherwise, the lot does not meet the acceptability criteria. If either Q_L or Q_U or both are negative, then the lot does not meet the acceptability criteria.

7.12.2.2 Summary for Operation of Sampling Plan—In cases where a different AQL value is established for the upper and lower specification limit for a single quality characteristic, the following steps summarize the procedures to be used:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and inspection level.

EXAMPLE 7-3

Example of Calculations
Double Specification Limit

Variability Unknown - Standard Deviation Method

One AQL Value for both Upper and Lower Specification Limit Combined

Example The minimum temperature of operation for a certain device is specified as 180°F. The maximum temperature is 209°F. A lot of 40 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 1 % is to be used. From Tables A-2 and B-3 it is seen that a sample of size 5 is required. Suppose the measurements obtained are as follows: 197°, 188°, 184°, 205°, and 201°; and compliance with the acceptability criterion is to be determined.

Line	Information Needed	Value Obtained	Explanation
1	Sample Size: n	5	
2	Sum of Measurements: $\sum X$	975	
3	Sum of Squared Measurements: $\sum X^2$	190 435	
4	Correction Factor (CF): $(\sum X)^2/n$	190 125	$(975)^2/5$
5	Corrected Sum of Squares (SS): $\sum X^2 - CF$	310	$190\ 435 - 190\ 125$
6	Variance (V): $SS/(n-1)$	77.5	$310/4$
7	Estimate of Lot Standard Deviation s: \sqrt{V}	8.81	$\sqrt{77.5}$
8	Sample Mean \bar{X} : $\sum X/n$	195	$975/5$
9	Upper Specification Limit: U	209	
10	Lower Specification Limit: L	180	
11	Quality Index: $Q_U = (U - \bar{X})/s$	1.59	$(209 - 195)/8.81$
12	Quality Index: $Q_L = (\bar{X} - L)/s$	1.70	$(195-180)/8.81$
13	Est. of Lot Percent Def. Above U: p_U	2.19 %	See Table B-5
14	Est. of Lot Percent Def. Below L: p_L	0.66 %	See Table B-5
15	Total Est. Percent Def. in Lot: $p = p_U + p_L$	2.85 %	$2.19\% + 0.66\%$
16	Max. Allowable Percent Def.: M	3.32 %	See Table B-3
17	Acceptability Criterion: Compare $p = p_U + p_L$ with M	2.85 % < 3.32 %	See Sec. 7.12.1.2(7)

The lot meets the acceptability criterion, since $p = p_U + p_L$ is less than M.

FIG. 3 Example 7-3

(2) Select the sampling plan from Master Table B-3 or B-4 (see Figs. A1.6 and A1.7). Obtain the sample size n and the maximum allowable percent defectives M_U and M_L , corresponding to the AQL values for the upper and lower specification limits, respectively.

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic on each unit in the sample.

(4) Compute the sample mean \bar{X} and estimate a lot standard deviation s.

(5) Compute the quality indices $Q_U = (U - \bar{X})/s$ and $Q_L = (\bar{X} - L)/s$.

(6) Determine the estimated lot percent defectives p_U and p_L , corresponding to the percent defectives above the upper and below the lower specification limits. Also determine the combined percent defective $p = p_U + p_L$.

(7) If all three of the following conditions are satisfied, the lot meets the acceptability criteria; otherwise the lot does not meet the acceptability criteria. If either Q_L or Q_U or both are negative, then the lot does not meet the acceptability criteria.

EXAMPLE 7-4

Example of Calculations
Double Specification Limit

Variability Unknown - Standard Deviation Method

Different AQL Values for Upper and Lower Specification Limits

Example The minimum temperature of operation for a certain device is specified as 180°F. The maximum temperature is 209°F. A lot of 40 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 1% for the upper and AQL = 2.5 % for the lower specification limit is to be used. From Tables A-2 and B-3 it is seen that a sample of size 5 is required. Suppose the measurements obtained are as follows: 197°, 188°, 184°, 205°, and 201°; and compliance with the acceptability criterion is to be determined.

Line	<u>Information Needed</u>	<u>Value Obtained</u>	<u>Explanation</u>
1	Sample Size: n	5	
2	Sum of Measurements: $\sum X$	975	
3	Sum of Squared Measurements: $\sum X^2$	190 435	
4	Correction Factor (CF): $(\sum X)^2/n$	190 125	$(975)^2/5$
5	Corrected Sum of Squares (SS): $\sum X^2 - CF$	310	$190\ 435 - 190\ 125$
6	Variance (V): SS/(n-1)	77.5	$310/4$
7	Estimate of Lot Standard Deviation s: \sqrt{V}	8.81	$\sqrt{77.5}$
8	Sample Mean \bar{X} : $\sum X/n$	195	$975/5$
9	Upper Specification Limit: U	209	
10	Lower Specification Limit: L	180	
11	Quality Index: $Q_U = (U - \bar{X})/s$	1.59	$(209 - 195)/8.81$
12	Quality Index: $Q_L = (\bar{X} - L)/s$	1.70	$(195 - 180)/8.81$
13	Est. of Lot Percent Def. above U: p_U	2.19 %	See Table B-5
14	Est. of Lot Percent Def. below L: p_L	0.66 %	See Table B-5
15	Total Est. Percent Def. in Lot: $p = p_U + p_L$	2.85 %	$2.19 \% + 0.66 \%$
16	Max. Allowable Percent Def. Above U: M_U	3.32 %	See Table B-3
17	Max. Allowable Percent Def. Below L: M_L	9.80 %	See Table B-3
18	Acceptability Criterion:		
	(a) Compare p_U with M_U	2.19 % < 3.32 %	See Sec. 7.12.2.2(7)(a)
	(b) Compare p_L with M_L	0.66 % < 9.80 %	See Sec. 7.12.2.2(7)(b)
	(c) Compare p with M_L	2.85 % < 9.80 %	See Sec. 7.12.2.2(7)(c)

The lot meets the acceptability criteria, since 18(a), (b), and (c) are satisfied; that is, $p_U < M_U$, $p_L < M_L$ and $p < M_L$.

FIG. 4 Example 7-4

(a) p_U is equal to or less than M_U

(b) p_L is equal to or less than M_L

(c) p is equal to or less than the larger of M_L and M_U

Part III—Estimation of Process Average and Criteria for Reduced and Tightened Inspection

7.13 Estimation of Process Average—The average percent defective, based upon a group of lots submitted for original inspection, is called the process average. Original inspection is the first inspection of a particular quantity of product submitted for acceptability as distinguished from the inspection of product which has been resubmitted after prior rejection. The process average shall be estimated from the results of inspection of samples drawn from a specified number of preceding lots for the purpose of determining severity of inspection during the course of a contract in accordance with 7.14.3. Any lot shall be included only once in estimating the process average. The estimate of the process average is designated by \bar{p}_U when computed with respect to an upper specification limit, by \bar{p}_L when computed with respect to a lower specification limit, and by \bar{p} when computed with respect to a double specification limit.

7.13.1 Abnormal Results—The results of inspection of product manufactured under conditions not typical of usual production shall be excluded from the estimated process average.

7.13.2 Computation of the Estimated Process Average—The estimated process average is the arithmetic mean of the estimated lot percent defectives computed from the sampling inspection results of the preceding ten (10) lots or as may be otherwise designated. In order to estimate the lot percent defective, the quality indices Q_U and/or Q_L shall be computed for each lot. These are: $Q_U = (U - \bar{X})/s$ and $Q_L = (\bar{X} - L)/s$. (See 7.11.2.)

7.13.2.1 Single Specification Limit⁵—The estimated lot percent defective shall be determined from Table B-5 (see Fig. A1.8) for the plans based on known variability. The quality index Q_U shall be used for the case of an upper specification limit, or Q_L for the case of a lower specification limit. Table B-5 is entered with Q_U or Q_L and the corresponding estimated lot percent defective p_U or p_L , respectively, is read from the table. The estimated process average \bar{p}_U is the arithmetic mean of the individual estimated lot percent defectives p_U 's. Similarly, the estimated process average \bar{p}_L is the arithmetic mean of the individual estimated lot percent defectives p_L 's.

7.13.2.2 Double Specification Limit—The estimated lot percent defective shall be determined from Table B-5 (see Fig. A1.8) for the plans based on variability known. The quality indices Q_U and Q_L shall be computed. Table B-5 is entered separately with Q_U and Q_L and the corresponding p_U and p_L are read from the table. The estimated lot percent defective is $p = p_U + p_L$. The estimated process average \bar{p} is the arithmetic mean of the individual estimated lot percent defectives p 's.

7.13.2.3 Special Case—If the quality index Q_U or Q_L is a negative number, then Table B-5 (see Fig. A1.8) is entered by disregarding the negative sign. However, in this case, the estimated lot percent defective above the upper limit or below

the lower limit is obtained by subtracting the percentage found in the table from 100 %.⁶

7.14 Normal, Tightened, and Reduced Inspection—This practice establishes sampling plans for normal, tightened, and reduced inspection.

7.14.1 At Start of Inspection—Normal inspection shall be used at the start of inspection unless otherwise designated.

7.14.2 During Inspection—During the course of inspection, normal inspection shall be used when inspection conditions are such that tightened or reduced inspection is not required in accordance with 7.14.3 and 7.14.4.

7.14.3 Tightened Inspection—Tightened inspection shall be instituted when the estimated process average computed from the preceding ten (10) lots (or such other number of lots designated) in accordance with 7.13.2 is greater than the AQL, and when more than a certain number T of these lots have estimates of the percent defective exceeding the AQL. The T-values are given in Table B-6 (see Fig. A1.9) for the process average computed from 5, 10, or 15 lots.⁷ Normal inspection shall be reinstated if the estimated process average of lots under tightened inspection is equal to or less than the AQL.

7.14.4 Reduced Inspection—Reduced inspection may be instituted provided that all of the following conditions are satisfied:

7.14.4.1 Condition A—The preceding ten (10) lots (or such other number of lots designated) have been under normal inspection and none has been rejected.

7.14.4.2 Condition B—The estimated percent defective for each of these preceding lots is less than the applicable lower limit shown in Table B-7 (see Fig. A1.10); or for certain sampling plans, the estimated lot percent defective is equal to zero for a specified number of consecutive lots (see Table B-7).

7.14.4.3 Condition C—Production is at a steady rate.

7.14.4.4 Normal inspection shall be reinstated if any one of the following conditions occurs under reduced inspection:

7.14.4.5 Condition D—A lot is rejected.

7.14.4.6 Condition E—The estimated process average is greater than the AQL.

7.14.4.7 Condition F—Production becomes irregular or delayed.

7.14.4.8 Condition G—Other conditions as may warrant that normal inspection should be reinstated.

7.14.5 Sampling Plans for Tightened or Reduced Inspection—Sampling plans for tightened and reduced inspection are provided in Section 7, Parts I and II.

8. Variability Unknown—Range Method

Part I—Single Specification Limit

8.1 Sampling Plan for Single Specification Limit—This part of the practice describes the procedures for use with plans for a single specification limit when variability of the lot with

⁵ When Form 1—Single Specification Limit is used for the acceptability criterion, the estimate of lot percent defective p_U or p_L is not obtained; in order to estimate the process average, it is necessary to complete 7.6.1 and 7.6.3 of Form 2.

⁶ For example, if $Q_U = -0.50$ and $Q_L = 1.60$, using sample size 50, then $p_U = 100\% - 30.93\% = 69.07\%$, $p_L = 5.33\%$ and $p = 69.07\% + 5.33\% = 74.40\%$.

⁷ If the sample size code letter is not the same for all samples used, the entry in Table B-6 (see Fig. A1.9) is determined by the sample size code letter corresponding to the smallest sample size used in any of the lots included in the estimation of the process average.

respect to the quality characteristic is unknown and the range method is used. The acceptability criterion is given in two equivalent forms. These are identified as Form 1 and Form 2.

8.1.1 *Use of Sampling Plans*—To determine whether the lot meets the acceptability criterion with respect to a particular quality characteristic and AQL value, the applicable sampling plan shall be used in accordance with the provisions of Section 6, General Description of Sampling Plans, and those in this part of the practice.

8.1.2 *Drawing of Samples*—All samples shall be drawn in accordance with 6.7.2.

8.1.3 *Determination of Sample Size Code Letter*—The sample size code letter shall be selected from Table A-2 (see Fig. A1.2) in accordance with 6.7.1.

8.2 Selecting the Sampling Plan When Form 1 is Used:

8.2.1 *Master Sampling Tables*—The master sampling tables for plans based on variability unknown for a single specification limit when using the range method are Tables C-1 and C-2 (see Figs. A1.12 and A1.13). Table C-1 is used for normal and tightened inspection and Table C-2 for reduced inspection.

8.2.2 *Obtaining the Sampling Plan*—The sampling plan consists of a sample size and an associated acceptability

constant.⁸ The sampling plan is obtained from Master Table C-1 or C-2 (see Figs. A1.12 and A1.13).

8.2.2.1 *Sample Size*—The sample size n is shown in the master table corresponding to each sample size code letter.

8.2.2.2 *Acceptability Constant*—The acceptability constant k , corresponding to the sample size mentioned in 8.2.2.1, is indicated in the column of the master table corresponding to the applicable AQL value. Table C-1 (see Fig. A1.12) is entered from the top for normal inspection and from the bottom for tightened inspection. Sampling plans for reduced inspection are provided in Table C-2 (see Fig. A1.13).

8.3 *Lot-by-lot Acceptability Procedures When Form 1 is Used* (see Example 8-1 (Fig. 5) for a complete example of this procedure):

8.3.1 *Acceptability Criterion*—The degree of conformance of a quality characteristic with respect to a single specification limit shall be judged by the quantity $(U - \bar{X})/\bar{R}$ or $(\bar{X} - L)/\bar{R}$.

⁸ See Section 8 Definitions in Annex A1 for definitions of all symbols used in the sampling plans based on variability unknown-range method.

EXAMPLE 8-1

Example of Calculations
Single Specification Limit-Form 1
Variability Unknown – Range Method

Example The lower specification limit for electrical resistance of a certain electrical component is 620 ohms. A lot of 100 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 0.4 % is to be used. From Tables A-2 and C-1 it is seen that a sample of size 10 is required. Suppose that values of the sample resistances in the order reading from left to right are as follows:

$$643, 651, 619, 677, 658, (\bar{R}_1 = 658 - 619 = 39)$$

$$670, 673, 641, 638, 650, (\bar{R}_2 = 673 - 638 = 35)$$

and compliance with the acceptability criterion is to be determined.

Line	Information Needed	Value Obtained	Explanation
1	Sample Size: n	10	
2	Sum of Measurements: $\sum X$	6470	
3	Sample Mean \bar{X} : $\sum X/n$	647	$6470/10$
4	Average Range \bar{R} : $\sum R/\text{no. of subgroups}$	37	$(39+35)/2$
5	Specification Limit (Lower): L	620	
6	The quantity: $(\bar{X} - L)/\bar{R}$	0.730	$(647-620)/37$
7	Acceptability Constant: k	0.811	See Table C-1
8	Acceptability Criterion: Compare $(\bar{X} - L)/\bar{R}$ with k	$0.730 < 0.811$	See Section 8.3.3

The lot does not meet the acceptability criterion, since $(\bar{X} - L)/\bar{R}$ is less than k .

NOTE: If a single upper specification limit U is given, then compute the quantity $(U - \bar{X})/\bar{R}$ in line 6 and compare it with k ; the lot meets the acceptability criterion, if $(U - \bar{X})/\bar{R}$ is equal to or greater than k .

FIG. 5 Example 8-1

8.3.2 Computation—The following quantity shall be computed: $(U - \bar{X})/\bar{R}$ or $(\bar{X} - L)/\bar{R}$, depending on whether the specification limit is an upper or a lower limit,

where:

U = the upper specification limit,
 L = the lower specification limit,
 \bar{X} = the sample mean, and
 \bar{R} = the average range of the sample.

8.3.2.1 In this practice, \bar{R} is the average range of subgroup ranges. Each of the subgroups consists of 5 measurements, except for those plans with sample size 3, 4, or 7 in which case the subgroup size is the same as the sample size. In computing \bar{R} , the order of the sample measurements as made must be retained. Subgroups of consecutive measurements must be formed and the range of each subgroup obtained. \bar{R} is the average of the individual subgroup ranges.

8.3.3 Acceptability Criterion—Compare the quantity $(U - \bar{X})/\bar{R}$ or $(\bar{X} - L)/\bar{R}$ with the acceptability constant k . If $(U - \bar{X})/\bar{R}$ or $(\bar{X} - L)/\bar{R}$ is equal to or greater than k , the lot meets the acceptability criterion; if $(U - \bar{X})/\bar{R}$ or $(\bar{X} - L)/\bar{R}$ is less than k or negative, then the lot does not meet the acceptability criterion.

8.4 Summary for Operation of Sampling Plan When Form 1 is Used:

8.4.1 The following steps summarize the procedures to be followed:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and the inspection level.

(2) Obtain plan from Master Table C-1 or C-2 (see Figs. A1.12 and A1.13) by selecting the sample size n and the acceptability constant k .

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic for each unit of the sample.

(4) Compute the sample mean \bar{X} and the average range of the sample \bar{R} , and also compute the quantity $(U - \bar{X})/\bar{R}$ for an upper specification limit U or the quantity $(\bar{X} - L)/\bar{R}$ for a lower specification limit L .

(5) If the quantity $(U - \bar{X})/\bar{R}$ or $(\bar{X} - L)/\bar{R}$ is equal to or greater than k , the lot meets the acceptability criterion; if $(U - \bar{X})/\bar{R}$ or $(\bar{X} - L)/\bar{R}$ is less than k or negative, then the lot does not meet the acceptability criterion.

8.5 Selecting the Sampling Plan When Form 2 is Used:

8.5.1 Master Sampling Tables—The master sampling tables for plans based on variability unknown for a single specification limit when using the range method are Tables C-3 and C-4 (see Figs. A1.14 and A1.15) of Part II. Table C-3 is used for normal and tightened inspection and Table C-4 for reduced inspection.

8.5.2 Obtaining the Sampling Plan—The sampling plan consists of a sample size and an associated maximum allowable percent defective. The sampling plan is obtained from Master Table C-3 or C-4 (see Figs. A1.14 and A1.15).

8.5.2.1 Sample Size—The sample size n is shown in the master table corresponding to each sample size code letter.

8.5.2.2 Maximum Allowable Percent Defective—The maximum allowable percent defective M for sample estimates

corresponding to the sample size mentioned in **8.5.2.1** is indicated in the column of the master table corresponding to the applicable AQL value. Table C-3 (see Fig. A1.14) is entered from the top for normal inspection and from the bottom for tightened inspection. Sampling plans for reduced inspection are provided in Table C-4 (see Fig. A1.15).

8.6 Lot-by-lot Acceptability Procedures When Form 2 is Used (see Example 8-2 (Fig. 6) for a complete example of this procedure):

8.6.1 Acceptability Criterion—The degree of conformance of a quality characteristic with respect to a single specification limit shall be judged by the percent of nonconforming product outside the upper or lower specification limit. The percentage of nonconforming product is estimated by entering Table C-5 (see Fig. A1.16) with the quality index and the sample size.

8.6.2 Computation of Quality Index—The quality index $Q_U = (U - \bar{X})c/\bar{R}$ shall be computed if the specification limit is an upper limit U , or $Q_L = (\bar{X} - L)c/\bar{R}$ if it is a lower limit L . The quantities, \bar{X} and \bar{R} , are the sample mean and average range of the sample, respectively. The computation of \bar{R} is explained in **8.3.2**. The factor c is provided in Master Tables C-3 and C-4 (see Figs. A1.14 and A1.15) corresponding to the sample size code letter.

8.6.3 Estimate of Percent Defective in Lot—The quality of a lot shall be expressed by p_U , the estimated percent defective in the lot above the upper specification limit, or by p_L , the estimated percent defective below the lower specification limit. The estimated percent defective p_U or p_L is obtained by entering Table C-5 (see Fig. A1.16) with Q_U or Q_L and the appropriate sample size.

8.6.4 Acceptability Criterion—Compare the estimated lot percent defective p_U or p_L with the maximum allowable percent defective M . If p_U or p_L is equal to or less than M , the lot meets the acceptability criterion; if p_U or p_L is greater than M or if Q_U or Q_L is negative, then the lot does not meet the acceptability criterion.

8.7 Summary of Operation of Sampling Plan When Form 2 is Used:

8.7.1 The following steps summarize the procedures to be followed:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and the inspection level.

(2) Obtain plan from Master Table C-3 or C-4 (see Figs. A1.14 and A1.15) by selecting the sample size n , the factor c , and the maximum allowable percent defective M .

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic on each unit of the sample.

(4) Compute the sample mean \bar{X} and the average range of the sample \bar{R} .

(5) Compute the quality index $Q_U = (U - \bar{X})c/\bar{R}$ if the upper specification limit U is specified, or $Q_L = (\bar{X} - L)c/\bar{R}$ if the lower specification limit L is specified.

(6) Determine the estimated lot percent defective p_U or p_L from Table C-5 (see Fig. A1.16).

(7) If the estimated lot percent defective p_U or p_L is equal to or less than the maximum allowable percent defective M , the lot meets the acceptability criterion; if p_U or p_L is greater

EXAMPLE 8-2

Example of Calculations

Single Specification Limit-Form 2 Variability Unknown – Range Method

Example The lower specification limit for electrical resistance of a certain electrical component is 620 ohms. A lot of 100 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 0.4 % is to be used. From Tables A-2 and C-1 it is seen that a sample of size 10 is required. Suppose that values of the sample resistances in the order reading from left to right are as follows:

$$643, 651, 619, 6Z7, 658, (R_1 = 658 - 619 = 39) \\ 670, 673, 641, 638, 650, (R_2 = 673 - 638 = 35)$$

and compliance with the acceptability criterion is to be determined.

Line	Information Needed	Value Obtained	Explanation
1	Sample Size: n	10	
2	Sum of Measurements: $\sum X$	6470	
3	Sample Mean $\bar{X} : \sum X/n$	647	6470/10
4	Average Range $\bar{R} : \sum R/\text{no. of subgroups}$	37	(39 + 35)/2
5	Factor c	2.405	See Table C-3
6	Specification Limit (Lower): L	620	
7	Quality Index: $Q_L = (\bar{X} - L)c / \bar{R}$	1.76	(647 - 620)2.405/37
8	Est. of Lot Percent Def.: p_L	2.54 %	See Table C-5
9	Max. Allowable Percent Def.: M	1.14 %	See Table C-3
10	Acceptability Criterion: Compare p_L with M	2.54 % > 1.14 %	See Section 8.6.4

The lot does not meet the acceptability criterion, since p_L is greater than M.

NOTE: If a single upper specification limit U is given, then compute the quality index $Q_U = (U - \bar{X})c / \bar{R}$ in line 7 and obtain the estimate of lot percent defective p_U . Compare p_U with M; the lot meets the acceptability criterion, if p_U is equal to or less than M.

FIG. 6 Example 8-2

than M or if Q_U or Q_L is negative, then the lot does not meet the acceptability criterion.

Part II—Double Specification Limit

8.8 Sampling Plan for Double Specification Limit—This part of the practice describes the procedures for use with plans for a double specification limit when variability of the lot with respect to the quality characteristic is unknown and the range method is used.

8.8.1 Use of Sampling Plans—To determine whether the lot meets the acceptability criterion with respect to a particular quality characteristic and AQL value(s), the applicable sampling plan shall be used in accordance with the provisions of Section 6, General Description of Sampling Plans, and those in this part of the practice.

8.9 Selecting the Sampling Plan—A sampling plan for each AQL value shall be selected from Table C-3 or C-4 (see Figs. A1.14 and A1.15) as follows:

8.9.1 Determination of Sample Size Code Letter—The sample size code letter shall be selected from Table A-2 (see Fig. A1.2) in accordance with 6.7.1.

8.9.2 Master Sampling Tables—The master sampling tables for plans based on variability unknown for a double specification limit when using the range method are Tables C-3 and C-4 (see Figs. A1.14 and A1.15). Table C-3 is used for normal and tightened inspection and Table C-4 for reduced inspection.

8.9.3 Obtaining Sampling Plan—A sampling plan consists of a sample size and the associated maximum allowable percent defective(s). The sampling plan to be applied in inspection shall be obtained from Master Table C-3 or C-4 (see Figs. A1.14 and A1.15).

8.9.3.1 Sample Size—The sample size n is shown in the master tables corresponding to each sample size code letter.

8.9.3.2 Maximum Allowable Percent Defective—The maximum allowable percent defective for sample estimates of percent defective for the lower, upper, or both specification limits combined, corresponding to the sample size mentioned in 8.9.3.1, is shown in the column of the master table corresponding to the applicable AQL value(s). If different AQL's are assigned to each specification limit, designate the maximum allowable percent defective by M_L for the lower limit, and by M_U for the upper limit. If one AQL is assigned to

both limits combined, designate the maximum allowable percent defective by M. Table C-3 (see Fig. A1.14) is entered from the top for normal inspection and from the bottom for tightened inspection. Sampling plans for reduced inspection are provided in Table C-4 (see Fig. A1.15).

8.10 Drawing of Samples:

8.10.1 Samples shall be selected in accordance with 6.7.2.

8.11 Lot-by-lot Acceptability Procedures:

8.11.1 *Acceptability Criterion*—The degree of conformance of a quality characteristic with respect to a double specification limit shall be judged by the percent of nonconforming product. The percentage of nonconforming product is estimated by entering Table C-5 (see Fig. A1.16) with the quality index and the sample size.

8.11.2 *Computation of Quality Indices*—The quality indices $Q_U = (U - \bar{X})c/\bar{R}$ and $Q_L = (\bar{X} - L)c/\bar{R}$ shall be computed,

where:

U = the upper specification limit,

L = the lower specification limit,

c = a factor provided in Tables C-3 and C-4 (see Figs. A1.14 and A1.15),

\bar{X} = the sample mean, and

\bar{R} = the average range of the sample.

8.11.2.1 In this practice, \bar{R} is the average range of the subgroup ranges. Each of the subgroups consists of 5 measurements, except for those plans with sample size 3, 4, or 7 in which case the subgroup size is the same as the sample size. In computing \bar{R} , the order of the sample measurements as made must be retained. Subgroups of consecutive measurements must be formed and the range of each subgroup obtained. It is the average of the individual subgroup ranges.

8.11.3 *Percent Defective in the Lot*—The quality of a lot shall be expressed in terms of the lot percent defective. Its estimate will be designated by p_L , p_U , or p . The estimate p_U indicates conformance with respect to the upper specification limit, p_L with respect to the lower specification limit, and p for both specification limits combined. The estimates p_L and p_U shall be determined by entering Table C-5 (see Fig. A1.16), respectively with Q_L and Q_U and the sample size. The estimate p shall be determined by adding the corresponding estimated percent defectives p_L and p_U found in the table.

8.12 Acceptability Criterion and Summary for Operation of Sampling Plans:

8.12.1 One AQL Value for both Upper and Lower Specification Limit Combined:

8.12.1.1 *Acceptability Criterion* (see Example 8-3 (Fig. 7) for a complete example of this procedure)—Compare the estimated lot percent defective $p = p_U + p_L$ with the maximum allowable percent defective M. If p is equal to or less than M, the lot meets the acceptability criterion; if p is greater than M or if either Q_U or Q_L or both are negative, then the lot does not meet the acceptability criterion.

8.12.1.2 *Summary for Operation of Sampling Plan*—In cases where a single AQL value is established for the upper and lower specification limit combined for a single quality characteristic, the following steps summarize the procedures to be used:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and the inspection level.

(2) Select plan from Master Table C-3 or C-4 (see Figs. A1.14 and A1.15). Obtain the sample size n, the factor c, and the maximum allowable percent defective M.

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic on each unit of the sample.

(4) Compute the sample mean \bar{X} and average range of the sample \bar{R} .

(5) Compute the quality indices $Q_U = (U - \bar{X})c/\bar{R}$ and $Q_L = (\bar{X} - L)c/\bar{R}$.

(6) Determine the estimated lot percent defective $p = p_U + p_L$ from Table C-5 (see Fig. A1.16).

(7) If the estimated lot percent defective p is equal to or less than the maximum allowable percent defective M, the lot meets the acceptability criterion; if p is greater than M or if either Q_U or Q_L or both are negative, then the lot does not meet the acceptability criterion.

8.12.2 Different AQL values for Upper and Lower Specification Limit:

8.12.2.1 *Acceptability Criteria* (see Example 8-4 (Fig. 8) for a complete example of this procedure)—Compare the estimated lot percent defectives p_L and p_U with the corresponding maximum allowable percent defectives M_L and M_U ; also compare $p = p_L + p_U$ with the larger of M_L and M_U . If p_L is equal to or less than M_L , p_U is equal to or less than M_U , and p is equal to or less than the larger of M_L and M_U , the lot meets the acceptability criteria; otherwise, the lot does not meet the acceptability criteria. If either Q_L or Q_U or both are negative, then the lot does not meet the acceptability criteria.

8.12.2.2 *Summary for Operation of Sampling Plan*—In cases where a different AQL value is established for the upper and lower specification limit for a single quality characteristic, the following steps summarize the procedures to be used:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and inspection level.

(2) Select the sampling plan from Master Table C-3 or C-4 (see Figs. A1.14 and A1.15). Obtain the sample size n, the factor c, and the maximum allowable percent defectives M_U and M_L , corresponding to AQL values for the upper and lower specification limits, respectively.

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic on each unit in the sample.

(4) Compute the sample mean \bar{X} and average range of the sample \bar{R} .

(5) Compute the quality indices $Q_U = (U - \bar{X})c/\bar{R}$ and $Q_L = (\bar{X} - L)c/\bar{R}$.

(6) Determine the estimated lot percent defectives p_U and p_L , corresponding to the percent defectives above the upper and below the lower specification limits. Also determine the combined percent defective $p = p_U + p_L$.

(7) If all three of the following conditions are satisfied, the lot meets the acceptability criteria; otherwise, the lot does not meet the acceptability criteria. If either Q_L or Q_U or both are negative, then the lot does not meet the acceptability criteria.

(a) p_U is equal to or less than M_U

EXAMPLE 8-3

Example of Calculations

Double Specification Limit

Variability Unknown – Average Range Method

One AQL Value for both Upper and Lower Specification Limit Combined

Example The lower specification limit for electrical resistance of a certain electrical component is 620 ohms. A lot of 100 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 0.4 % is to be used. From Tables A-2 and C-1 it is seen that a sample of size 10 is required. Suppose that values of the sample resistances in the order reading from left to right are as follows:

$$643, 651, 619, 627, 658, (R_1 = 658 - 619 = 39)$$

$$670, 673, 641, 638, 650, (R_2 = 673 - 638 = 35)$$

and compliance with the acceptability criterion is to be determined.

<u>Line</u>	<u>Information Needed</u>	<u>Value Obtained</u>	<u>Explanation</u>
1	Sample Size: n	10	
2	Sum of Measurements: $\sum X$	6470	
3	Sample Mean $\bar{X} : \sum X/n$	647	6470/10
4	Average Range $\bar{R} : \sum R/\text{no. of subgroups}$	37	(39 + 35)/2
5	Factor c	2.405	See Table C-3
6	Upper Specification Limit: U	680	
7	Lower Specification Limit: L	620	
8	Quality Index: $Q_U = (U - \bar{X})c/\bar{R}$	2.15	(680 - 6470)2.405/37
9	Quality Index: $Q_L = (\bar{X} - L)c/\bar{R}$	1.76	(647 - 620)2.405/37
10	Est. of Lot Percent Def. Above U: p_U	0.35 %	See Table C-5
11	Est. of Lot Percent Def. Below L: p_L	2.54 %	See Table C-5
12	Total Est. Percent Def. in Lot: $p = p_U + p_L$	2.89 %	0.35 % + 2.54 %
13	Max. Allowable Percent Def.: M	1.14 %	See Table C-3
14	Acceptability Criterion: Compare $p = p_U + p_L$ with M	2.89 % > 1.14 %	See Sec. 8.12.1.2(7)

The lot does not meet the acceptability criterion, since $p = p_U + p_L$ is greater than M.

FIG. 7 Example 8-3

(b) p_L is equal to or less than M_L

(c) p is equal to or less than the larger of M_L and M_U

Part III—Estimation of Process Average and Criteria for Reduced and Tightened Inspection

8.13 *Estimation of Process Average*—The average percent defective, based upon a group of lots submitted for original inspection, is called the process average. Original inspection is the first inspection of a particular quantity of product submitted for acceptability as distinguished from the inspection of product which has been resubmitted after prior rejection. The process average shall be estimated from the results of inspection of samples drawn from a specified number of preceding lots for the purpose of determining severity of inspection during the course of a contract in accordance with 8.14.3. Any lot shall be included only once in estimating the process

average. The estimate of the process average is designated by \bar{p}_U when computed with respect to an upper specification limit, by \bar{p}_L when computed with respect to a lower specification limit, and by \bar{p} when computed with respect to a double specification limit.

8.13.1 *Abnormal Results*—The results of inspection of product manufactured under conditions not typical of usual production shall be excluded from the estimated process average.

8.13.2 *Computation of the Estimated Process Average*—The estimated process average is the arithmetic mean of the estimated lot percent defectives computed from the sampling inspection results of the preceding ten (10) lots or as may be otherwise designated. In order to estimate the lot percent defective, the quality indices Q_U and/or Q_L shall be computed for each lot. These are: $Q_U = (U - \bar{X})c/\bar{R}$ and $Q_L = (\bar{X} - L)c/\bar{R}$. (See 8.11.2.)

EXAMPLE 8-4

Example of Calculations

Double Specification Limit

Variability Unknown – Average Range Method

Different AQL Values for Upper and Lower Specification Limits

Example The lower specification limit for electrical resistance of a certain electrical component is 620 ohms. A lot of 100 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 0.4 % is to be used. From Tables A-2 and C-1 it is seen that a sample of size 10 is required. Suppose that values of the sample resistances in the order reading from left to right are as follows:

$$643, 651, 619, 627, 658, (R_1 = 658 - 619 = 39)$$

$$670, 673, 641, 638, 650, (R_2 = 673 - 638 = 35)$$

and compliance with the acceptability criterion is to be determined.

<u>Line</u>	<u>Information Needed</u>	<u>Value Obtained</u>	<u>Explanation</u>
1	Sample Size: n	10	
2	Sum of Measurements: $\sum X$	6470	
3	Sample Mean $\bar{X} : \sum X/n$	647	6470/10
4	Average Range $\bar{R} : \sum R/\text{no. of subgroups}$	37	(39 + 35)/2
5	Factor c	2.405	See Table C-3
6	Upper Specification Limit: U	680	
7	Lower Specification Limit: L	620	
8	Quality Index: $Q_U = (U - \bar{X})c / \bar{R}$	2.15	$(680 - 6470)2.405/37$
9	Quality Index: $Q_L = (\bar{X} - L)c / \bar{R}$	1.76	$(647 - 620)2.405/37$
10	Est. of Lot Percent Def. Above U: p_U	0.35 %	See Table C-5
11	Est. of Lot Percent Def. Below L: p_L	2.54 %	See Table C-5
12	Total Est. Percent Def. in Lot: $p = p_U + p_L$	2.89 %	0.35 % + 2.54 %
13	Max. Allowable Percent Def. Above U: M_U	7.42 %	See Table C-3
14	Max. Allowable Percent Def. Below L: M_L	3.23 %	See Table C-3
15	Acceptability Criterion:		
	(a) Compare p_U with M_U	0.35 % < 7.42 %	See Sec. 8.12.2.2(7)(a)
	(b) Compare p_L with M_L	2.54 % < 3.23 %	See Sec. 8.12.2.2(7)(b)
	(c) Compare p with M_U	2.89 % < 7.42 %	See Sec. 8.12.2.2(7)(c)

The lot meets the acceptability criteria, since 15(a), (b), and (c) are satisfied; that is, $p_U < M_U$, $p_L < M_L$ and $p < M_U$.

FIG. 8 Example 8-4

8.13.2.1 Single Specification Limit⁹—The estimated lot percent defective shall be determined from Table C-5 (see Fig. A1.16) for the plans based on the range method. The quality index Q_U shall be used for the case of an upper specification limit or Q_L for the case of a lower specification limit. Table C-5

is entered with Q_U or Q_L and the sample size, and the corresponding estimated lot percent defective p_U or p_L , respectively, is read from the table. The estimated process average \bar{p}_U is the arithmetic mean of the individual estimated lot percent defectives p_U 's. Similarly, the estimated process average \bar{p}_L is the arithmetic mean of the individual estimated lot percent defectives p_L 's.

8.13.2.2 Double Specification Limit—The estimated lot percent defective shall be determined from Table C-5 (see Fig.

⁹ When Form 1—Single Specification Limit is used for the acceptability criterion, the estimate of lot percent defective p_U or p_L is not obtained; in order to estimate the process average, it is necessary to complete 8.6.2 and 8.6.3 of Form 2.

A1.16) for the plans based on the range method. The quality indices Q_U and Q_L shall be computed. Table C-5 is entered separately with Q_U and Q_L and the sample size, and the corresponding p_U and p_L are read from the table. The estimated lot percent defective is $p = p_U + p_L$. The estimated process average \bar{p} is the arithmetic mean of the individual estimated lot percent defectives p 's.

8.13.2.3 Special Case—If the quality index Q_U or Q_L is a negative number, then Table C-5 (see Fig. A1.16) is entered by disregarding the negative sign. However, in this case the estimated lot percent defective above the upper limit or below the lower limit is obtained by subtracting the percentage found in the table from 100 %.¹⁰

8.14 Normal, Tightened and Reduced Inspection—This practice established sampling plans for normal, tightened, and reduced inspection.

8.14.1 At Start of Inspection—Normal inspection shall be used at the start of inspection unless otherwise designated.

8.14.2 During Inspection—During the course of inspection, normal inspection shall be used when inspection conditions are such that tightened or reduced inspection is not required in accordance with **8.14.3** and **8.14.4**.

8.14.3 Tightened Inspection—Tightened inspection shall be instituted when the estimated process average computed from the preceding ten (10) lots (or such other number of lots designated) in accordance with **8.13.2** is greater than the AQL, and when more than a certain number T of these lots have estimates of the percent defective exceeding the AQL. The T -values are given in Table C-6 (see Fig. A1.17) for the process average computed from 5, 10 or 15 lots. Normal inspection shall be reinstated if the estimated process average of lots under tightened inspection is equal to or less than the AQL.

8.14.4 Reduced Inspection—Reduced inspection may be instituted provided that all of the following conditions are satisfied:

8.14.4.1 Condition A—The preceding ten (10) lots (or such other number of lots designated) have been under normal inspection and none has been rejected.

8.14.4.2 Condition B—The estimated percent defective for each of these preceding lots is less than the applicable lower limit shown in Table C-7 (see Fig. A1.18); or for certain sampling plans, the estimated lot percent defective is equal to zero for a specified number of consecutive lots (see Table C-7).

8.14.4.3 Condition C—Production is at a steady rate.

8.14.4.4 Normal inspection shall be reinstated if any one of the following conditions occurs under reduced inspection:

8.14.4.5 Condition D—A lot is rejected.

8.14.4.6 Condition E—The estimated process average is greater than the AQL.

8.14.4.7 Condition F—Production becomes irregular or delayed.

8.14.4.8 Condition G—Other conditions as may warrant that normal inspection should be reinstated.

8.14.5 Sampling Plans for Tightened or Reduced Inspection—Sampling plans for tightened and reduced inspection are provided in Section 8, Parts I and II.

9. Variability Known

Part I—Single Specification Limit

9.1 Sampling Plan for Single Specification Limit—This part of the practice describes the procedures for use with plans for a single specification limit when variability of the lot with respect to the quality characteristic is known. The acceptability criterion is given in two equivalent forms. These are identified as Form 1 and Form 2.

9.1.1 Use of Sampling Plans—To determine whether the lot meets the acceptability criterion with respect to a particular quality characteristic and AQL value, the applicable sampling plan shall be used in accordance with the provisions of Section 6, General Description of Sampling Plans, and those in this part of the practice.

9.1.2 Drawing of Samples—All samples shall be drawn in accordance with **6.7.2**.

9.1.3 Determination of Sample Size Code Letter—The sample size code letter shall be selected from Table A-2 (see Fig. A1.2) in accordance with **6.7.1**.

9.2 Selecting the Sampling Plan When Form 1 is Used:

9.2.1 Master Sampling Tables—The master sampling tables for plans based on variability known for a single specification limit are Tables D-1 and D-2 (see Figs. A1.20 and A1.21). Table D-1 is used for normal and tightened inspection and Table D-2 for reduced inspection.

9.2.2 Obtaining Sampling Plan—The sampling plan consists of a sample size and an associated acceptability constant.¹¹ The sampling plan is obtained from Master Table D-1 and D-2 (see Figs. A1.20 and A1.21).

9.2.2.1 Sample Size—The sample size n is shown in the master table corresponding to each sample size code letter and AQL.

9.2.2.2 Acceptability Constant—The acceptability constant k , corresponding to the sample size mentioned in **9.2.2.1**, is indicated in the column of the master table corresponding to the applicable AQL value. Table D-1 (see Fig. A1.20) is entered from the top for normal inspection and from the bottom for tightened inspection. Sampling plans for reduced inspection are provided in Table D-2 (see Fig. A1.21).

9.3 Lot-by-lot Acceptability Procedures When Form 1 is Used (see Example 9-1 (Fig. 9) for a complete example of this procedure):

9.3.1 Acceptability Criterion—The degree of conformance of a quality characteristic with respect to a single specification limit shall be judged by the quantity $(U - \bar{X})/\sigma$ or $(\bar{X} - L)/\sigma$.

9.3.2 Computation—The following quantity shall be computed: $(U - \bar{X})/\sigma$ or $(\bar{X} - L)/\sigma$, depending on whether the specification limit is an upper or a lower limit,

¹⁰ For example, if $Q_U = -0.50$ and $Q_L = 1.60$, using sample size 60, $p_U = 100 \% - 30.94 \% = 69.06 \%$, $p_L = 5.32 \%$ and $p = 69.06 \% + 5.32 \% = 74.38 \%$.

¹¹ See Section 9 Definitions in Annex A1 for definitions of all symbols used in the sampling plans based on variability known.

EXAMPLE 9-1
 Example of Calculations
 Single Specification Limit-Form 1
 Variability Known

Example The specified minimum yield point for certain steel castings is 58,000 psi. A lot of 500 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 1.5 % is to be used. The variability σ is known to be 3000 psi. From Tables A-2 and D-1 it is seen that a sample of size 10 is required. Suppose the yield points of the sample specimens are:

$$62,500; 60,500; 68,000; 59,000; 65,500; \\ 62,000; 61,000; 69,000; 58,000; 64,500;$$

and compliance with the acceptability criterion is to be determined.

Line	Information Needed	Value Obtained	Explanation
1	Sample Size: n	10	
2	Known Variability: σ	3 000	
3	Sum of Measurements: $\sum X$	630 000	
4	Sample Mean \bar{X} : $\sum X/n$	63 000	630 000/10
5	Specification Limit (Lower): L	58 000	
6	The quantity: $(\bar{X} - L)/\sigma$	1.67	$(63,000 - 58,000)/3,000$
7	Acceptability Constant: k	1.70	See Table D-1
8	Acceptability Criterion: Compare $(\bar{X} - L)/\sigma$ with k	1.67 < 1.70	See Section 9.3.3

The lot does not meet the acceptability criterion, since $(\bar{X} - L)/\sigma$ is less than k.

NOTE: If a single upper specification limit U is given, then compute the quantity $(U - \bar{X})/\sigma$ in line 6 and compare it with k; the lot meets the acceptability criterion, if $(U - \bar{X})/\sigma$ is equal to or greater than k.

FIG. 9 Example 9-1

where:

U = the upper specification limit,
 L = the lower specification limit,
 \bar{X} = the sample mean, and
 σ = the known variability.

9.3.3 Acceptability Criterion—Compare the quantity $(U - \bar{X})/\sigma$ or $(\bar{X} - L)/\sigma$ with the acceptability constant k. If $(U - \bar{X})/\sigma$ or $(\bar{X} - L)/\sigma$ is equal to or greater than k, the lot meets the acceptability criterion; if $(U - \bar{X})/\sigma$ or $(\bar{X} - L)/\sigma$ is less than k or negative, then the lot does not meet the acceptability criterion.

9.4 Summary for Operation of Sampling Plan When Form 1 is Used:

9.4.1 The following steps summarize the procedures to be followed:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and the inspection level.

(2) Obtain plan from Master Table D-1 or D-2 (see Figs. A1.20 and A1.21) by selecting the sample size n and the acceptability constant k.

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic for each unit of the sample.

(4) Compute the sample mean \bar{X} , and also compute the quantity $(U - \bar{X})/\sigma$ for an upper specification limit U or the quantity $(\bar{X} - L)/\sigma$ for a lower specification limit L.

(5) If the quantity $(U - \bar{X})/\sigma$ or $(\bar{X} - L)/\sigma$ is equal to or greater than k, the lot meets the acceptability criterion; if $(U - \bar{X})/\sigma$ or $(\bar{X} - L)/\sigma$ is less than k or negative, then the lot does not meet the acceptability criterion.

9.5 Selecting the Sampling Plan When Form 2 is Used:

9.5.1 Master Sampling Tables—The master sampling tables for plans based on variability known for a single specification limit are Tables D-3 and D-4 (see Figs. A1.22 and A1.23) of Part II. Table D-3 is used for normal and tightened inspection and Table D-4 for reduced inspection.

9.5.2 Obtaining the Sampling Plan—The sampling plan consists of a sample size and an associated maximum allowable percent defective. The sampling plan is obtained from Master Table D-3 or D-4 (see Figs. A1.22 and A1.23).

9.5.2.1 Sample Size—The sample size n is shown in the master table corresponding to each sample size code letter.

9.5.2.2 Maximum Allowable Percent Defective—The maximum allowable percent defective M for sample estimates corresponding to the sample size mentioned in **9.5.2.1** is indicated in the column of the master table corresponding to

the applicable AQL value. Table D-3 (see Fig. A1.22) is entered from the top for normal inspection and from the bottom for tightened inspection. Sampling plans for reduced inspection are provided in Table D-4 (see Fig. A1.23).

9.6 Lot-by-lot Acceptability Procedures When Form 2 is Used (see Example 9-2 (Fig. 10) for a complete example of this procedure):

9.6.1 Acceptability Criterion—The degree of conformance of a quality characteristic with respect to a single specification limit shall be judged by the percent of nonconforming product outside the upper or lower specification limit. The percentage of nonconforming product is estimated by entering Table D-5 (see Fig. A1.24) with the quality index.

9.6.2 Computation of Quality Index—The quality index $Q_U = (U - \bar{X})v/\sigma$ shall be computed if the specification limit is an upper limit U, or $Q_L = (\bar{X} - L)v/\sigma$ if it is a lower limit L. The quantities, \bar{X} and σ , are the sample mean and known variability, respectively. The factor v is provided in Tables D-3 and D-4 (see Figs. A1.22 and A1.23) corresponding to the sample size.

9.6.3 Estimate of Percent Defective in Lot—The quality of a lot shall be expressed by p_U , the estimated percent defective in the lot above the upper specification limit, or by p_L , the estimated percent defective below the lower specification limit. The estimated percent defective p_U or p_L is obtained by entering Table D-5 (see Fig. A1.24) with Q_U or Q_L .

9.6.4 Acceptability Criterion—Compare the estimated of percent defective p_U or p_L with the maximum allowable percent defective M. If p_U or p_L is equal to or less than M, the lot meets the acceptability criterion; if p_U or p_L is greater than M or if Q_U or Q_L is negative, then the lot does not meet the acceptability criterion.

9.7 Summary for Operation of Sampling Plan When Form 2 is Used:

9.7.1 The following steps summarize the procedures to be followed:

- (1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and the inspection level.

EXAMPLE 9-2

Example of Calculations
Single Specification Limit-Form 2
Variability Known

Example The specified minimum yield point for certain steel castings is 58 000 psi. A lot of 500 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 1.5 % is to be used. The variability σ is known to be 3000 psi. From Tables A-2 and D-1 it is seen that a sample of size 10 is required. Suppose the yield points of the sample specimens are:

$$62\ 500; 60\ 500; 68\ 000; 59\ 000; 65\ 500; \\ 62\ 000; 61\ 000; 69\ 000; 58\ 000; 64\ 500;$$

and compliance with the acceptability criterion is to be determined.

Line	Information Needed	Value Obtained	Explanation
1	Sample Size: n	10	
2	Known Variability: σ	3 000	
3	Sum of Measurements: $\sum X$	630 000	
4	Sample Mean \bar{X} : $\sum X/n$	63 000	630 000/10
5	Factor: v	1.054	
6	Specification Limit (Lower): L	58 000	
7	Quality Index: $Q_L = (\bar{X} - L)v/\sigma$	1.76	$(63\ 000 - 58\ 000)1.054/3\ 000$
8	Est. of Lot Percent Def.: p_L	3.92 %	See Table D-5
9	Max. Allowable Percent Def.: M	3.63 %	See Table D-3
10	Acceptability Criterion: Compare p_L with M	3.92 % > 3.63 %	See Section 9.6.4

The lot does not meet the acceptability criterion, since p_L is greater than M.

NOTE: If a single upper specification limit U is given, then compute the quality index $Q_U = (U - \bar{X})v/\sigma$ in line 7 and obtain the estimate of lot percent defective p_U . Compare p_U with M; the lot meets the acceptability criterion, if p_U is equal to or less than M.

FIG. 10 Example 9-2

(2) Obtain plan from Master Table D-3 or D-4 (see Figs. A1.22 and A1.23) by selecting the sample size n , the factor v , and the maximum allowable percent defective M .

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic on each unit of the sample.

(4) Compute the sample mean \bar{X} .

(5) Compute the quality index $Q_U = (U - \bar{X})v/\sigma$ if an upper specification limit U is specified, or $Q_L = (\bar{X} - L)v/\sigma$ if a lower specification limit L is specified.

(6) Determine the estimated lot percent defective p_U or p_L from Table D-5 (see Fig. A1.24).

(7) If the estimated lot percent defective p_U or p_L is equal to or less than the maximum allowable percent defective M , the lot meets the acceptability criterion; if p_U or p_L is greater than M or if Q_U or Q_L is negative, then the lot does not meet the acceptability criterion.

Part II—Double Specification Limit

9.8 Sampling Plan for Double Specification Limit—This part of the practice describes the procedures for use with plans for a double specification limit when variability of the lot with respect to the quality characteristic is known.

9.8.1 Use of Sampling Plans—To determine whether the lot meets the acceptability criterion with respect to a particular quality characteristic and AQL value(s), the applicable sampling plan shall be used in accordance with the provisions of Section 6, General Description of Sampling Plans, and those in this part of the practice.

9.9 Selecting the Sampling Plan—A sampling plan for each AQL value shall be selected from Table D-3 or D-4 (see Figs. A1.22 and A1.23) as follows:

9.9.1 Determination of Sample Size Code Letter—The sample size code letter shall be selected from Table A-2 (see Fig. A1.2) in accordance with 6.7.1.

9.9.2 Master Sampling Tables—The master sampling tables for plans based on variability known for a double specification limit are Tables D-3 and D-4 (see Figs. A1.22 and A1.23). Table D-3 is used for normal and tightened inspection and Table D-4 for reduced inspection.

9.9.3 Obtaining Sampling Plan—A sampling plan consists of a sample size and an associated maximum allowable percent defective(s). The sampling plan to be applied in Inspection shall be obtained from Master Table D-3 or D-4 (see Figs. A1.22 and A1.23).

9.9.3.1 Sample Size—The sample size n is shown in the master tables corresponding to each sample size code letter and AQL.

9.9.3.2 Maximum Allowable Percent Defective—The maximum allowable percent defective for sample estimates of percent defective for the lower, upper, or both specification limits combined, corresponding to the sample size mentioned in 9.9.3.1, is shown in the column of the master table corresponding to the applicable AQL value(s). If different AQL's are assigned to each specification limit, designate the maximum allowable percent defective by M_L for the lower limit, and by M_U for the upper limit. If one AQL is assigned to both limits combined, designate the maximum allowable per-

cent defective by M . Table D-3 (see Fig. A1.22) is entered from the top for normal inspection and from the bottom for tightened inspection. Sampling plans for reduced inspection are provided in Table D-4 (see Fig. A1.23).

9.10 Drawing of Samples:

9.10.1 Samples shall be selected in accordance with 6.7.2.

9.11 Lot-by-lot Acceptability Procedures:

9.11.1 Acceptability Criterion—The degree of conformance of a quality characteristic with respect to a double specification limit shall be judged by the percent of nonconforming product. The percentage of nonconforming product is estimated by entering Table D-5 with the quality index.

9.11.2 Computation of Quality Indices—The quality indices $Q_U = (U - \bar{X})v/\sigma$ and $Q_L = (\bar{X} - L)v/\sigma$ shall be computed,

where:

U = the upper specification limit,

L = the lower specification limit,

v = a factor provided in Tables D-3 and D-4 (see Figs. A1.22 and A1.23),

\bar{X} = the sample mean, and

σ = the known variability.

9.11.3 Percent Defective in the Lot—The quality of a lot shall be expressed in terms of the lot percent defective. Its estimate will be designated by p_L , p_U , or p . The estimate p_U indicates conformance with respect to the upper specification limit, p_L with respect to the lower specification limit, and p for both specification limits combined. The estimates p_L and p_U shall be determined by entering Table D-5 (see Fig. A1.24), respectively with Q_L and Q_U . The estimate p shall be determined by adding the corresponding estimated percent defectives p_L and p_U found in the table.

9.12 Acceptability Criterion and Summary for Operation of Sampling Plans:

9.12.1 One AQL value for both Upper and Lower Specification Limit Combined:

9.12.1.1 Acceptability Criterion (see Example 9-3 (Fig. 11) for a complete example of this procedure)—Compare the estimated lot percent defective $p = p_U + p_L$ with the maximum allowable percent defective M . If p is equal to or less than M , the lot meets the acceptability criterion; if p is greater than M or if Q_U or Q_L or both are negative, then the lot does not meet the acceptability criterion.

9.12.1.2 Summary of Operation of Sampling Plan—In cases where a single AQL value is established for the upper and lower specification limit combined for a single quality characteristic, the following steps summarize the procedures to be used:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and the inspection level.

(2) Select plan from Master Table D-3 or D-4 (see Figs. A1.22 and A1.23). Obtain the sample size n , the factor v , and the maximum allowable percent defective M .

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic on each unit of the sample.

(4) Compute the sample mean \bar{X} .

(5) Compute the quality indices $Q_U = (U - \bar{X})v/\sigma$ and $Q_L = (\bar{X} - L)v/\sigma$.

EXAMPLE 9-3

Example of Calculations
Double Specification Limit
Variability Known

One AQL Value for both Upper and Lower Specification Limit Combined

Example The specified maximum and minimum yield points for certain steel castings are 67 000 psi and 58 000 psi, respectively. A lot of 500 items is submitted for inspection. Inspection Level IV, normal inspection, with AQL = 1.5 % is to be used. The variability is known to be 3 000 psi. From Tables A-2 and D-3 it is seen that a sample of size 10 is required. Suppose the yield points of the sample specimens are:

$$62\ 500; 60\ 500; 68\ 000; 59\ 000; 65\ 500; \\ 62\ 000; 61\ 000; 69\ 000; 58\ 000; 64\ 500;$$

and compliance with the acceptability criterion is to be determined.

<u>Line</u>	<u>Information Needed</u>	<u>Value Obtained</u>	<u>Explanation</u>
1	Sample Size: n	10	
2	Known Variability: σ	3 000	
3	Sum of Measurements: $\sum X$	630 000	
4	Sample Mean \bar{X} : $\sum X/n$	63 000	630,000/10
5	Factor: v	1.054	See Table D-3
6	Upper Specification Limit: U	67 000	
7	Lower Specification Limit: L	58 000	
8	Quality Index: $Q_U = (U - \bar{X})v / \sigma$	1.41	$(67\ 000 - 63\ 000)1.054/3\ 000$
9	Quality Index: $Q_L = (\bar{X} - L)v / \sigma$	1.76	$(63\ 000 - 58\ 000)1.054/3\ 000$
10	Est. of Lot Percent Def. Above U : p_U	7.93 %	See Table D-5
11	Est. of Lot Percent Def. Below L : p_L	3.92 %	See Table D-5
12	Total Est. Percent Def. in Lot: $p = p_U + p_L$	11.85 %	7.93 % + 3.92 %
13	Max. Allowable Percent Def.: M	3.63 %	See Table D-3
14	Acceptability Criterion: Compare $p = p_U + p_L$ with M	11.85 % > 3.63 %	See Section 9.11.4

The lot does not meet the acceptability criterion, since $p = p_U + p_L$ is greater than M .

FIG. 11 Example 9-3

(6) Determine the estimated lot percent defective $p = p_U + p_L$ from Table D-5 (see Fig. A1.24).

(7) If the estimated lot percent defective p is equal to or less than the maximum allowable percent defective M , the lot meets the acceptability criterion; if p is greater than M or if Q_U or Q_L or both are negative, then the lot does not meet the acceptability criterion.

9.12.2 Different AQL Values for Upper and Lower Specification Limit:

9.12.2.1 Acceptability Criteria (see Example 9-4 (Fig. 12) for a complete example of this procedure)—Compare the estimated of percent defectives p_L and p_U with the corresponding maximum allowable percent defectives M_L and M_U ; also compare $p = p_L + p_U$ with the larger of M_L and M_U . If p_L is

equal to or less than M_L , p_U is equal to or less than M_U , and p is equal to or less than the larger of M_L and M_U , the lot meets the acceptability criteria; otherwise, the lot does not meet the acceptability criteria. If either Q_L or Q_U or both are negative, then the lot does not meet the acceptability criteria.

9.12.2.2 Summary of Operation of Sampling Plan—In cases where a different AQL value is established for the upper and lower specification limit for a single quality characteristic, the following steps summarize the procedures to be used:

(1) Determine the sample size code letter from Table A-2 (see Fig. A1.2) by using the lot size and inspection level.

(2) Select the sampling plan from Master Table D-3 or D-4 (see Figs. A1.22 and A1.23). Obtain the sample size n and the factor v , corresponding to the larger of the two AQL values,

EXAMPLE 9-4

Example of Calculations
 Double Specification Limit
 Variability Known
 Different AQL Values for Upper and Lower Specification Limits

Example The specified maximum and minimum yield points for certain steel castings are 67 000 psi and 58 000 psi, respectively. A lot of 500 items is submitted for inspection. Inspection Level IV, normal inspection with AQL = 1 % for the upper and AQL = 2.5 % for the lower specification limit is to be used. The variability σ is known to be 3 000 psi. From Tables A-2 and D-3 it is seen that a sample of size 11 corresponding to the sample size code letter, I, and the AQL value of 2.5 % is required. Suppose the yield points of the sample specimens are:

62 500; 60 500; 64 000; 59 000; 65 500;
 62 000; 61 000; 60 631; 68 000; 62 000; 63 000

and compliance with the acceptability criteria is to be determined.

<u>Line</u>	<u>Information Needed</u>	<u>Value Obtained</u>	<u>Explanation</u>
1	Sample Size: n	11	
2	Known Variability: σ	3 000	
3	Sum of Measurements: $\sum X$	678 131	
4	Sample Mean \bar{X} : $\sum X/n$	61 648	678 131/11
5	Factor: v	1.049	See Table D-3
6	Upper Specification Limit: U	67 000	
7	Lower Specification Limit: L	58,000	
8	Quality Index: $Q_U = (U - \bar{X})v / \sigma$	1.87	$(67 000 - 61 648)1.049/3 000$
9	Quality Index: $Q_L = (\bar{X} - L)v / \sigma$	1.28	$(61 648 - 58 000)1.049/3 000$
10	Est. of Lot Percent Def. Above U: p_U	3.07 %	See Table D-5
11	Est. of Lot Percent Def. Below L: p_L	10.03 %	See Table D-5
12	Total Est. Percent Def. in Lot: $p = p_U + p_L$	13.10 %	3.07 % + 10.03 %
13	Max. Allowable Percent Def. Above U: M_U	2.59 %	See Table D-3
14	Max. Allowable Percent Def. Below L: M_L	5.60 %	See Table D-3
15	Acceptability Criterion:		
	(a) Compare p_U with M_U	3.07 % > 2.59 %	See Section 9.12.2.2(7)(a)
	(b) Compare p_L with M_L	10.03 % > 5.60 %	See Section 9.12.2.2(7)(b)
	(c) Compare p with M_L	13.10 % > 5.60 %	See Section 9.12.2.2(7)(c)

The lot does not meet the acceptability criteria, since 15(a), (b), and (c) are not satisfied; that is, $p_U > M_U$, $p_L > M_L$ and $p > M_L$.

FIG. 12 Example 9-4

and also the maximum allowable percent defectives M_U and M_L , corresponding to the AQL values for the upper and lower specification limits, respectively.

(3) Select at random the sample of n units from the lot; inspect and record the measurement of the quality characteristic on each unit in the sample.

(4) Compute the sample mean \bar{X} .

(5) Compute the quality indices $Q_U = (U - \bar{X})v/\sigma$ and $Q_L = (\bar{X} - L)v/\sigma$.

(6) Determine the estimated lot percent defectives p_U and p_L , corresponding to the percent defectives above the upper and below the lower specification limits. Also determine the combined percent defective $p = p_U + p_L$.

(7) If all three of the following conditions are satisfied, the lot meets the acceptability criteria; otherwise, the lot does not meet the acceptability criteria. If either Q_L or Q_U or both are negative, then the lot does not meet the acceptability criteria.

(a) p_U is equal to or less than M_U

(b) p_L is equal to or less than M_L

(c) p is equal to or less than the larger of M_U and M_L

Part III—Estimation of Process Average and Criteria for Reduced and Tightened Inspection

9.13 Estimation of Process Average—The average percent defective, based upon a group of lots submitted for original inspection, is called the process average. Original inspection is the first inspection of a particular quantity of product submitted for acceptability as distinguished from the inspection of product which has been resubmitted after prior rejection. The process average shall be estimated from the results of inspection of samples drawn from a specified number of preceding lots for the purpose of determining severity of inspection during the course of a contract in accordance with 9.14.3. Any lot shall be included only once in estimating the process average. The estimate of the process average is designated by \bar{p}_U when computed with respect to an upper specification limit, by \bar{p}_L when computed with respect to a lower specification limit, and by \bar{p} when computed with respect to a double specification limit.

9.13.1 Abnormal Results—The results of inspection of product manufactured under conditions not typical of usual production shall be excluded from the estimated process average.

9.13.2 Computation of the Estimated Process Average—The estimated process average is the arithmetic mean of the estimated lot percent defective computed from the sampling inspection results of the preceding ten (10) lots or as may be otherwise designated. In order to estimate the lot percent defective, the quality indices Q_U and/or Q_L shall be computed for each lot. These are: $Q_U = (U - \bar{X})v/\sigma$ and $Q_L = (\bar{X} - L)v/\sigma$. (See 7.11.2.)

9.13.2.1 Single Specification Limit¹²—The estimated lot percent defective shall be determined from Table D-5 (see Fig. A1.24) for the plans based on known variability. The quality index Q_U shall be used for the case of an upper specification limit or Q_L for the case of a lower specification limit. Table D-5 is entered with Q_U or Q_L and the corresponding estimated lot percent defective p_U or p_L , respectively, is read from the table. The estimated process average \bar{p}_U is the arithmetic mean of the individual estimated lot percent defectives p_U 's. Similarly, the estimated process average \bar{p}_L is the arithmetic mean of the individual estimated lot percent defectives p_L 's.

¹² When Form 1—Single Specification Limit is used for the acceptability criterion, the estimate of lot percent defective p_U or p_L is not obtained; in order to estimate the process average, it is necessary to complete 9.6.1 and 9.6.3 of Form 2.

9.13.2.2 Double Specification Limit—The estimated lot percent defective shall be determined from Table D-5 (see Fig. A1.24) for the plans based on variability known. The quality indices Q_U and Q_L shall be computed. Table D-5 is entered separately with Q_U and Q_L and the corresponding p_U and p_L are read from the table. The estimated lot percent defective is $p = p_U + p_L$. The estimated process average \bar{p} is the arithmetic mean of the individual estimated lot percent defectives p 's.

9.13.2.3 Special Case—If the quality index Q_U or Q_L is a negative number, then Table D-5 (see Fig. A1.24) is entered by disregarding the negative sign. However, in this case the estimated lot percent defective above the upper limit or below the lower limit is obtained by subtracting the percentage found in the table from 100 %.¹³

9.14 Normal, Tightened, and Reduced Inspection—This practice establishes sampling plans for normal, tightened, and reduced inspection.

9.14.1 At Start of Inspection—Normal inspection shall be used at the start of inspection unless otherwise designated.

9.14.2 During Inspection—During the course of inspection, normal inspection shall be used when inspection conditions are such that tightened or reduced inspection is not required in accordance with 9.14.3 and 9.14.4.

9.14.3 Tightened Inspection—Tightened inspection shall be instituted when the estimated process average computed from the preceding ten (10) lots (or such other number of lots designated) in accordance with 9.13.2 is greater than the AQL, and when more than a certain number T of these lots have estimates of the percent defective exceeding the AQL. The T -values are given in Table D-6 (see Fig. A1.25) when the process average is computed from 5, 10, or 15 lots. Normal inspection shall be reinstated if the estimated process average of lots under tightened inspection is equal to or less than the AQL.

9.14.4 Reduced Inspection—Reduced inspection may be instituted provided that all of the following conditions are satisfied:

9.14.4.1 Condition A—The preceding ten (10) lots (or such other number of lots designated) have been under normal inspection and none has been rejected.

9.14.4.2 Condition B—The estimated percent defective for each of these preceding lots is less than the applicable lower limit shown in Table D-7 (see Fig. A1.26).

9.14.4.3 Condition C—Production is at a steady rate.

9.14.4.4 Normal inspection shall be reinstated if any one of the following conditions occurs under reduced inspection:

9.14.4.5 Condition D—A lot is rejected.

9.14.4.6 Condition E—The estimated process average is greater than the AQL.

9.14.4.7 Condition F—Production becomes irregular or delayed.

9.14.4.8 Condition G—Other conditions as may warrant that normal inspection should be reinstated.

¹³ For example, if $Q_U = -0.50$ and $Q_L = 1.60$, then $p_U = 100\% - 30.854\% = 69.146\%$, $p_L = 5.48\%$ and $p = 69.146\% + 5.48\% = 74.626\%$.

9.14.5 Sampling Plans for Tightened or Reduced Inspection—Sampling plans for tightened and reduced inspection are provided in Section 9, Parts I and II.

inspection; inspection by attributes; inspection by variables; lot; lot size; major defects; minor defects; mixed variables-attributes inspection; percent defective; quality characteristic; sampling plans; specification limits; unit of product

10. Keywords

10.1 acceptability constant; acceptability criterion; acceptable quality level; classification of defects; critical defects;

ANNEX

(Mandatory Information)

A1. DEFINITIONS AND TABLES

Section 7 Definitions
Section 8 Definitions
Section 9 Definitions

Table A-1 (Fig. A1.1)
Table A-2 (Fig. A1.2)
Table A-3 (Fig. A1.3)

AQL Conversion Table
Sample Size Code Letters
Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9
(Graphs for Sample Size Code Letters B through Q)^A

Table B-1 (Fig. A1.4)
Table B-2 (Fig. A1.5)
Table B-3 (Fig. A1.6)
Table B-4 (Fig. A1.7)
Table B-5 (Fig. A1.8)
Table B-6 (Fig. A1.9)
Table B-7 (Fig. A1.10)
Table B-8 (Fig. A1.11)

Master Table for Normal and Tightened Inspection (Form 1 - Single Limit)^A
Master Table for Reduced Inspection (Form 1 - Single Limit)^A
Master Table for Normal and Tightened Inspection (Double Limit and Form 2 - Single Limit)^A
Master Table for Reduced Inspection (Double Limit and Form 2 - Single Limit)^A
Table for Estimating the Lot Percent Defective
Values of T for Tightened Inspection^A
Limits of Estimated Lot Percent Defective for Reduced Inspection^A
Values of F for Maximum Standard Deviation (MSD)^A

Table C-1 (Fig. A1.12)
Table C-2 (Fig. A1.13)
Table C-3 (Fig. A1.14)
Table C-4 (Fig. A1.15)
Table C-5 (Fig. A1.16)
Table C-6 (Fig. A1.17)
Table C-7 (Fig. A1.18)
Table C-8 (Fig. A1.19)

Master Table for Normal and Tightened Inspection (Form 1 - Single Limit)^A
Master Table for Reduced Inspection (Form 1 - Single Limit)^A
Master Table for Normal and Tightened Inspection (Double Limit and Form 2 - Single Limit)^A
Master Table for Reduced Inspection (Double Limit and Form 2 - Single Limit)^A
Table for Estimating the Lot Percent Defective
Values of T for Tightened Inspection^A
Limits of Estimated Lot Percent Defective for Reduced Inspection^A
Values of f for Maximum Average Range (MAR)^A

Table D-1 (Fig. A1.20)
Table D-2 (Fig. A1.21)
Table D-3 (Fig. A1.22)
Table D-4 (Fig. A1.23)
Table D-5 (Fig. A1.24)
Table D-6 (Fig. A1.25)
Table D-7 (Fig. A1.26)

Master Table for Normal and Tightened Inspection (Form 1 - Single Limit)^A
Master Table for Reduced Inspection (Form 1 - Single Limit)^A
Master Table for Normal and Tightened Inspection (Double Limit and Form 2 - Single Limit)^A
Master Table for Reduced Inspection (Double Limit and Form 2 - Single Limit)^A
Table for Estimating the Lot Percent Defective
Values of T for Tightened Inspection^A
Limits of Estimated Lot Percent Defective for Reduced Inspection^A

^A This original table contains the wording “acceptable” instead of the now recognized term “acceptance” for the AQL value.

Section 7 Definitions

Symbol	Read	Definition
n		Sample size for a single lot.
\bar{X}	X bar	Sample mean. Arithmetic mean of sample measurements from a single lot.
s		Estimate of lot standard deviation. Standard deviation of sample measurements from a single lot. (See Examples in Section 5.)
U		Upper specification limit.
L		Lower specification limit.

k		The acceptability constant given in Tables B-1 and B-2 (see Figs. A1.4 and A1.5). ^A
Q_U	Q sub U	Quality index for use with Table B-5 (see Fig. A1.8).
Q_L	Q sub L	Quality index for use with Table B-5 (see Fig. A1.8).
p_U	p sub U	Sample estimate of the lot percent defective above U from Table B-5 (see Fig. A1.8).
p_L	p sub L	Sample estimate of the lot percent defective below L from Table B-5 (see Fig. A1.8).
p		Total sample estimate of the lot percent defective $p = p_U + p_L$.
M		Maximum allowable percent defective for sample estimates given in Tables B-3 and B-4 (see Figs. A1.6 and A1.7).
M_U	M sub U	Maximum allowable percent defective above U given in Tables B-3 and B-4 (see Figs. A1.6 and A1.7). (For use when different AQL values for U and L are specified.)
M_L	M sub L	Maximum allowable percent defective below L given in Tables B-3 and B-4 (see Figs. A1.6 and A1.7). (For use when different AQL values for U and L are specified.)
\bar{p}	p bar	Sample estimate of the process percent defective, that is, the estimated process average.
\bar{p}_U	p bar sub U	The estimated process average for an upper specification limit.
\bar{p}_L	p bar sub L	The estimated process average for a lower specification limit.
T		The maximum number of estimated process averages which may exceed the AQL given in Table B-6 (see Fig. A1.9). (For use in determining application of tightened inspection.)
F		A factor used in determining the Maximum Standard Deviation (MSD). The F values are given in Table B-8 (see Fig. A1.11).
>	Greater than	Greater than
<	Less than	Less than
Σ	Sum of	Sum of

^A This original table contains the wording “acceptable” instead of the now recognized term “acceptance” for the AQL value.

Section 8 Definitions

Symbol	Read	Definition
n		Sample size for a single lot.
\bar{X}	X bar	Sample mean. Arithmetic mean of sample measurements from a single lot.
R		Range. The difference between the largest and smallest measurements in a subgroup. In this practice, the subgroup size is S except for those plans in which $n = 3, 4$, or 7 , in which case the subgroup is the same as the sample size.
R_1		Range of the first subgroup.
R_2		Range of the second subgroup.
\bar{R}	R bar	Average range. The arithmetic mean of the range values of the subgroups of the sample measurements from a single lot.
U		Upper specification limit.
L		Lower specification limit.
k		The acceptability constant given in Tables C-1 and C-2 (see Figs. A1.12 and A1.13). ^A
c		A factor used in determining the quality index when using the range method. The c values are given in Tables C-3 and C-4 (see Figs. A1.14 and A1.15).
Q_U	Q sub U	Quality index for use with Table C-5 (see Fig. A1.16).
Q_L	Q sub L	Quality index for use with Table C-5 (see Fig. A1.16).

p_U	$p_{\text{sub } U}$	Sample estimate of the lot percent defective above U from Table C-5 (see Fig. A1.16).
p_L	$p_{\text{sub } L}$	Sample estimate of the lot percent defective below L from Table C-5 (see Fig. A1.16).
p		Total sample estimate of the lot percent defective $p = p_U + p_L$.
M		Maximum allowable percent defective for sample estimates given in Tables C-3 and C-4 (see Figs. A1.14 and A1.15).
M_U	$M_{\text{sub } U}$	Maximum allowable percent defective above U given in Tables C-3 and C-4 (see Figs. A1.14 and A1.15). (For use when different AQL values for U and L are specified.)
M_L	$M_{\text{sub } L}$	Maximum allowable percent defective below L given in Tables C-3 and C-4 (see Figs. A1.14 and A1.15). (For use when different AQL values for U and L are specified.)
\bar{p}	p_{bar}	Sample estimate of the process percent defective, that is, the estimated process average.
\bar{p}_U	$p_{\text{bar sub } U}$	The estimated process average for an upper specification limit.
\bar{p}_L	$p_{\text{bar sub } L}$	The estimated process average for a lower specification limit.
T		The maximum number of estimated process averages which may exceed the AQL given in Table C-6 (see Fig. A1.17). (For use in determining application of tightened inspection.)
f		A factor used in determining the Maximum Average Range (MAR). The F values are given in Table C-8 (see Fig. A1.19).
>	Greater than	Greater than
<	Less than	Less than
Σ	Sum of	Sum of

^a This original table contains the wording “acceptable” instead of the now recognized term “acceptance” for the AQL value.

Section 9 Definitions

Symbol	Read	Definition
n		Sample size for a single lot.
\bar{X}	X bar	Sample mean. Arithmetic mean of sample measurements from a single lot.
σ	Sigma	Known variability. The predetermined variability of the quality characteristic which will be used with the variability known acceptability plans.
U		Upper specification limit.
L		Lower specification limit.
k		The acceptability constant given in Tables D-1 and D-2 (see Figs. A1.20 and A1.21). ^a
v		A factor used in determining the quality indices when using the known variability acceptability plan. The v values are given in Tables D-3 and D-4 (see Figs. A1.22 and A1.23).
Q_U	$Q_{\text{sub } U}$	Quality index for use with Table D-5 (see Fig. A1.24).
Q_L	$Q_{\text{sub } L}$	Quality index for use with Table D-5 (see Fig. A1.24).
p_U	$p_{\text{sub } U}$	Sample estimate of the lot percent defective above U from Table D-5 (see Fig. A1.24).
p_L	$p_{\text{sub } L}$	Sample estimate of the lot percent defective below L from Table D-5 (see Fig. A1.24).
p		Total sample estimate of the lot percent defective $p = p_U + p_L$.
M		Maximum allowable percent defective for sample estimates given in Tables D-3 and D-4 (see Figs. A1.22 and A1.23).
M_U	$M_{\text{sub } U}$	Maximum allowable percent defective above U given in Tables D-3 and D-4 (see Figs. A1.22 and A1.23). (For use when different AQL values for U and L are specified.)
M_L	$M_{\text{sub } L}$	Maximum allowable percent defective below L given in Tables D-3 and D-4 (see Figs. A1.22 and A1.23). (For use when different AQL values for U and L are specified.)
\bar{p}	p_{bar}	Sample estimate of the process percent defective, that is, the estimated process average.

\bar{p}_U	p bar sub U	The estimated process average for an upper specification limit.
\bar{p}_L	p bar sub L	The estimated process average for a lower specification limit.
T		The maximum number of estimated process averages which may exceed the AQL given in Table D-6 (see Fig. A1.25). (For use in determining application of tightened inspection.)
>	Greater than	Greater than
<	Less than	Less than
Σ	Sum of	Sum of

^a This original table contains the wording "acceptable" instead of the now recognized term "acceptance" for the AQL value.

TABLE A-1
AQL Conversion Table

For specified AQL values falling within these ranges	Use this AQL value
— to 0.049	0.04
0.050 to 0.069	0.065
0.070 to 0.109	0.10
0.110 to 0.164	0.15
0.165 to 0.279	0.25
0.280 to 0.439	0.40
0.440 to 0.699	0.65
0.700 to 1.09	1.0
1.10 to 1.64	1.5
1.65 to 2.79	2.5
2.80 to 4.39	4.0
4.40 to 6.99	6.5
7.00 to 10.9	10.0
11.00 to 16.4	15.0

FIG. A1.1 Table A-1 AQL Conversion Table

TABLE A-2
Sample Size Code Letters¹

Lot Size		Inspection Levels				
		I	II	III	IV	V
3 to	8	B	B	B	B	C
9 to	15	B	B	B	B	D
16 to	25	B	B	B	C	E
26 to	40	B	B	B	D	F
41 to	65	B	B	C	E	G
66 to	110	B	B	D	F	H
111 to	180	B	C	E	G	I
181 to	300	B	D	F	H	J
301 to	500	C	E	G	I	K
501 to	800	D	F	H	J	L
801 to	1,300	E	G	I	K	L
1,301 to	3,200	F	H	J	L	M
3,201 to	8,000	G	I	L	M	N
8,001 to	22,000	H	J	M	N	O
22,001 to 110,000		I	K	N	O	P
110,001 to 550,000		I	K	O	P	Q
550,001 and over		I	K	P	Q	Q

¹ Sample size code letters given in body of table are applicable when the indicated inspection levels are to be used.

FIG. A1.2 Table A-2 Sample Size Code Letters



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
B

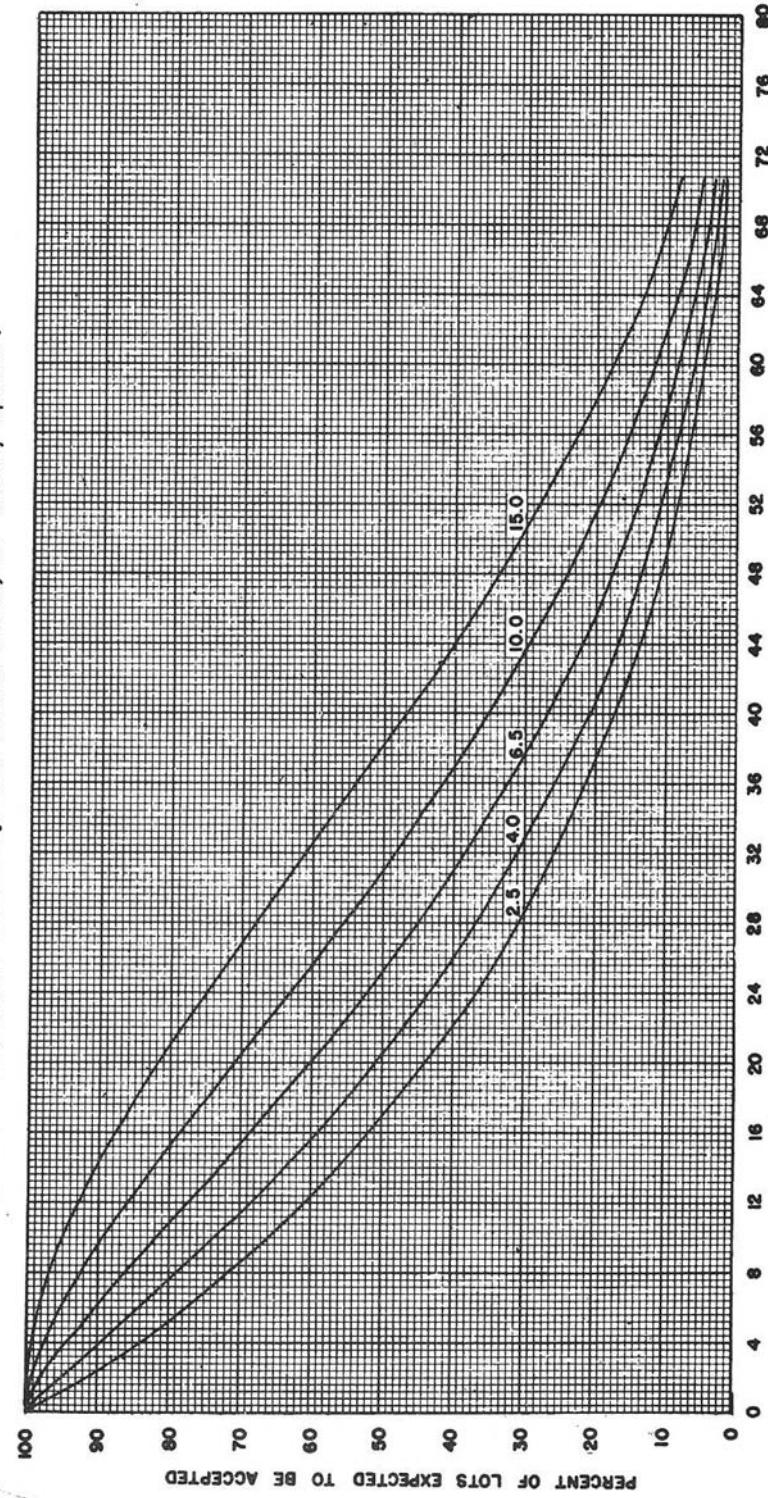
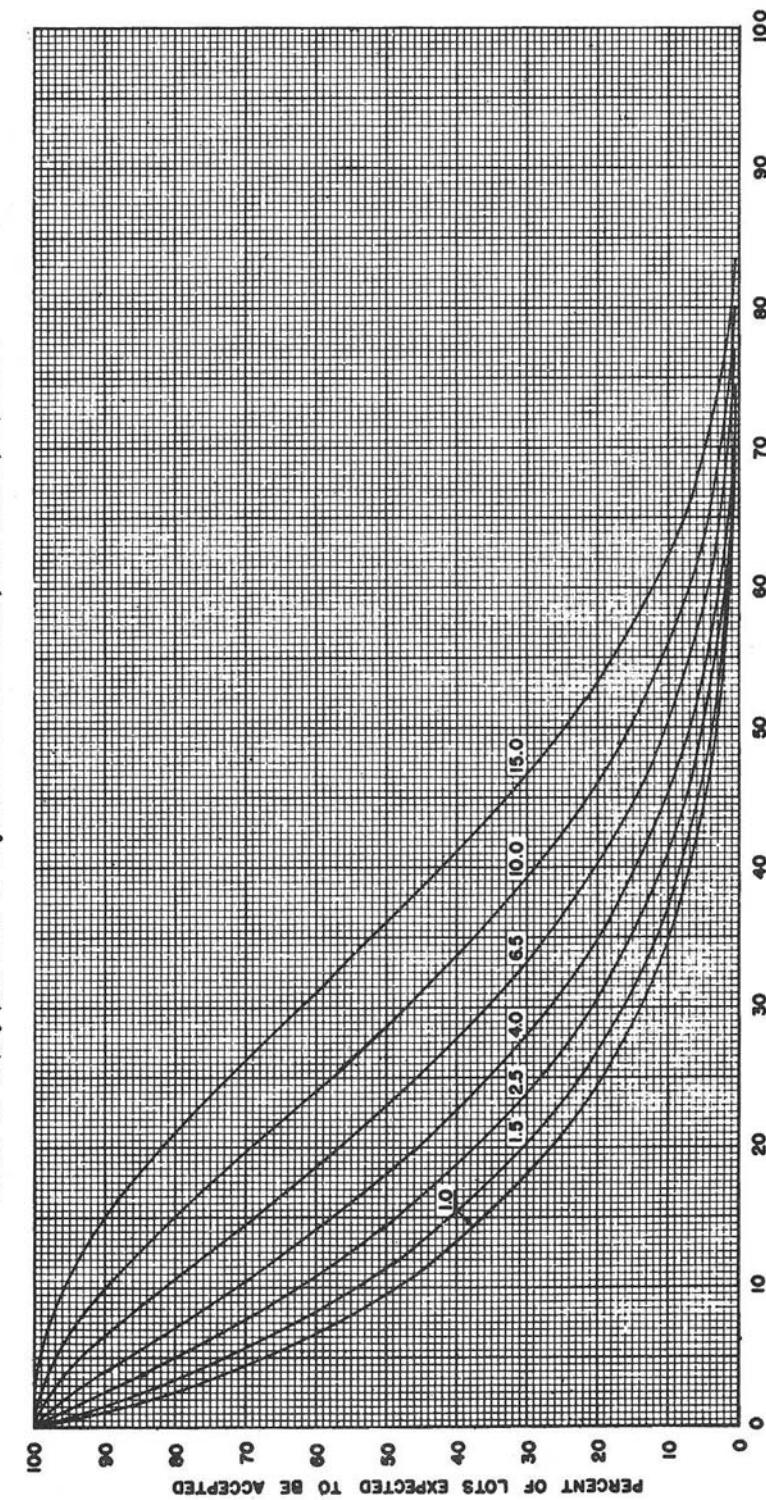


FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
C



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

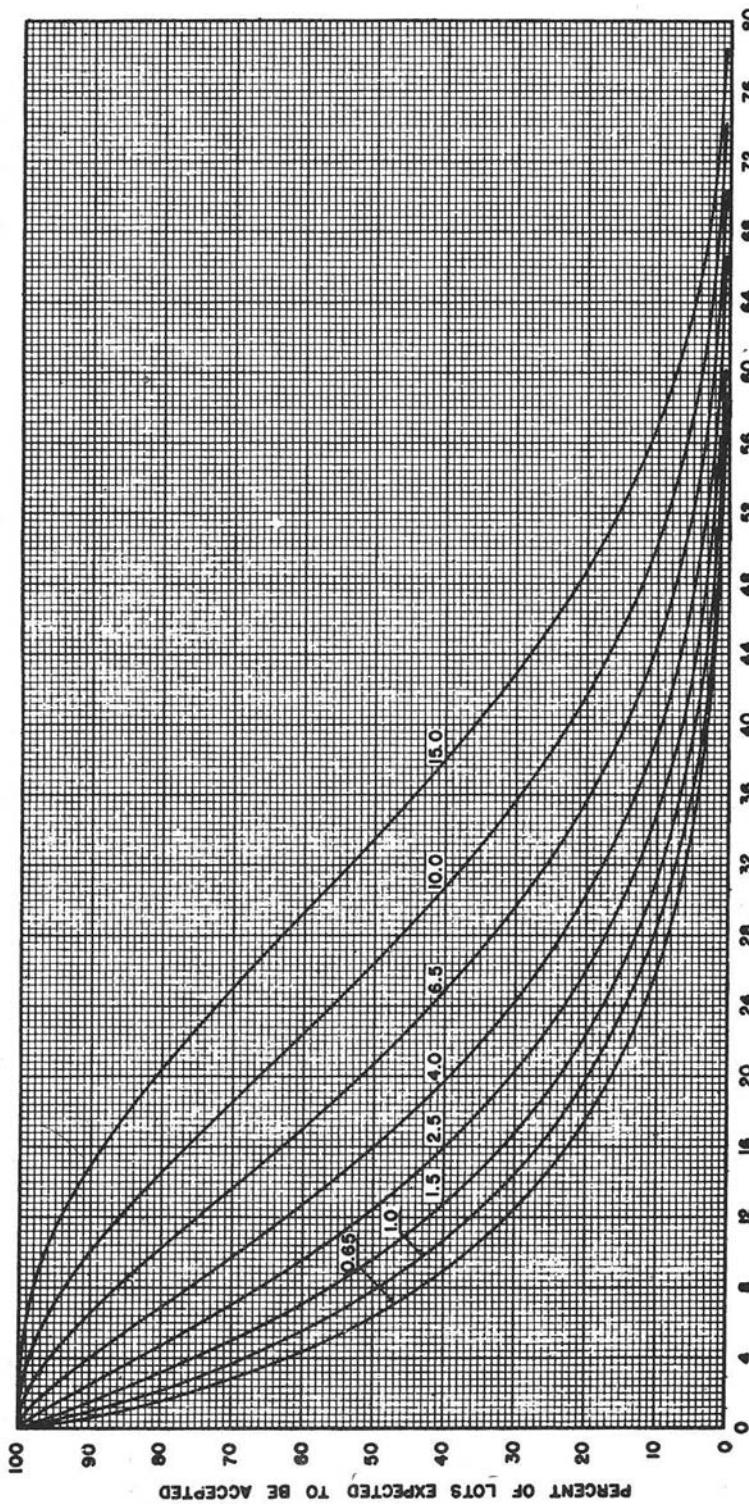
QUALITY OF SUBMITTED LOTS (in percent defective)
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD

SAMPLE SIZE CODE LETTER
D

{ Curves for sampling plans based on range method and known variability are essentially equivalent }



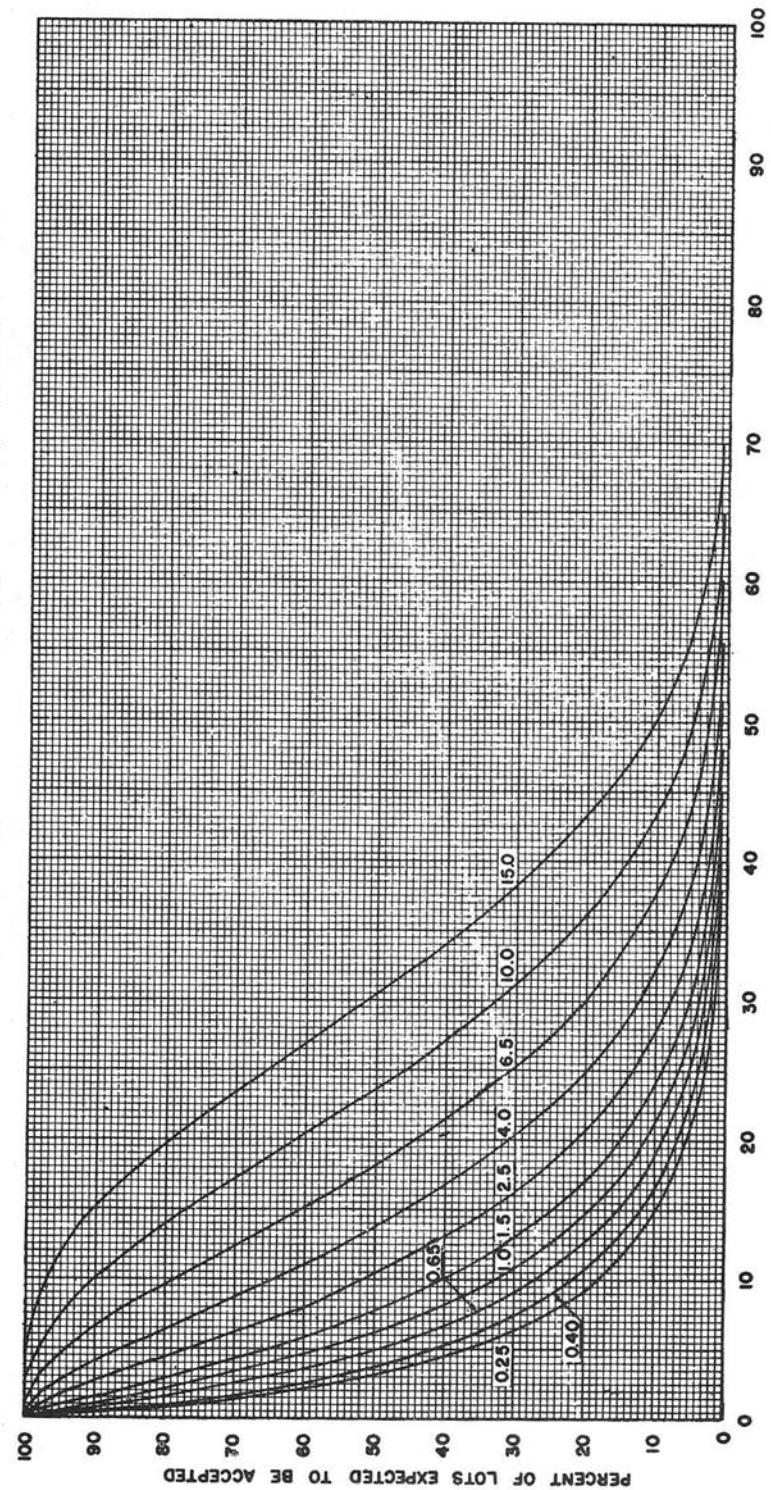
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.
FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
E



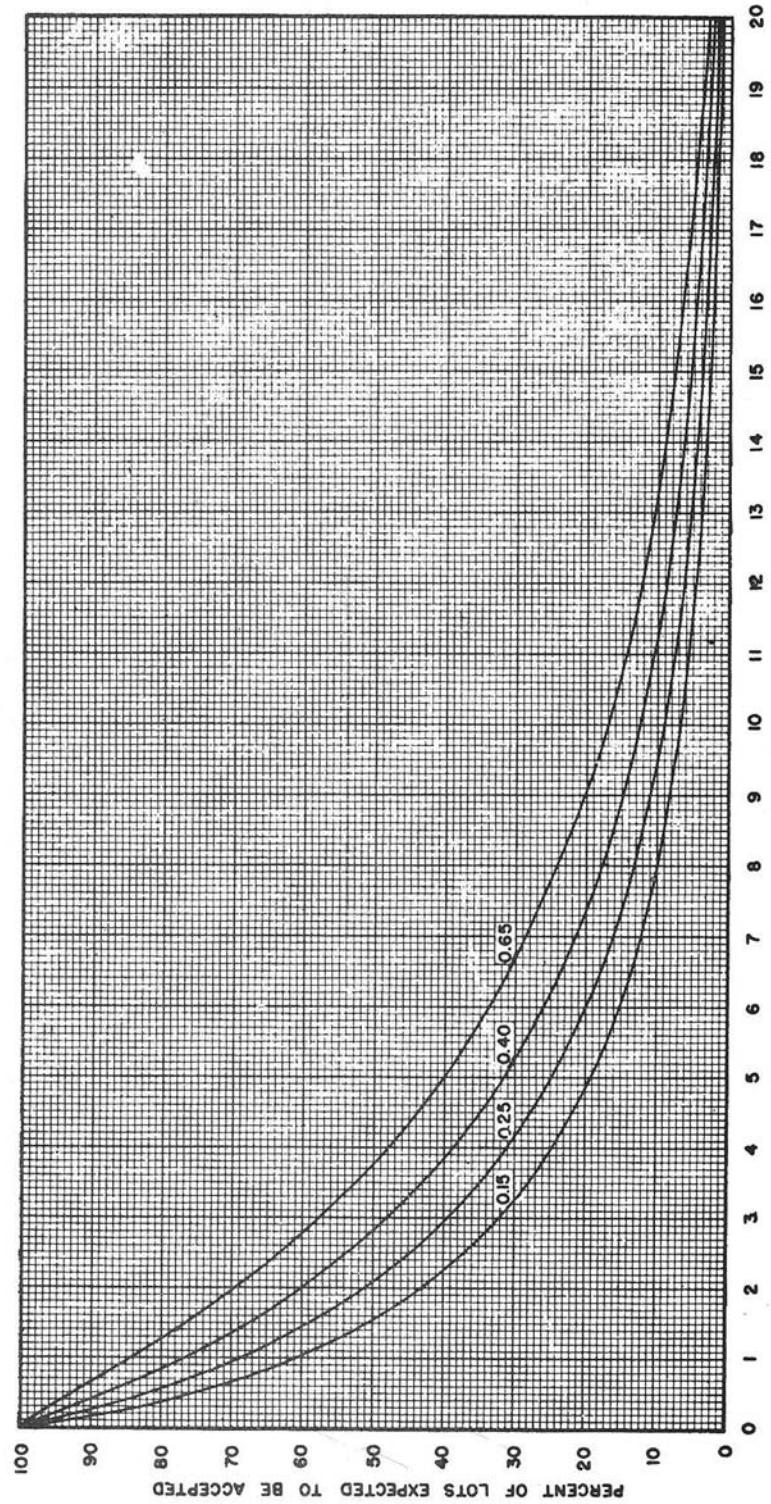
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
F



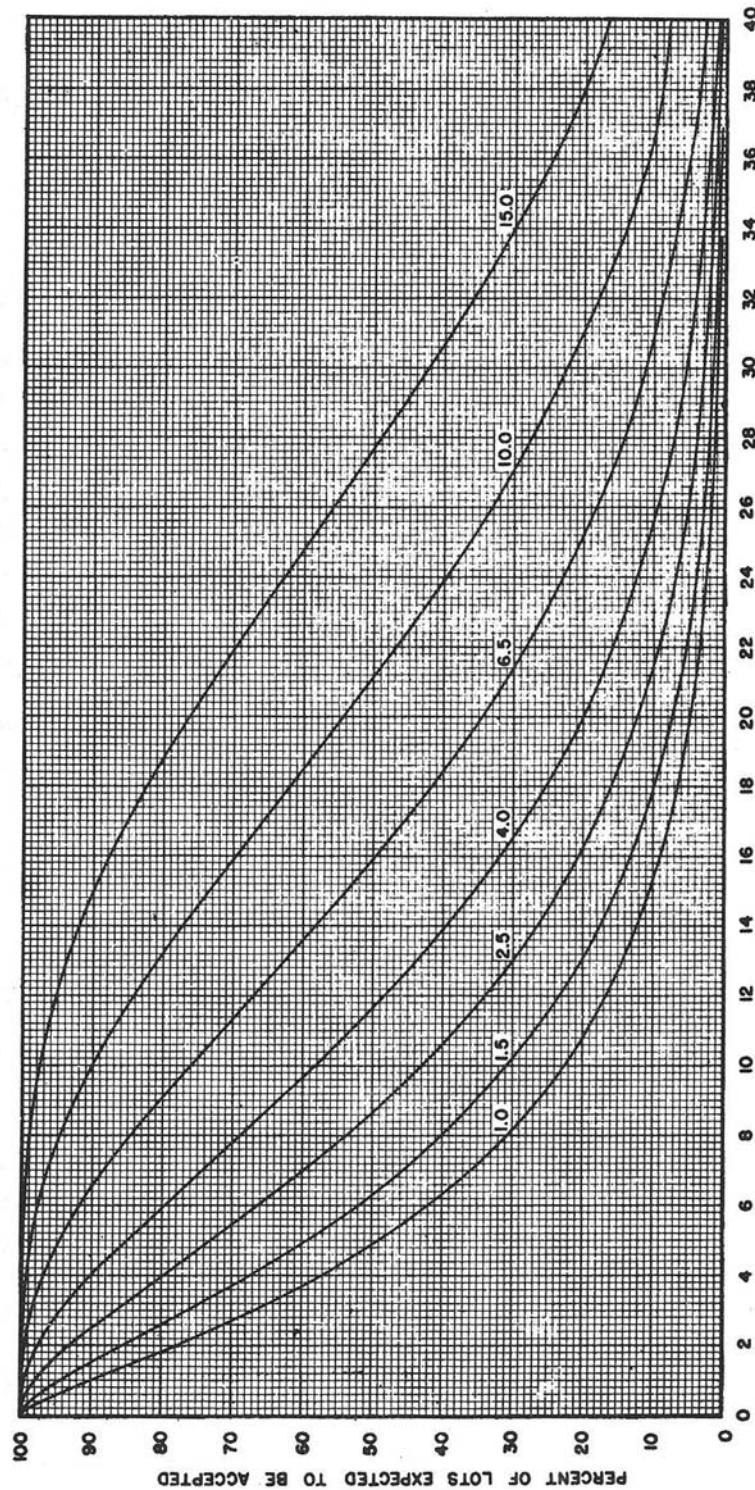
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
F (Continued)



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

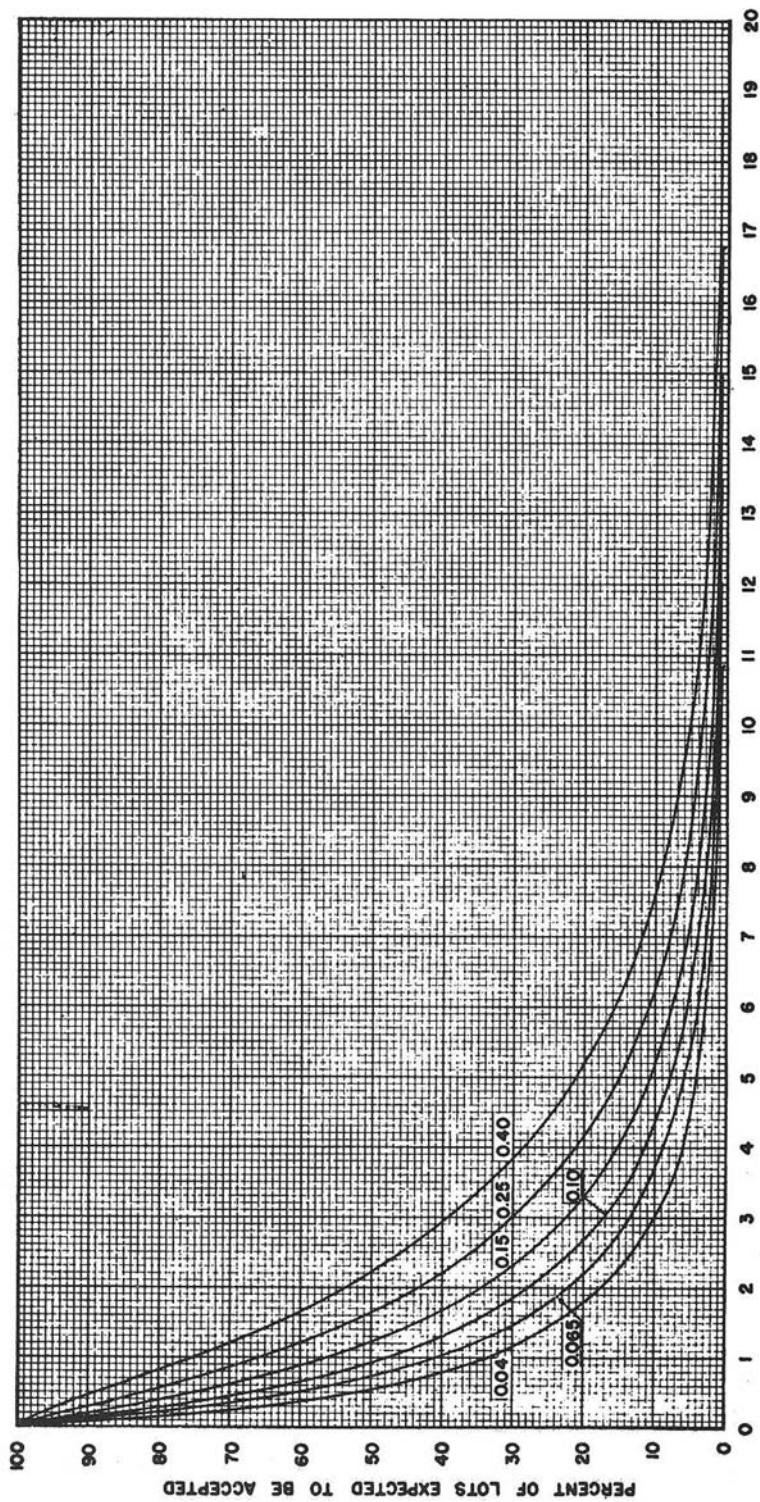
QUALITY OF SUBMITTED LOTS (in percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
G
(Curves for sampling plans based on range method and known variability are essentially equivalent)



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

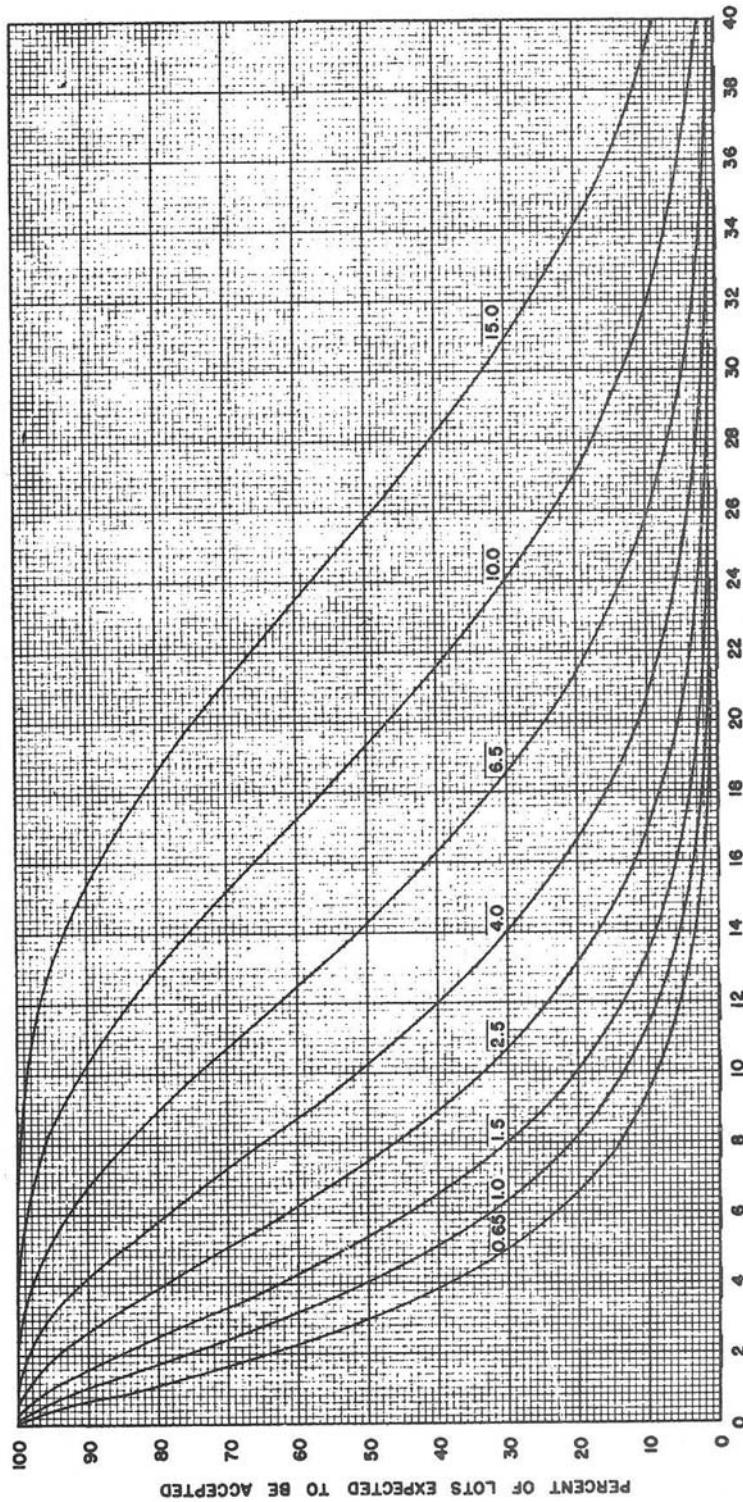
QUALITY OF SUBMITTED LOTS (In percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
G (Continued)



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

NOTE: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

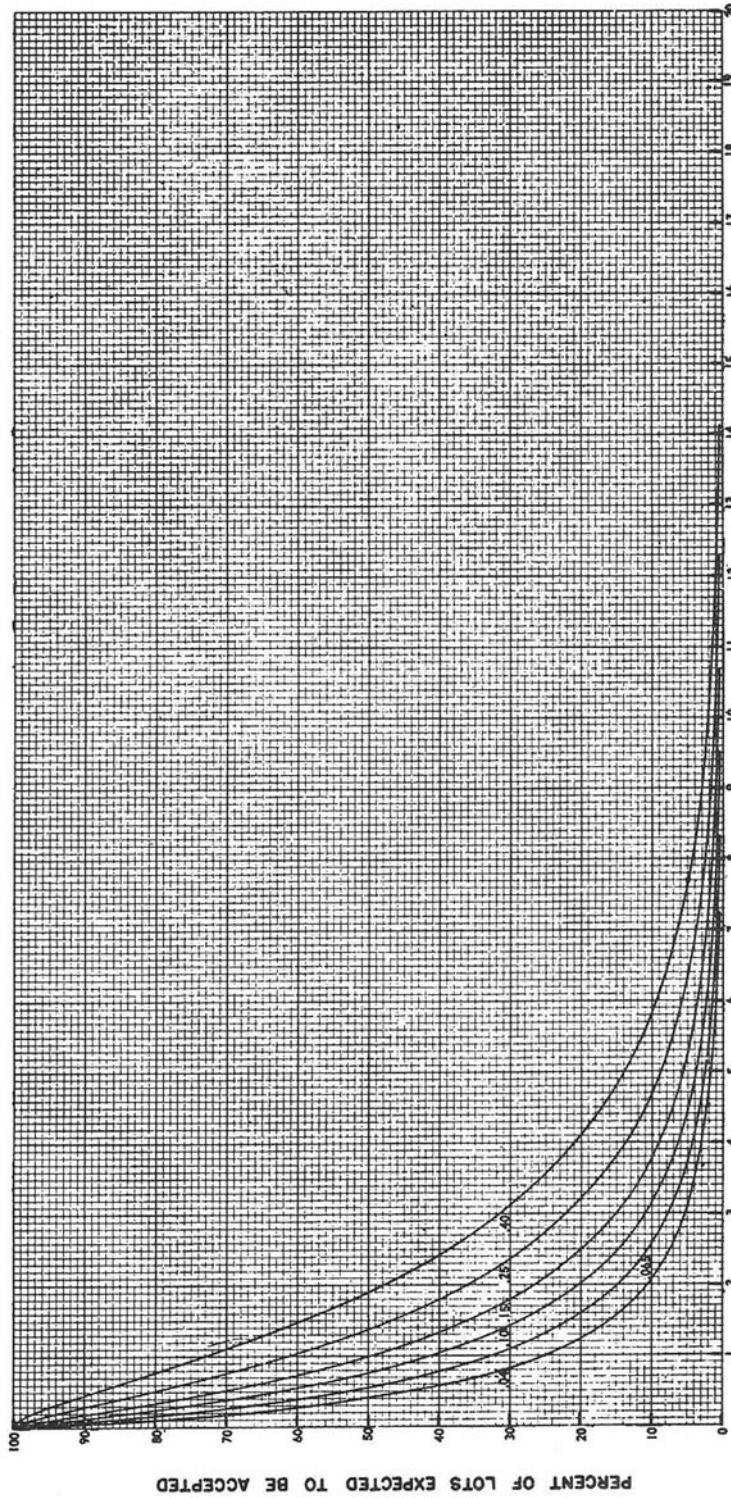


TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD

SAMPLE SIZE CODE LETTER

H

{ Curves for sampling plans based on range method and known variability are essentially equivalent }

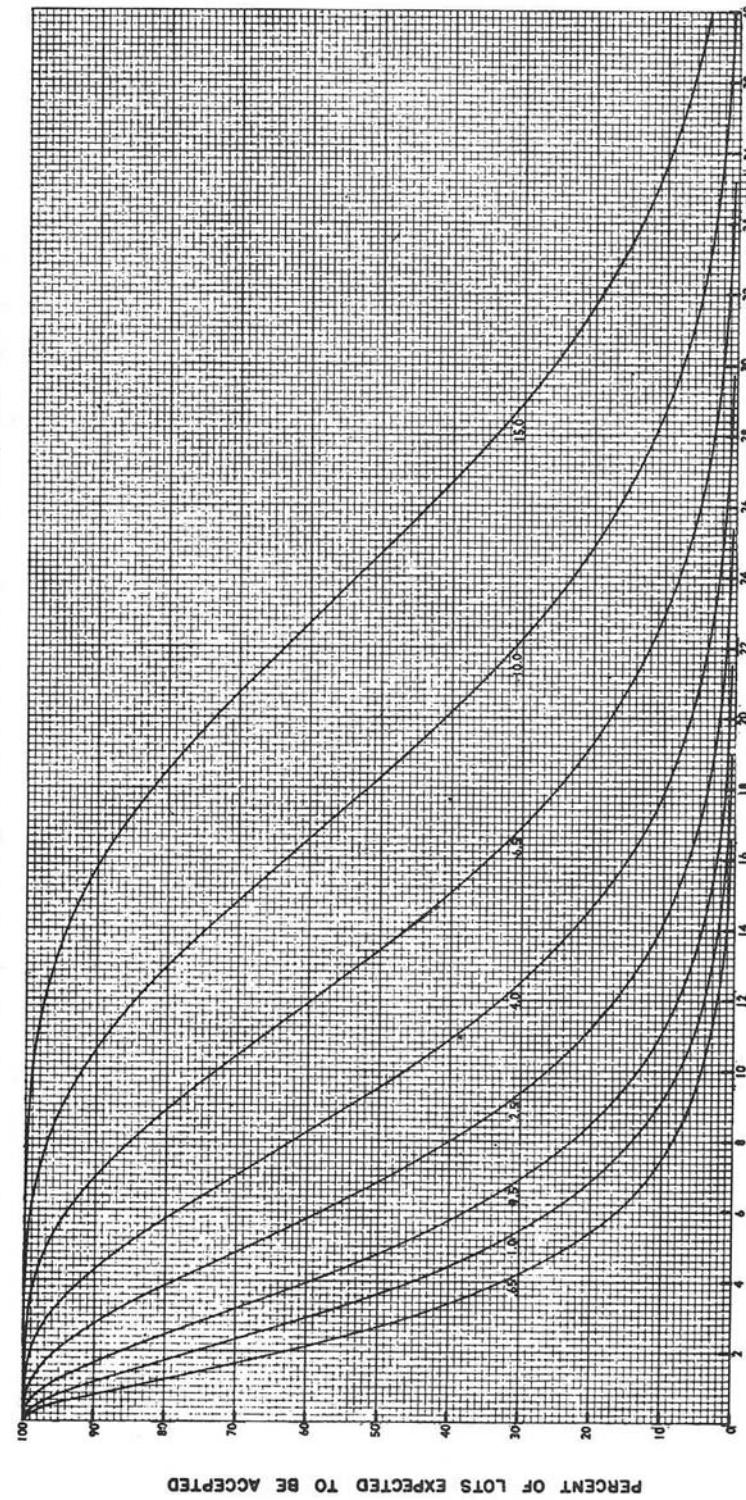


The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
H (Continued)



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)

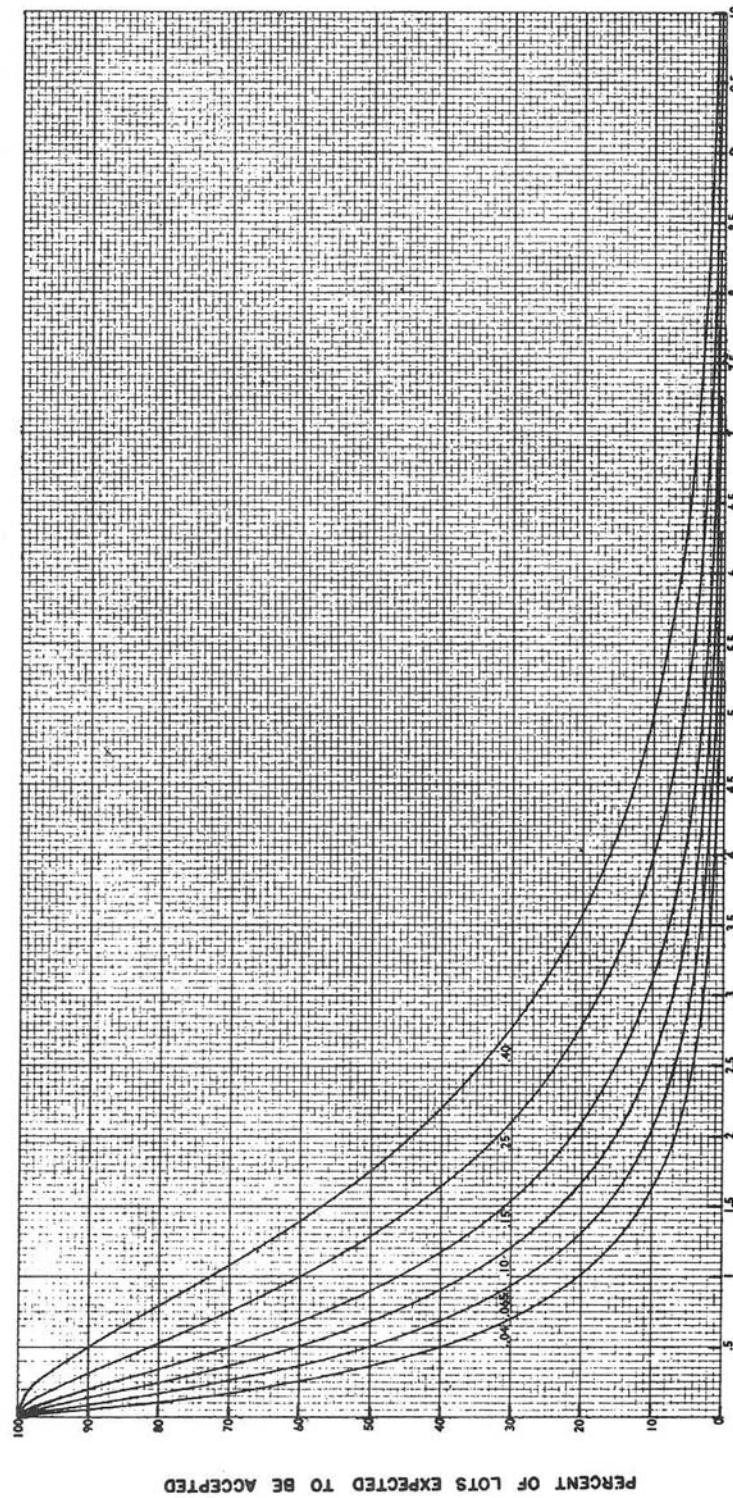
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD

SAMPLE SIZE CODE LETTER



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)

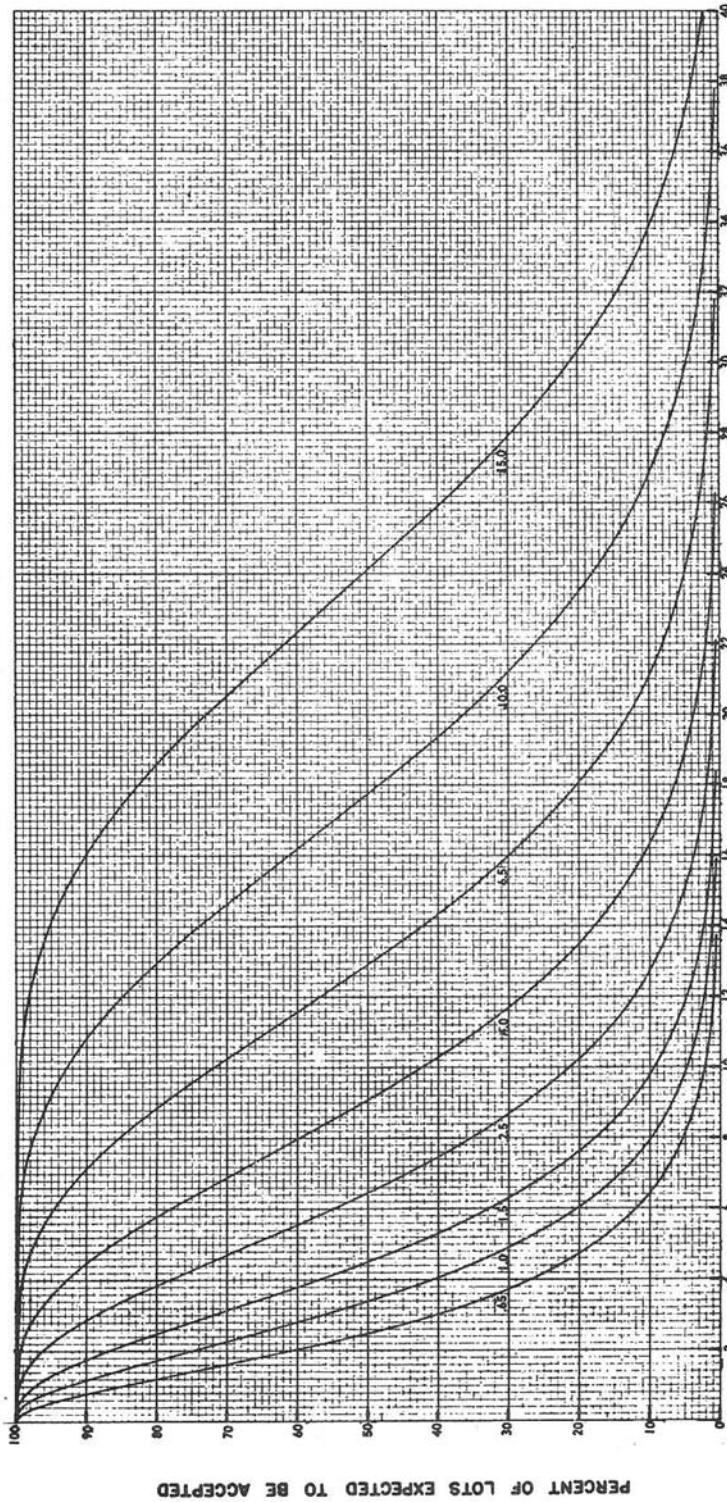
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER

| (Continued)
(Curves for sampling plans based on range method and known variability are essentially equivalent)



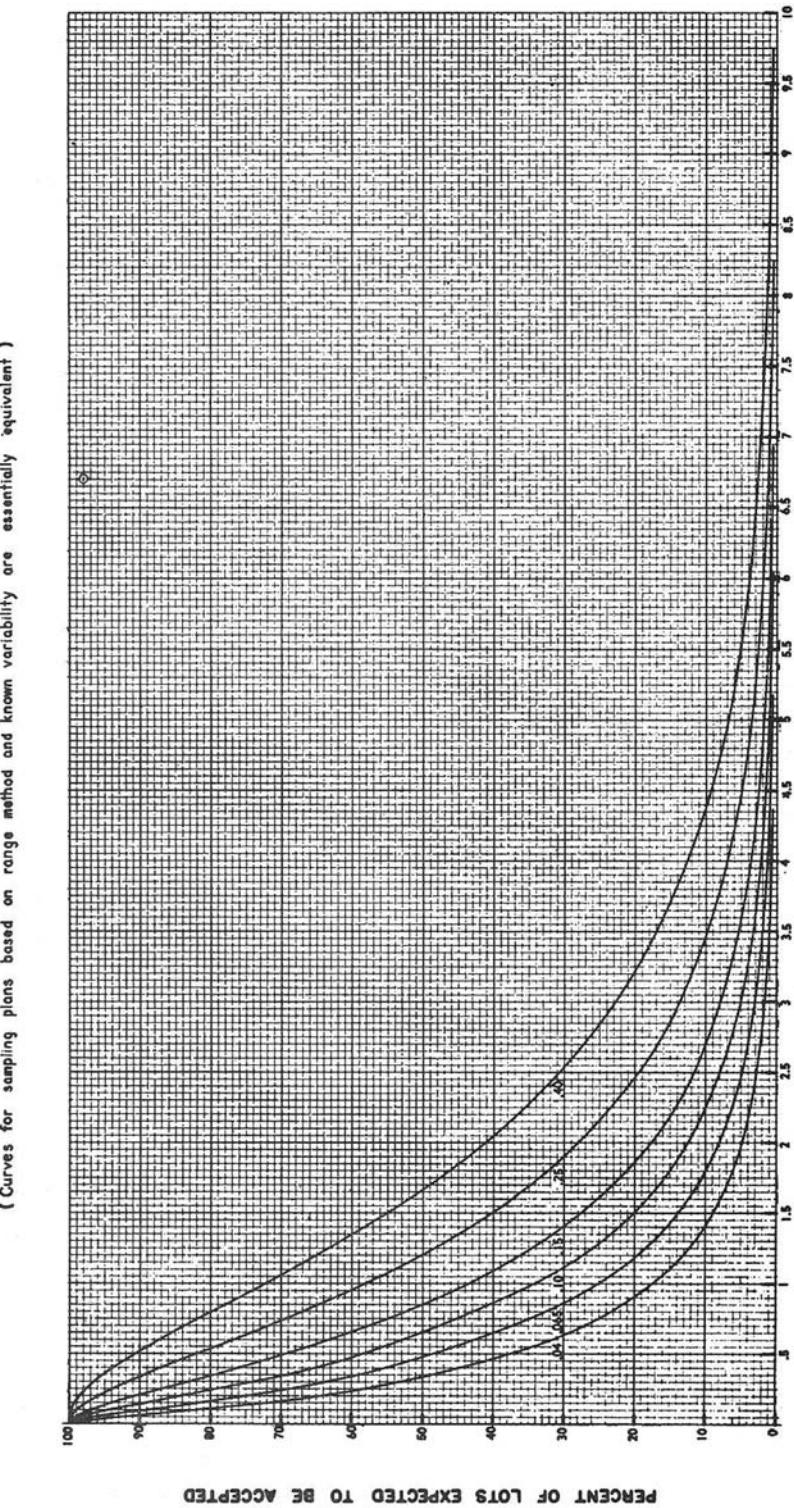
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
J



PERCENT OF LOTS EXPECTED TO BE ACCEPTED

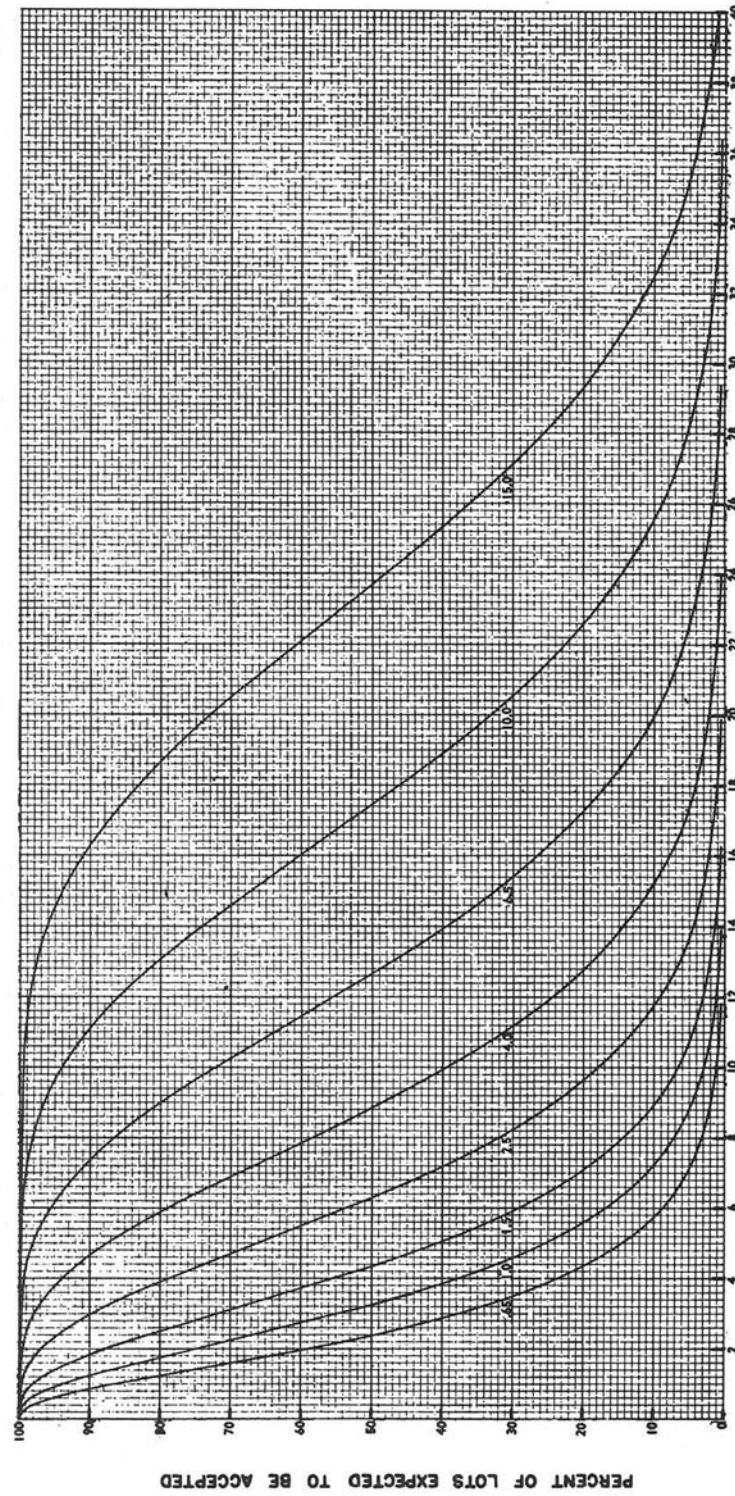
QUALITY OF SUBMITTED LOTS (in percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
J (Continued)



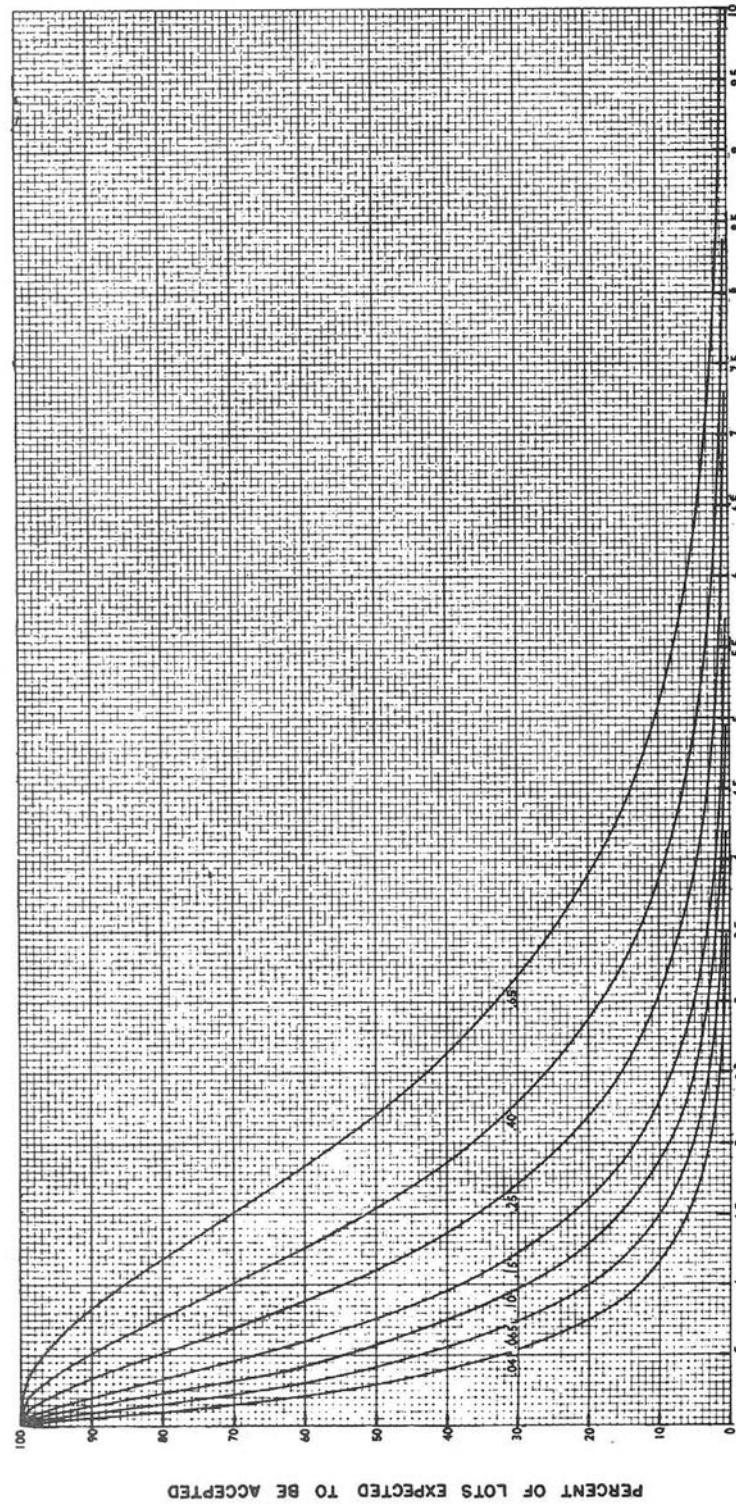
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)
Note: Figures on curves are Acceptable Quality Levels for normal Inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
K



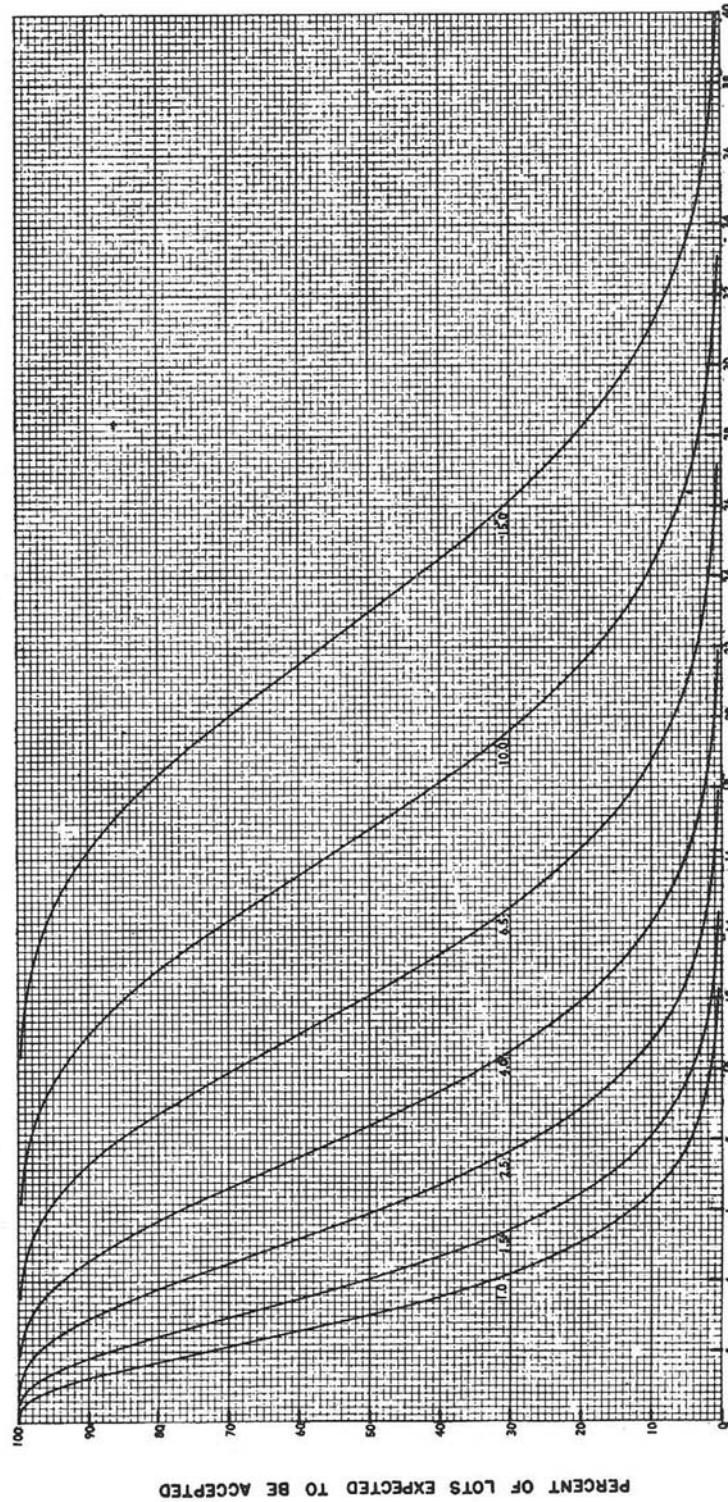
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
K (Continued)



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

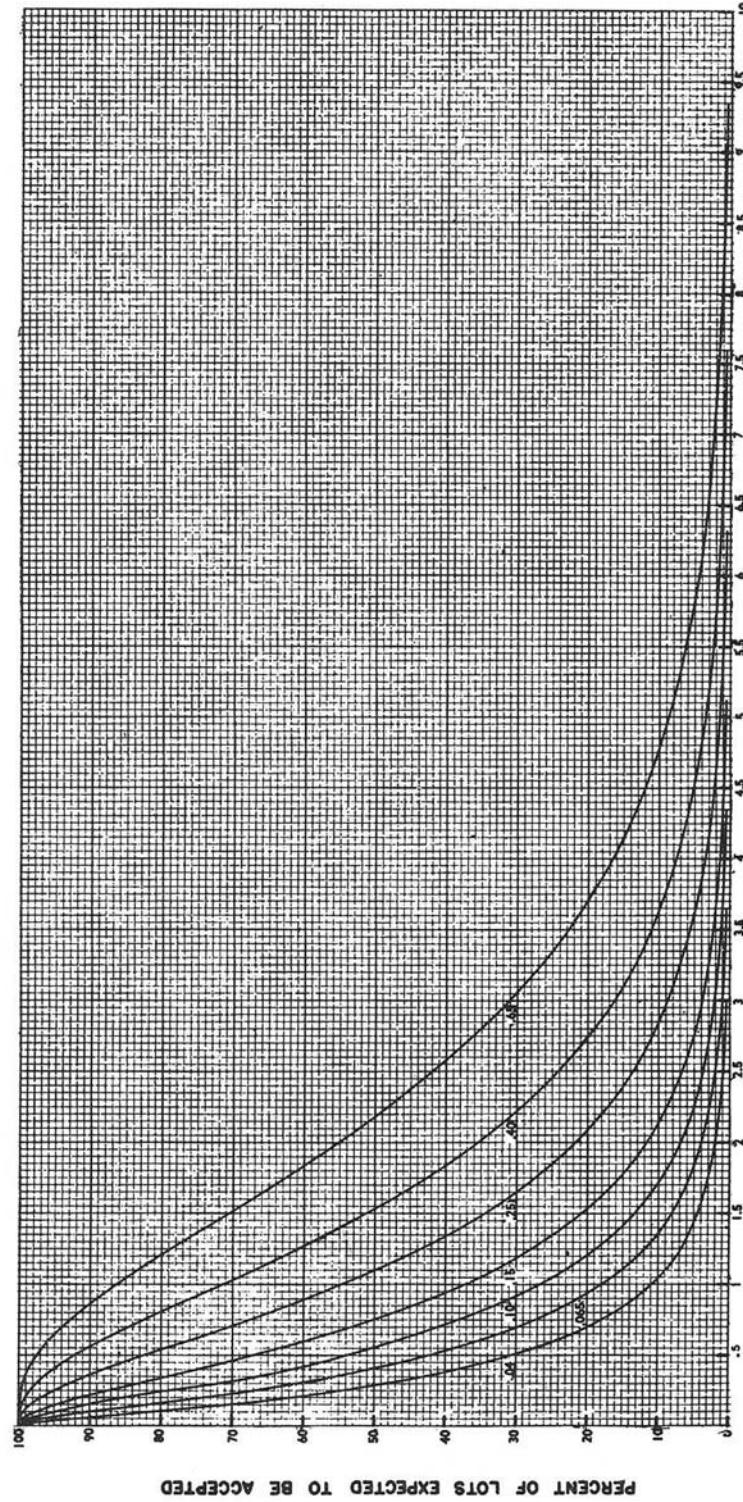
QUALITY OF SUBMITTED LOTS (In percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
L



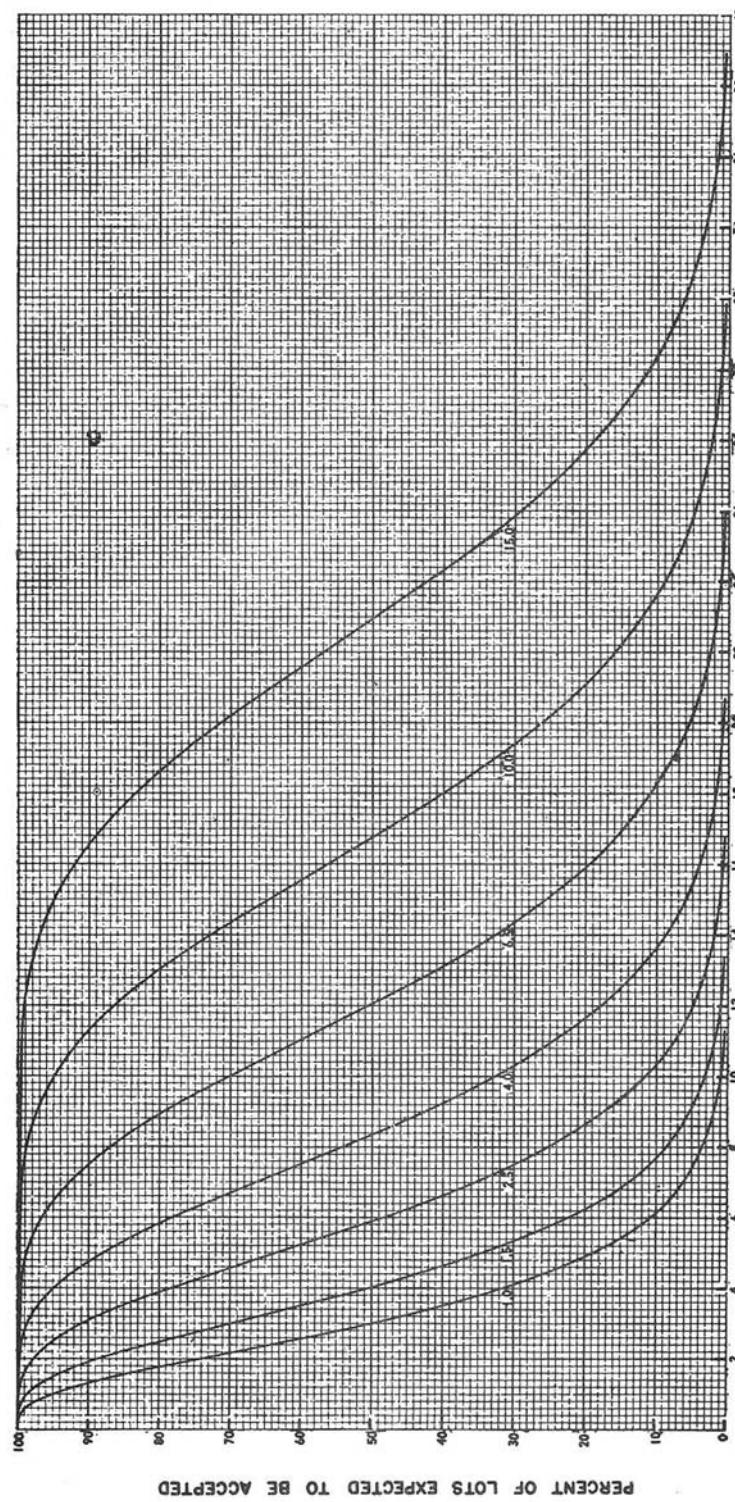
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
L (Continued)



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (in percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

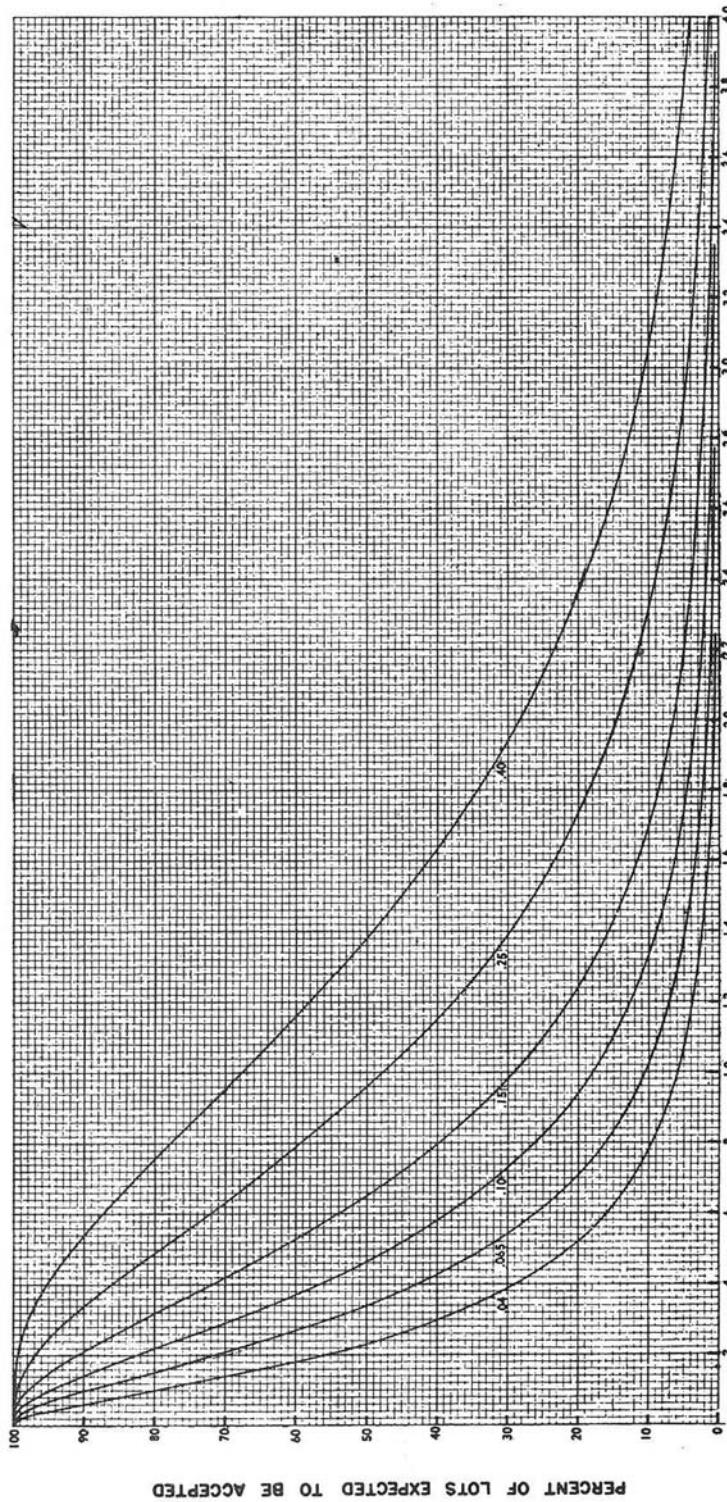


TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD

SAMPLE SIZE CODE LETTER

M

{ Curves for sampling plans based on range method and known variability are essentially equivalent }



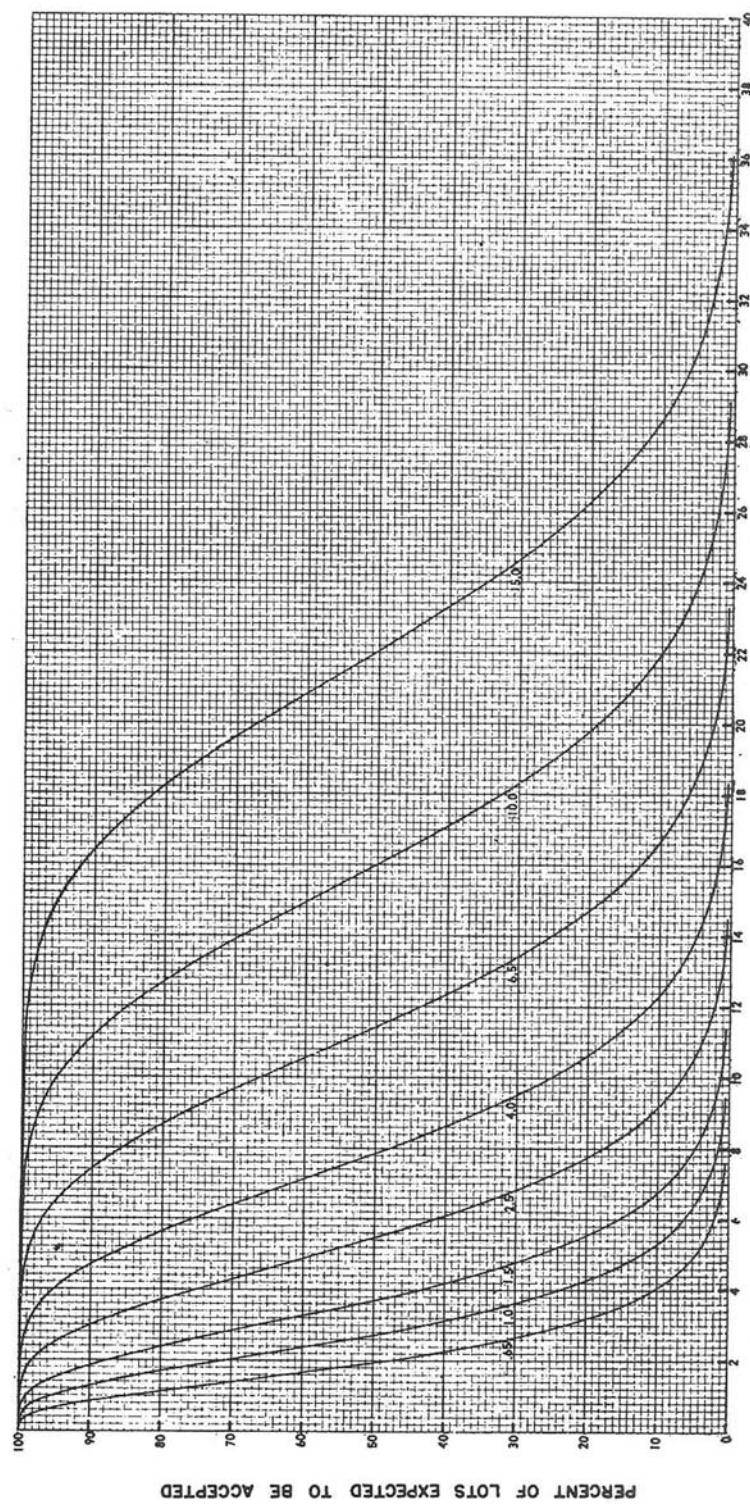
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
M (Continued)



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

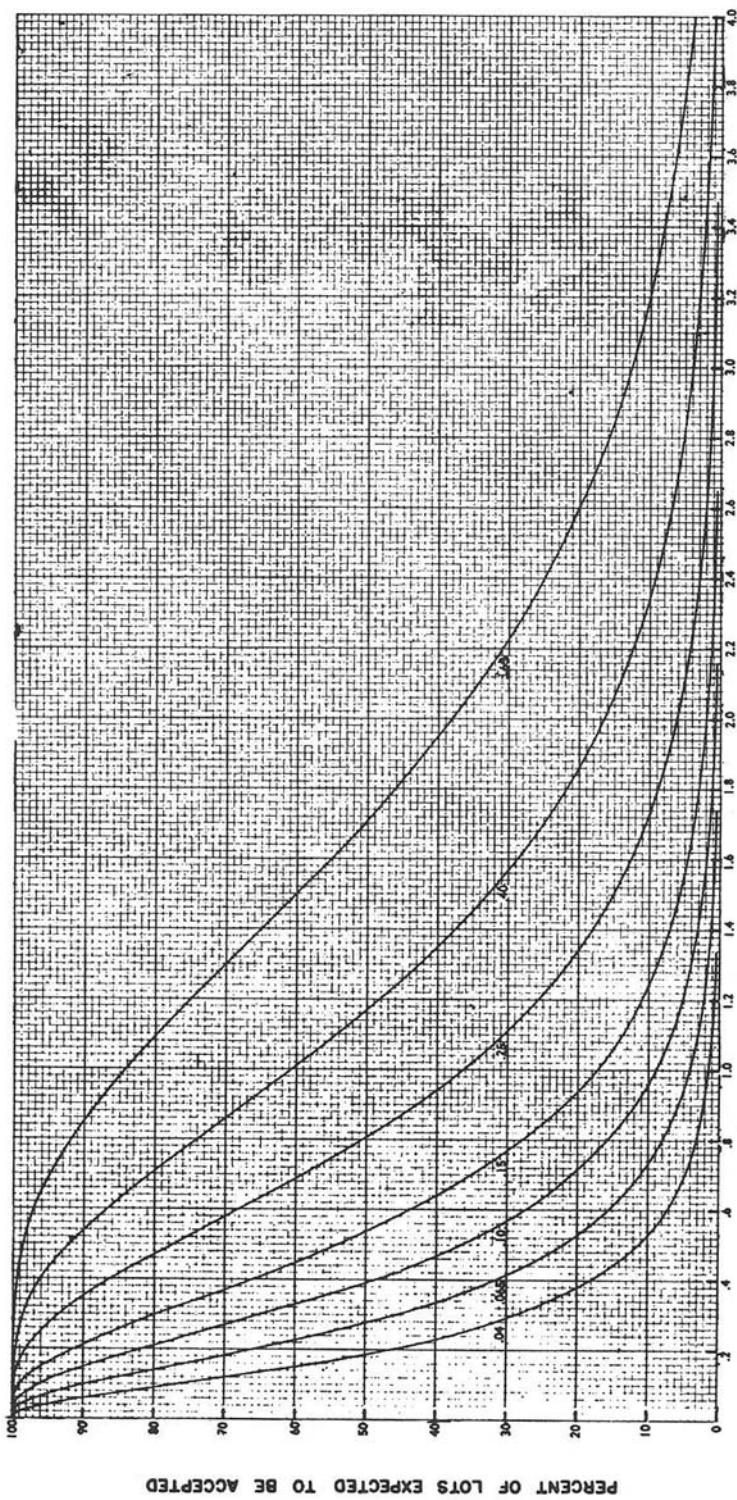
FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD

SAMPLE SIZE CODE LETTER

N

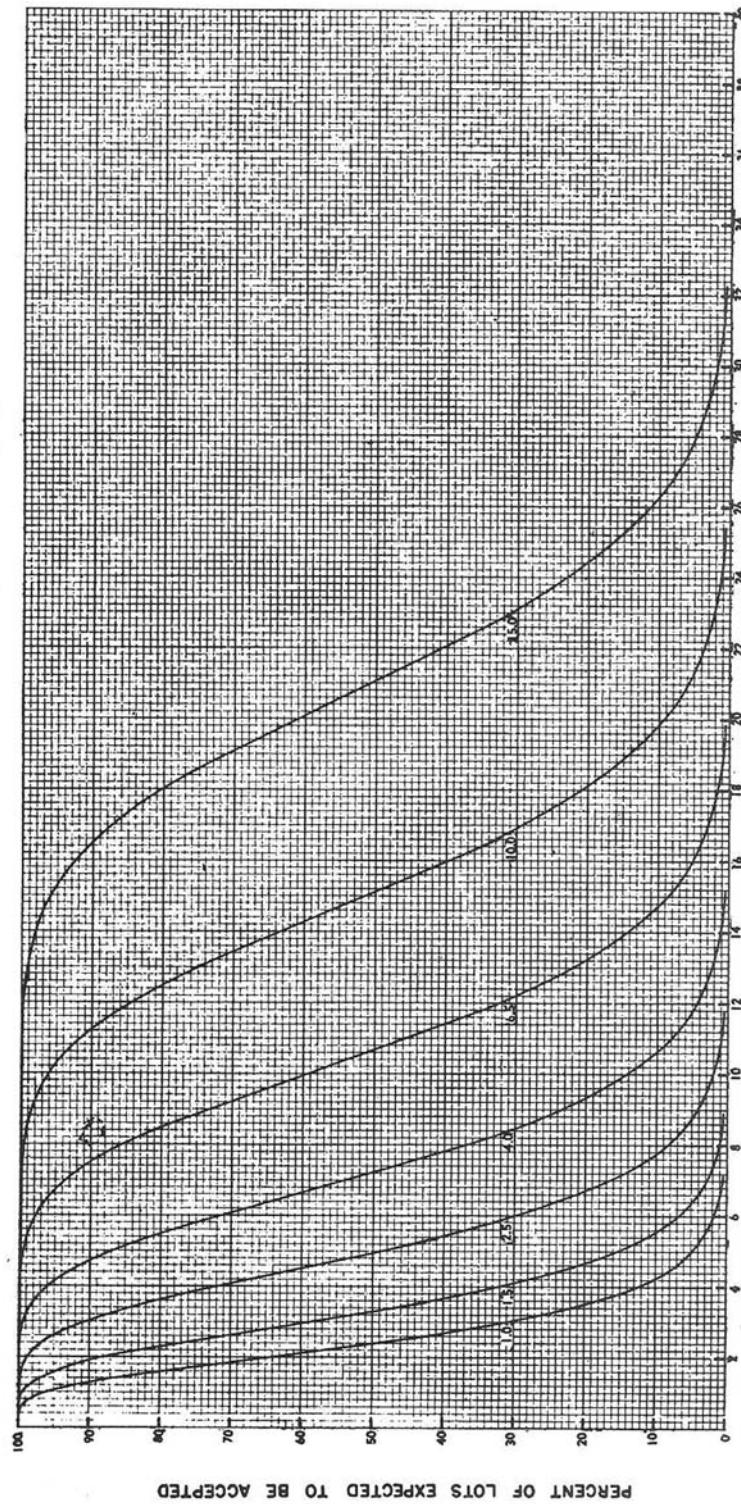


The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
N (Continued)



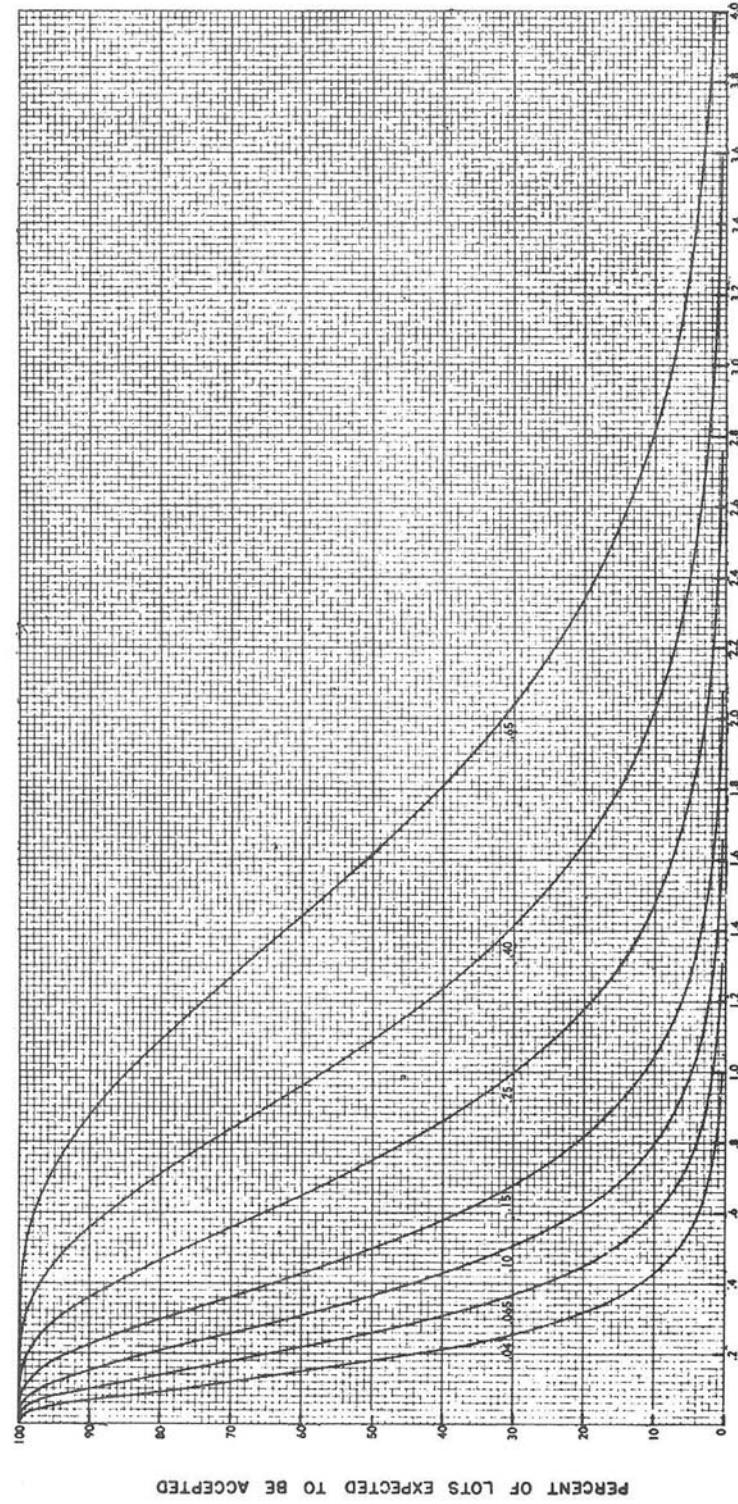
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
O



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

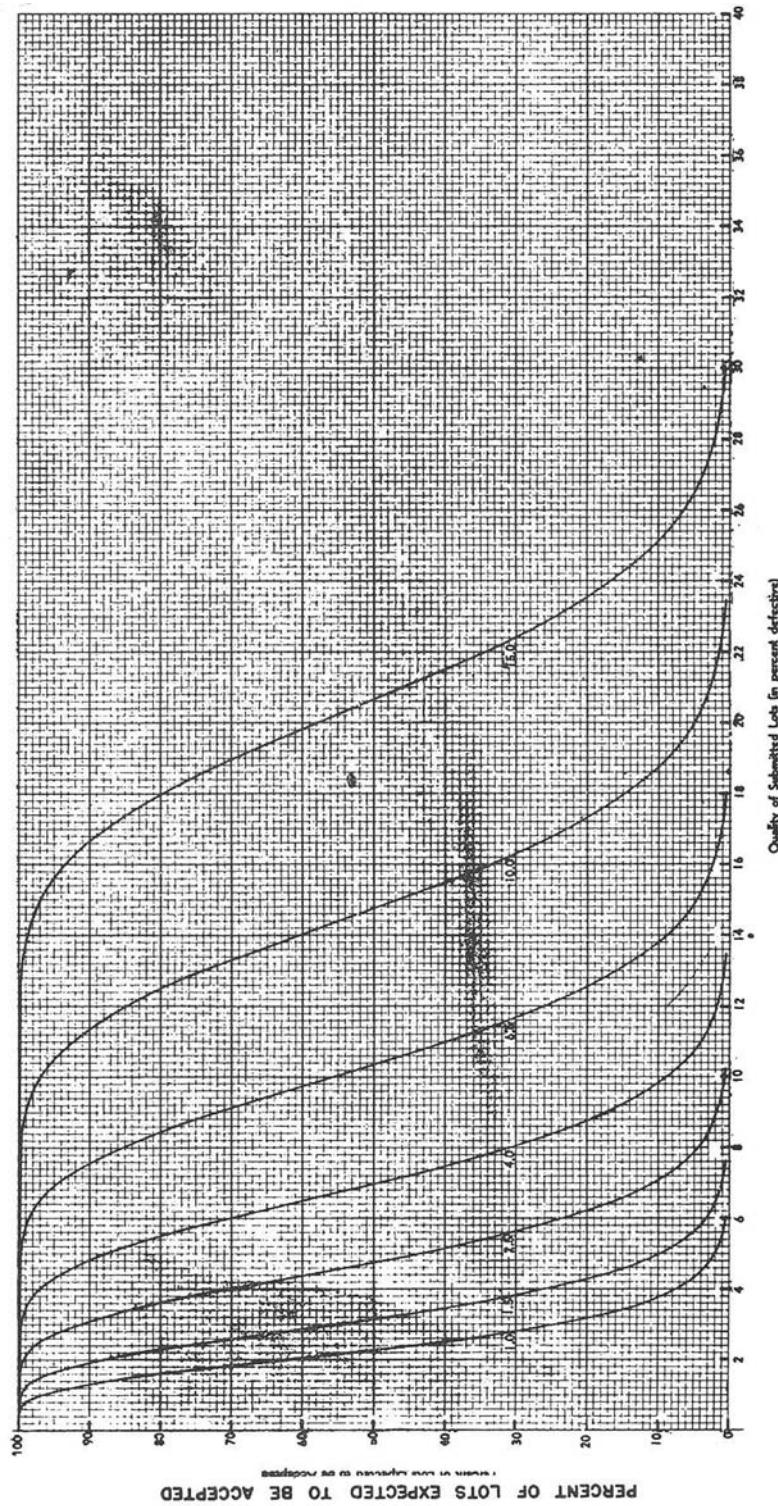
Quality of Submitted Lots (In percent defective)

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD

SAMPLE SIZE	CODE LETTER
10	A
20	B
30	C
40	D
50	E
60	F
70	G
80	H
90	I
100	J
120	K
140	L
160	M
180	N
200	O
220	P
240	Q
260	R
280	S
300	T
320	U
340	V
360	W
380	X
400	Y
420	Z



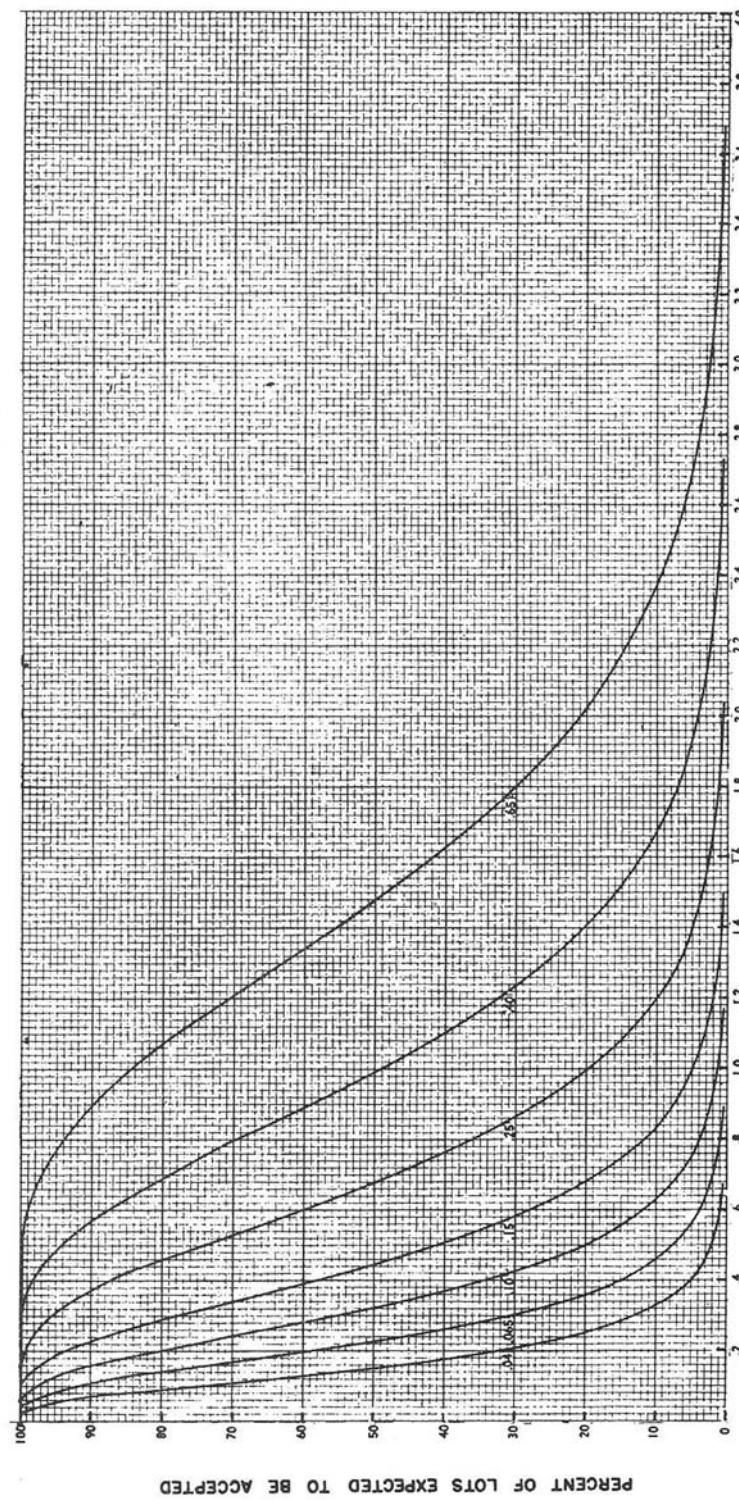
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)

FIG. A1-3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
P



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)

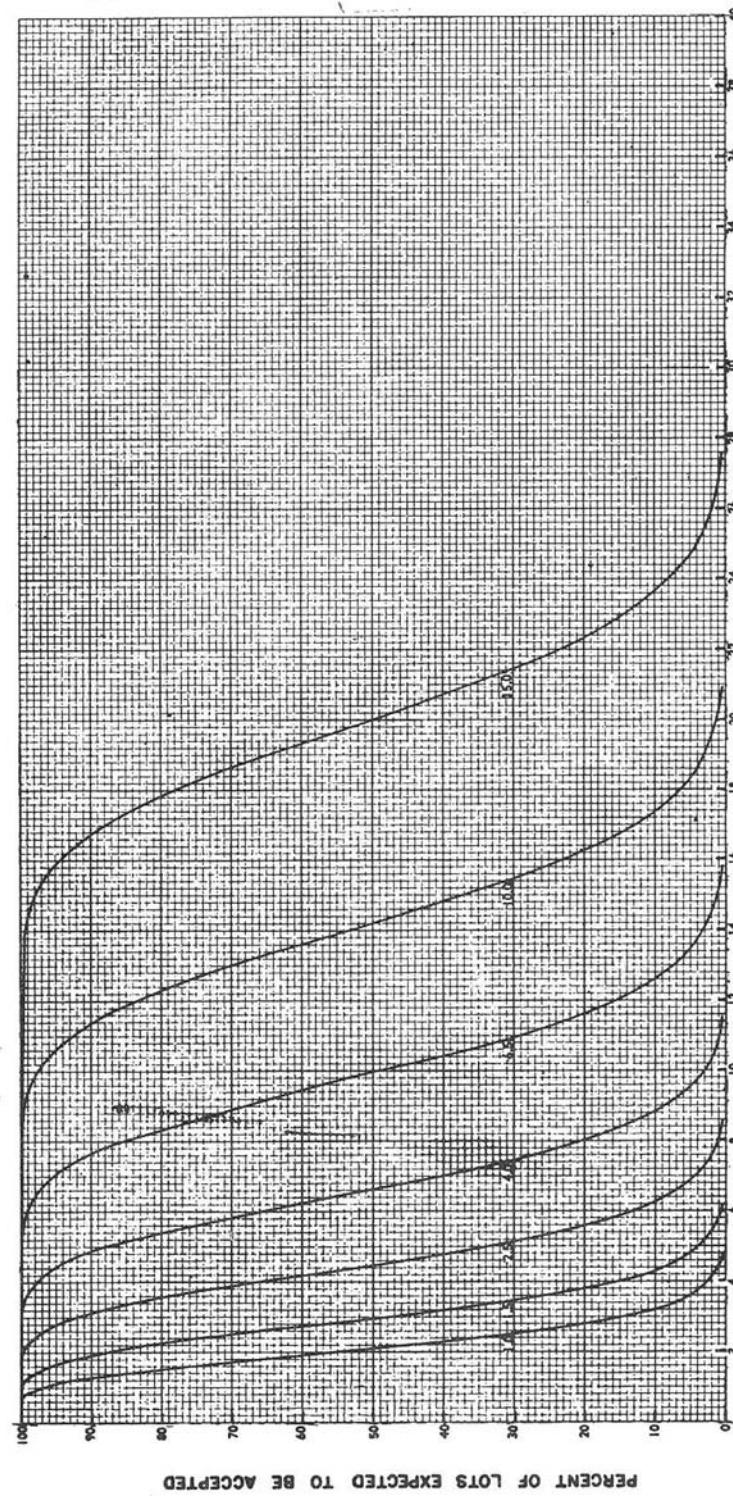
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD

SAMPLE SIZE CODE LETTER

P (Continued)



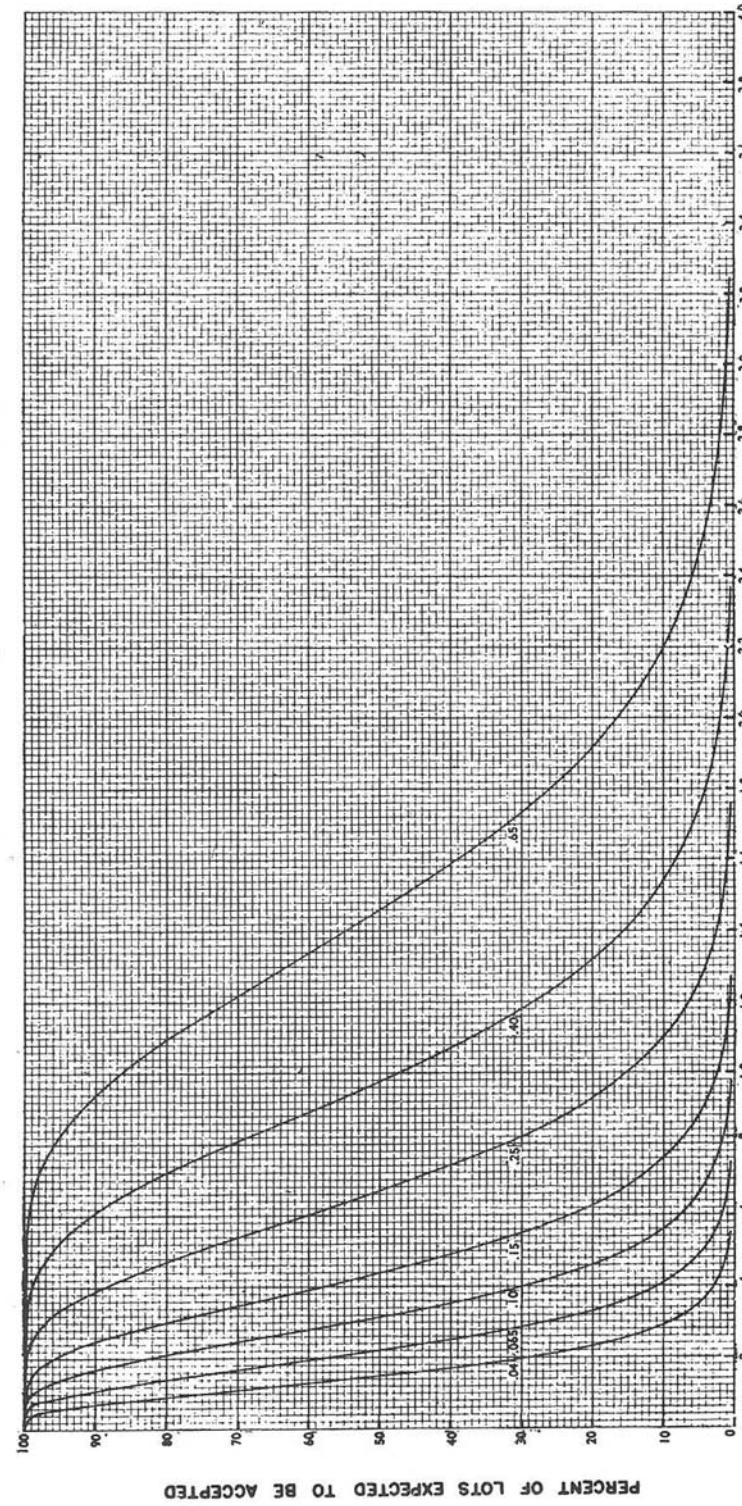
The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER

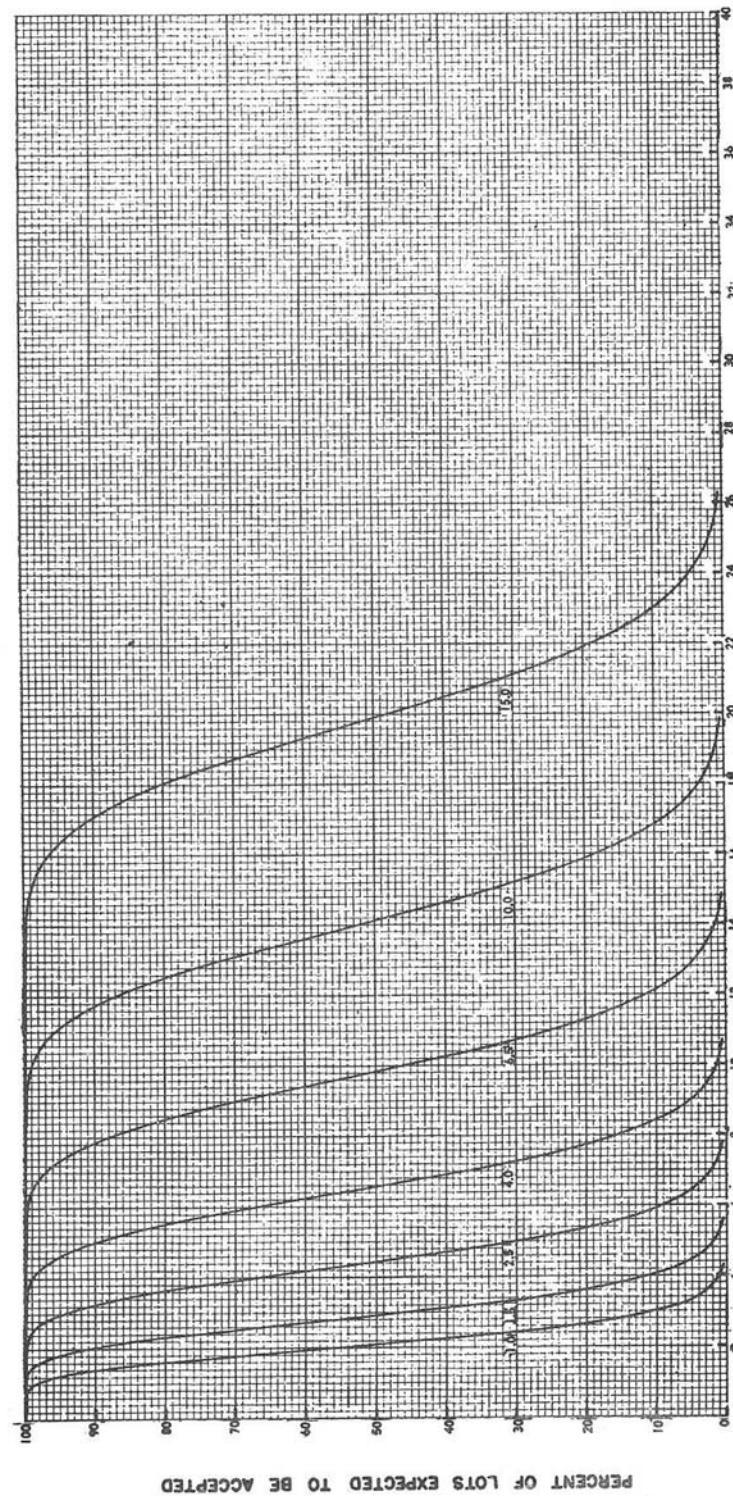


The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A1.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)

TABLE A-3
OPERATING CHARACTERISTIC CURVES FOR SAMPLING PLANS BASED ON STANDARD DEVIATION METHOD
SAMPLE SIZE CODE LETTER
Q (Continued)



The values of the percent of lots expected to be accepted are valid only when measurements are selected at random from a normal distribution.

QUALITY OF SUBMITTED LOTS (In percent defective)
Note: Figures on curves are Acceptable Quality Levels for normal inspection.

FIG. A.3 Table A-3 Operating Characteristic Curves for Sampling Plans of Sections 7, 8, and 9 (continued)



TABLE B-1
Master Table For Normal and Tightened Inspection for Plans Based on Variability Unknown
(Single Specification Limit—Form 1)

Sample size code letter	Sample size	Acceptable Quality Levels (normal inspection)													
		.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00
k	k	k	k	k	k	k	k	k	k	k	k	k	k	k	
B	3														
C	4														
D	5														
E	7														
F	10														
G	15	2.64	2.53	2.42	2.32	2.20	2.06	1.91	1.79	1.65	1.47	1.30	1.09	.886	.664
H	20	2.69	2.58	2.47	2.36	2.24	2.11	1.96	1.82	1.69	1.51	1.33	1.12	.917	.695
I	25	2.72	2.61	2.50	2.40	2.26	2.14	1.98	1.85	1.72	1.53	1.35	1.14	.936	.712
J	30	2.73	2.61	2.51	2.41	2.28	2.15	2.00	1.86	1.73	1.55	1.36	1.15	.946	.723
K	35	2.77	2.65	2.54	2.45	2.31	2.18	2.03	1.89	1.76	1.57	1.39	1.18	.969	.745
L	40	2.77	2.66	2.55	2.44	2.31	2.18	2.03	1.89	1.76	1.58	1.39	1.18	.971	.746
M	50	2.83	2.71	2.60	2.50	2.35	2.22	2.08	1.93	1.80	1.61	1.42	1.21	1.00	.774
N	75	2.90	2.77	2.66	2.55	2.41	2.27	2.12	1.98	1.84	1.65	1.46	1.24	1.03	.804
O	100	2.92	2.80	2.69	2.58	2.43	2.29	2.14	2.00	1.86	1.67	1.48	1.26	1.05	.819
P	150	2.96	2.84	2.73	2.61	2.47	2.33	2.18	2.03	1.89	1.70	1.51	1.29	1.07	.841
Q	200	2.97	2.85	2.73	2.62	2.47	2.33	2.18	2.04	1.89	1.70	1.51	1.29	1.07	.845
	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00		

Acceptable Quality Levels (tightened inspection)

All AQL values are in percent defective.
 ↓ Use first sampling plan below arrow, that is, both sample size as well as k value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.4 Table B-1 Master Table for Normal and Tightened Inspection (Form 1 - Single Limit)



TABLE B-2
Master Table for Reduced Inspection for Plans Based on Variability Unknown
(Single Specification Limit—Form 1)

Sample size code letter	Sample size	Acceptable Quality Levels											
		.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50
k	k	k	k	k	k	k	k	k	k	k	k	k	k
B	3								1.12	.958	.765	.566	.341
C	3								1.12	.958	.765	.566	.341
D	3								1.12	.958	.765	.566	.341
E	3								1.12	.958	.765	.566	.341
F	4								1.17	1.01	.814	.617	.393
G	5								1.34	1.17	1.01	.814	.617
H	7								1.45	1.34	1.17	1.01	.814
I	10								1.65	1.53	1.40	1.24	1.07
J	10								1.75	1.62	1.50	1.33	1.15
K	15								1.88	1.75	1.62	1.40	1.24
L	20								2.00	1.88	1.75	1.62	1.50
M	20								2.11	1.98	1.84	1.72	1.58
N	25								2.24	2.11	1.98	1.84	1.72
O	30								2.24	2.11	1.98	1.84	1.72
P	50								2.36	2.24	2.11	1.98	1.84
Q	75								2.41	2.28	2.15	2.00	1.86

All AQL values are in percent defective.

Use first sampling plan below arrow, that is, both sample size as well as k value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.5 Table B-2 Master Table for Reduced Inspection (Form 1 - Single Limit)



TABLE B-3
Master Table for Normal and Tightened Inspection for Plans Based on Variability Unknown
(Double Specification Limit and Form 2—Single Specification Limit)

Sample size code letter	Sample size	Acceptable Quality Levels (normal inspection)												
		.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	
B	3	M	M	M	M	M	M	M	M	M	M	M	M	
C	4													
D	5													
E	7													
F	10													
G	15	0.099	0.186	0.312	0.503	0.818	1.31	2.11	3.05	4.31	6.56	9.46	13.71	18.94
H	20	0.135	0.228	0.365	0.544	0.846	1.29	2.05	2.95	4.09	6.17	8.92	12.99	18.03
I	25	0.155	0.250	0.380	0.551	0.877	1.29	2.00	2.86	3.97	5.97	8.63	12.57	17.51
J	30	0.179	0.280	0.413	0.581	0.879	1.29	1.98	2.83	3.91	5.86	8.47	12.36	17.24
K	35	0.170	0.264	0.388	0.535	0.847	1.23	1.87	2.68	3.70	5.57	8.10	11.87	16.65
L	40	0.179	0.275	0.401	0.566	0.873	1.26	1.88	2.71	3.72	5.58	8.09	11.85	16.61
M	50	0.163	0.250	0.363	0.503	0.789	1.17	1.71	2.49	3.45	5.20	7.61	11.23	15.87
N	75	0.147	0.228	0.330	0.467	0.720	1.07	1.60	2.29	3.20	4.87	7.15	10.63	15.13
O	100	0.145	0.220	0.317	0.447	0.689	1.02	1.53	2.20	3.07	4.69	6.91	10.32	14.75
P	150	0.134	0.203	0.293	0.413	0.638	0.949	1.43	2.05	2.89	4.43	6.57	9.88	14.20
Q	200	0.135	0.204	0.294	0.414	0.637	0.945	1.42	2.04	2.87	4.40	6.53	9.81	14.12
	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00	

Acceptability Quality Levels (tightened inspection)

All AQL and table values are in percent defective.

↓ Use first sampling plan below arrow, that is, both sample size as well as M value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.6 Table B-3 Master Table for Normal and Tightened Inspection (Double Limit and Form 2 - Single Limit)



TABLE B-4
Master Table for Reduced Inspection for Plans Based on Variability Unknown
(Double Specification Limit and Form 2—Single Specification Limit)

Sample size code letter	Sample size	Acceptable Quality Levels											
		.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50
M	M	M	M	M	M	M	M	M	M	M	M	M	M
B	3									7.59	18.86	26.94	33.69
C	3									7.59	18.86	26.94	33.69
D	3									7.59	18.86	26.94	33.69
E	3									7.59	18.86	26.94	33.69
F	4									1.53	5.50	10.92	16.45
G	5									1.33	3.32	5.83	9.80
H	7									2.14	3.55	5.35	8.40
I	10									0.349	0.716	1.30	2.17
J	10									0.349	0.716	1.30	2.17
K	15									0.312	0.503	0.818	1.31
L	20									0.365	0.544	0.846	1.29
M	20									0.365	0.544	0.846	1.29
N	25									0.380	0.551	0.877	1.29
O	30									0.413	0.581	0.879	1.29
P	50									0.363	0.503	0.789	1.17
Q	75									0.330	0.467	0.720	1.07

All AQL and table values are in percent defective.

↓ Use first sampling plan below arrow, that is, both sample size as well as M value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.7 Table B-4 Master Table for Reduced Inspection (Double Limit and Form 2 - Single Limit)

TABLE B-5
Table for Estimating the Lot Percent Defective Using Standard Deviation Method¹

Sample Size	Group A																				
	4	3	2	1	0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
n	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21	22	23	24
0	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	
-1	47.26	46.87	46.48	46.10	45.71	45.32	44.93	44.54	44.15	43.76	43.37	42.98	42.59	42.20	41.81	41.42	41.03	40.64	40.25	40.86	40.47
-2	44.46	43.33	42.54	42.35	42.24	42.13	42.02	41.91	41.80	41.69	41.58	41.47	41.36	41.25	41.14	41.03	40.92	40.81	40.70	40.59	40.48
-3	41.43	40.20	39.37	38.67	38.00	37.33	36.67	36.00	35.33	34.67	34.00	33.33	32.67	32.00	31.33	30.67	30.00	29.33	28.67	28.00	27.33
-4	31.41	29.25	28.97	28.50	28.23	28.06	27.89	27.62	27.35	27.08	26.81	26.54	26.27	25.99	25.72	25.45	25.18	24.91	24.64	24.37	24.10
-5	21.02	20.06	19.33	18.66	18.00	17.33	16.67	16.00	15.33	14.67	14.00	13.33	12.67	12.00	11.33	10.67	10.00	9.33	8.67	8.00	7.33
-6	12.10	11.06	10.47	9.88	9.29	8.70	8.11	7.52	6.93	6.34	5.75	5.16	4.57	4.00	3.41	2.82	2.23	1.64	1.05	0.46	0.87
-7	3.33	2.99	2.60	2.21	1.82	1.43	1.04	0.65	0.26	0.87	0.48	0.09	0.69	0.29	0.87	0.48	0.09	0.69	0.29	0.87	0.48
-8	-2.4	-40.49	-37.97	-35.45	-32.93	-30.41	-27.89	-25.37	-22.85	-20.33	-17.81	-15.29	-12.77	-10.25	-7.73	-5.21	-2.69	-0.17	-2.69	-5.21	-7.73
-9	-35	-40.33	-37.62	-35.00	-32.38	-29.76	-27.14	-24.52	-21.90	-19.28	-16.66	-14.04	-11.42	-8.80	-6.18	-3.56	-0.94	-3.56	-6.18	-8.80	-11.42
-10	-26	-29.91	-26.20	-23.48	-20.76	-18.04	-15.32	-12.60	-9.88	-7.16	-4.44	-1.72	-8.00	-15.32	-22.69	-29.91	-37.19	-44.47	-51.75	-59.03	-66.31
-11	-12	-27.86	-25.24	-22.62	-19.99	-17.37	-14.75	-12.13	-9.50	-6.88	-4.26	-1.64	-8.00	-15.37	-22.74	-29.12	-36.50	-43.88	-51.26	-58.64	-66.02
-12	-3	-39.33	-37.23	-35.10	-32.98	-30.85	-28.73	-26.60	-24.47	-22.34	-20.21	-18.08	-15.95	-13.82	-11.69	-9.56	-7.43	-5.30	-3.17	-1.04	-2.91
-13	-39	-39.03	-37.00	-34.96	-32.92	-30.88	-28.84	-26.80	-24.76	-22.72	-20.68	-18.64	-16.60	-14.56	-12.52	-10.48	-8.44	-6.40	-4.36	-2.32	-0.28
-14	-39	-39.59	-37.56	-35.52	-33.48	-31.44	-29.40	-27.36	-25.32	-23.28	-21.24	-19.20	-17.16	-15.12	-13.08	-11.04	-8.00	-5.96	-3.92	-1.88	-0.84
-15	-35	-34.83	-32.79	-30.75	-28.71	-26.67	-24.63	-22.59	-20.55	-18.51	-16.47	-14.43	-12.39	-10.35	-8.31	-6.27	-4.23	-2.19	-0.15	-2.11	-4.07
-16	-43	-37.45	-35.31	-33.17	-31.03	-28.89	-26.75	-24.61	-22.47	-20.33	-18.19	-16.05	-13.91	-11.77	-9.63	-7.49	-5.35	-3.21	-1.07	-2.93	-4.89
-17	-47	-37.45	-35.31	-33.17	-31.03	-28.89	-26.75	-24.61	-22.47	-20.33	-18.19	-16.05	-13.91	-11.77	-9.63	-7.49	-5.35	-3.21	-1.07	-2.93	-4.89
-18	-44	-37.76	-35.62	-33.48	-31.34	-29.20	-27.06	-24.92	-22.78	-20.64	-18.50	-16.36	-14.22	-12.08	-9.94	-7.80	-5.66	-3.52	-1.38	-3.24	-5.10
-19	-45	-37.76	-35.62	-33.48	-31.34	-29.20	-27.06	-24.92	-22.78	-20.64	-18.50	-16.36	-14.22	-12.08	-9.94	-7.80	-5.66	-3.52	-1.38	-3.24	-5.10
-20	-44	-37.76	-35.62	-33.48	-31.34	-29.20	-27.06	-24.92	-22.78	-20.64	-18.50	-16.36	-14.22	-12.08	-9.94	-7.80	-5.66	-3.52	-1.38	-3.24	-5.10
-21	-45	-37.76	-35.62	-33.48	-31.34	-29.20	-27.06	-24.92	-22.78	-20.64	-18.50	-16.36	-14.22	-12.08	-9.94	-7.80	-5.66	-3.52	-1.38	-3.24	-5.10
-22	-46	-36.96	-34.81	-32.66	-30.51	-28.36	-26.21	-24.06	-21.91	-19.76	-17.61	-15.46	-13.31	-11.16	-8.01	-5.86	-3.71	-1.56	-0.41	-2.26	-4.11
-23	-47	-36.66	-34.53	-32.27	-30.08	-27.89	-25.70	-23.51	-21.32	-19.13	-16.94	-14.75	-12.56	-10.37	-8.18	-5.99	-3.80	-1.61	-0.42	-2.27	-4.12
-24	-48	-36.25	-34.00	-31.52	-29.07	-26.65	-24.21	-21.77	-19.33	-16.89	-14.44	-12.00	-9.55	-7.00	-4.45	-2.00	-0.55	-0.10	-0.05	-0.02	-0.01
-25	-49	-36.67	-34.78	-32.36	-30.03	-27.72	-25.37	-23.02	-20.67	-18.32	-16.07	-13.82	-11.57	-9.32	-7.07	-4.82	-2.57	-1.32	-0.57	-0.28	-0.14

Values tabulated are read in percent.

FIG. A1.8 Table B-5 Table for Estimating the Lot Percent Defective

TABLE B-5—Continued
Table for Estimating the Lot Percent Defective Using Standard Deviation Method

FIG. A1.8 Table B-5 Table for Estimating the Lot Percent Defective (*continued*)

TABLE B-5—Continued
Table for Estimating the Lot Percent Defective Using Standard Deviation Method

Q _U	Q _L	Sample Size																				
		3	4	5	7	10	15	20	25	30	35	40	50	75	100	150	200	3	4	5	7	
1.90	0.00	0.00	0.00	0.93	1.75	2.21	2.40	2.53	2.57	2.62	2.65	2.70	2.76	2.79	2.82	2.83	2.80	0.000	0.000	0.233	0.348	
1.91	0.00	0.00	0.00	0.87	1.68	2.14	2.34	2.44	2.51	2.56	2.59	2.63	2.69	2.72	2.73	2.77	2.31	0.000	0.000	0.218	0.346	
1.92	0.00	0.00	0.00	0.83	1.68	2.08	2.27	2.38	2.45	2.49	2.52	2.57	2.63	2.66	2.69	2.70	2.32	0.000	0.000	0.203	0.349	
1.93	0.00	0.00	0.00	0.76	1.56	2.02	2.21	2.32	2.38	2.43	2.46	2.51	2.57	2.60	2.62	2.64	2.33	0.000	0.000	0.199	0.346	
1.94	0.00	0.00	0.00	0.70	1.50	1.96	2.15	2.25	2.32	2.37	2.40	2.45	2.51	2.54	2.56	2.58	2.24	0.000	0.000	0.195	0.346	
1.95	0.00	0.00	0.00	0.65	1.44	1.90	2.09	2.19	2.26	2.31	2.34	2.45	2.48	2.50	2.52	2.55	2.25	0.000	0.000	0.191	0.346	
1.96	0.00	0.00	0.00	0.60	1.30	1.64	1.80	2.03	2.14	2.20	2.25	2.30	2.39	2.42	2.44	2.46	2.26	0.000	0.000	0.185	0.346	
1.97	0.00	0.00	0.00	0.56	1.23	1.59	1.78	1.97	2.08	2.14	2.19	2.22	2.27	2.33	2.36	2.39	2.40	2.37	0.000	0.000	0.180	0.345
1.98	0.00	0.00	0.00	0.51	1.27	1.73	1.92	2.02	2.09	2.13	2.17	2.21	2.27	2.30	2.33	2.34	2.38	2.36	0.000	0.000	0.175	0.345
1.99	0.00	0.00	0.00	0.47	1.22	1.67	1.86	1.97	2.03	2.08	2.11	2.14	2.22	2.25	2.29	2.30	2.30	2.30	0.000	0.000	0.170	0.345
2.00	0.00	0.00	0.00	0.43	1.17	1.62	1.81	1.91	1.98	2.03	2.06	2.10	2.19	2.22	2.23	2.24	2.24	2.20	0.000	0.000	0.165	0.345
2.01	0.00	0.00	0.00	0.39	1.12	1.57	1.76	1.86	1.93	1.97	2.01	2.05	2.11	2.14	2.17	2.18	2.14	2.00	0.000	0.000	0.160	0.345
2.02	0.00	0.00	0.00	0.37	1.07	1.52	1.63	1.87	1.92	1.95	2.00	2.06	2.09	2.11	2.13	2.13	2.12	2.00	0.000	0.000	0.159	0.345
2.10	0.00	0.00	0.00	0.32	1.03	1.47	1.66	1.76	1.82	1.87	1.90	1.95	2.01	2.04	2.08	2.08	2.03	2.00	0.000	0.000	0.143	0.345
2.04	0.00	0.00	0.00	0.29	0.98	1.42	1.56	1.71	1.77	1.85	1.88	1.90	1.96	1.99	2.01	2.03	2.04	2.00	0.000	0.000	0.137	0.345
2.05	0.00	0.00	0.00	0.26	0.94	1.36	1.56	1.66	1.73	1.77	1.80	1.85	1.91	1.94	1.98	2.00	2.05	2.00	0.000	0.000	0.130	0.345
2.06	0.00	0.00	0.00	0.23	0.90	1.33	1.51	1.61	1.68	1.72	1.76	1.80	1.86	1.89	1.92	1.93	2.06	2.00	0.000	0.000	0.124	0.345
2.07	0.00	0.00	0.00	0.21	0.86	1.28	1.47	1.57	1.63	1.68	1.71	1.76	1.81	1.86	1.87	1.88	2.07	2.00	0.000	0.000	0.117	0.345
2.08	0.00	0.00	0.00	0.18	0.82	1.24	1.42	1.52	1.59	1.63	1.66	1.71	1.75	1.79	1.82	1.84	2.08	2.00	0.000	0.000	0.111	0.345
2.09	0.00	0.00	0.00	0.16	0.78	1.20	1.38	1.48	1.54	1.59	1.62	1.66	1.72	1.75	1.78	1.79	2.09	2.00	0.000	0.000	0.105	0.345
2.10	0.00	0.00	0.00	0.14	0.74	1.16	1.34	1.44	1.50	1.55	1.58	1.62	1.68	1.71	1.73	1.75	2.50	2.00	0.000	0.000	0.100	0.345
2.11	0.00	0.00	0.00	0.12	0.71	1.12	1.30	1.39	1.46	1.50	1.53	1.58	1.63	1.66	1.69	1.70	2.51	2.00	0.000	0.000	0.097	0.345
2.12	0.00	0.00	0.00	0.10	0.67	1.08	1.26	1.35	1.42	1.46	1.49	1.54	1.59	1.62	1.65	1.66	2.52	2.00	0.000	0.000	0.093	0.345
2.13	0.00	0.00	0.00	0.08	0.64	1.04	1.22	1.31	1.38	1.42	1.45	1.50	1.55	1.58	1.63	1.63	2.53	2.00	0.000	0.000	0.089	0.345
2.14	0.00	0.00	0.00	0.06	0.61	1.00	1.18	1.28	1.34	1.38	1.41	1.46	1.51	1.54	1.58	1.58	2.54	2.00	0.000	0.000	0.085	0.345
2.15	0.00	0.00	0.00	0.06	0.58	0.97	1.14	1.20	1.30	1.34	1.37	1.42	1.47	1.50	1.53	1.54	2.55	2.00	0.000	0.000	0.082	0.345
2.16	0.00	0.00	0.00	0.05	0.55	0.93	1.10	1.20	1.26	1.30	1.34	1.40	1.46	1.50	1.55	1.56	2.56	2.00	0.000	0.000	0.078	0.345
2.17	0.00	0.00	0.00	0.04	0.52	0.97	1.07	1.16	1.22	1.27	1.30	1.34	1.42	1.45	1.46	1.47	2.57	2.00	0.000	0.000	0.074	0.345
2.18	0.00	0.00	0.00	0.03	0.49	0.87	1.03	1.13	1.19	1.23	1.26	1.30	1.36	1.41	1.42	1.43	2.58	2.00	0.000	0.000	0.070	0.345
2.19	0.00	0.00	0.00	0.02	0.46	0.83	1.00	1.09	1.15	1.20	1.22	1.27	1.32	1.35	1.36	1.39	2.59	2.00	0.000	0.000	0.063	0.345
2.20	0.00	0.00	0.00	0.015	0.47	0.83	0.98	1.03	1.10	1.16	1.19	1.23	1.28	1.34	1.35	1.36	2.60	2.00	0.000	0.000	0.061	0.345
2.21	0.00	0.00	0.00	0.010	0.40	0.76	0.86	0.98	1.07	1.12	1.18	1.23	1.28	1.33	1.35	1.36	2.61	2.00	0.000	0.000	0.056	0.345
2.22	0.00	0.00	0.00	0.006	0.36	0.72	0.80	0.89	0.96	1.04	1.09	1.15	1.20	1.25	1.29	1.31	2.62	2.00	0.000	0.000	0.050	0.345
2.23	0.00	0.00	0.00	0.003	0.33	0.66	0.73	0.81	0.89	0.95	1.03	1.09	1.15	1.20	1.25	1.26	2.63	2.00	0.000	0.000	0.045	0.345
2.24	0.00	0.00	0.00	0.002	0.30	0.63	0.69	0.75	0.82	0.88	0.94	1.01	1.07	1.13	1.18	1.19	2.64	2.00	0.000	0.000	0.040	0.345
2.25	0.00	0.00	0.00	0.001	0.28	0.58	0.64	0.70	0.76	0.82	0.88	0.94	1.00	1.06	1.11	1.12	2.65	2.00	0.000	0.000	0.035	0.345
2.26	0.00	0.00	0.00	0.000	0.26	0.54	0.60	0.66	0.72	0.78	0.84	0.90	0.96	1.02	1.07	1.08	2.66	2.00	0.000	0.000	0.030	0.345
2.27	0.00	0.00	0.00	0.000	0.24	0.50	0.56	0.62	0.68	0.74	0.80	0.86	0.92	0.98	1.03	1.04	2.67	2.00	0.000	0.000	0.025	0.345
2.28	0.00	0.00	0.00	0.000	0.22	0.48	0.54	0.60	0.66	0.72	0.78	0.84	0.90	0.96	1.01	1.02	2.68	2.00	0.000	0.000	0.020	0.345
2.29	0.00	0.00	0.00	0.000	0.20	0.46	0.52	0.58	0.64	0.70	0.76	0.82	0.88	0.94	0.99	1.00	2.69	2.00	0.000	0.000	0.015	0.345

FIG. A1.8 Table B-5 Table for Estimating the Lot Percent Defective (continued)

TABLE B-5—Continued
Table for Estimating the Lot Percent Defective Using Standard Deviation Method

FIG. A1.8 Table B-5 Table for Estimating the λ of Percent Defective (continued)



TABLE B-5—Continued
Table for Estimating the Lot Percent Defective Using Standard Deviation Method

Q _{ct}	Q _c	Sample Size																			
		3	4	5	7	10	15	20	25	30	35	40	50	75	100	150	200	30	35	40	50
3.50	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.51	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.52	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.53	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.54	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.55	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.56	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.57	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.58	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.59	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.60	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.61	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.62	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.63	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.64	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.65	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.66	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.67	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.68	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	
3.69	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	

FIG. A1.8 Table B-5 Table for Estimating the Lot Percent Defective (continued)

TABLE B-6

Standard Deviation Method

Values of T for Tightened Inspection

Sample size code letter	Acceptable Quality Levels (in percent defective)														Number of Lots
	.04	.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	4.0	6.5	10.0	15.0	
B	*	*	*	*	*	*	*	*	*	2 4 5	3 5 6	4 6 8	4 7 9	4 7 11	5 10 15
C	*	*	*	*	*	*	*	2 3 5	2 4 6	3 5 7	3 6 8	4 7 9	4 7 10	4 8 11	5 10 15
D	*	*	*	*	*	*	2 4 5	3 4 6	3 5 7	3 6 8	4 6 9	4 7 10	4 7 10	4 8 11	5 10 15
E	*	*	*	*	2 4 5	3 4 6	3 5 6	3 5 7	4 6 8	4 6 9	4 7 9	4 7 10	4 7 11	4 8 11	5 10 15
F	*	*	*	3 4 6	3 5 6	3 5 7	3 6 8	4 6 8	4 6 9	4 7 9	4 7 10	4 7 11	4 8 11	4 8 11	5 10 15
G	3 4 6	3 5 6	3 5 6	3 5 7	3 6 7	4 6 8	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 11	4 8 11	4 8 11	5 10 15
H	3 5 6	3 5 7	3 5 7	3 5 8	4 6 8	4 6 9	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 11	4 8 11	4 8 11	5 10 15
I	3 5 7	3 6 7	4 6 8	4 6 9	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	5 10 15
J	3 6 8	4 6 8	4 6 9	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
K	4 6 8	4 6 8	4 6 9	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 8 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
L	4 6 8	4 6 9	4 6 9	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 8 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
M	4 6 9	4 7 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
N	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	5 10 15						
O	4 7 10	4 7 10	4 7 10	4 7 10	4 7 11	4 8 11	5 10 15								

*There are no sampling plans provided in this Standard for these code letters and AQL values.

FIG. A1.9 Table B-6 Values of T for Tightened Inspection

TABLE B-6—Continued Standard Deviation Method
Values of T for Tightened Inspection

Sample size code letter	Acceptable Quality Levels (in percent defective)														Number of Lots
	.04	.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	4.0	6.5	10.0	15.0	
P	4	4	4	4	4	4	4	4	4	4	4	4	4	4	5
	7	7	7	8	8	8	8	8	8	8	8	8	8	8	10
	10	10	10	10	11	11	11	11	11	11	11	11	11	12	15
Q	4	4	4	4	4	4	4	4	4	4	4	4	4	4	5
	7	8	8	8	8	8	8	8	8	8	8	8	8	8	10
	10	11	11	11	11	11	11	11	11	11	11	11	11	12	15

The top figure in each block refers to the preceding 5 lots, the middle figure to the preceding 10 lots and the bottom figure to the preceding 15 lots.

Tightened inspection is required when the number of lots with estimates of percent defective above the AQL from the preceding 5, 10, or 15 lots is greater than the given value of T in the table, and the process average from these lots exceeds the AQL.

All estimates of the lot percent defective are obtained from Table B-5.

FIG. A1.9 Table B-6 Values of T for Tightened Inspection (continued)



TABLE B-7
Limits of Estimated Lot Percent Defective for Reduced Inspection
Standard Deviation Method

Sample size code letter	Acceptable Quality Levels										Number of Lots			
	.04	.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	4.0			
B	*	*	*	*	*	*	*	*	*	[42]**	[28]**	[18]**	[12]**	[9]**
C	*	*	*	*	*	*	[45]**	[31]**	[22]**	[15]**	[10]**	[7]**	[7]**	[9]**
D	*	*	*	*	*	[33]**	[25]**	[18]**	[13]**	[9]**	0.00	.74	6.06	5
E	*	*	*	*	[25]**	[18]**	[14]**	[11]**	.00	4.40	9.96	15.00	10	15
F	*	*	*	*	[000	.000	.003	.044	.306	1.38	4.24	9.09	5	
G	[000	[002	[006	[018	[057	[143	[330	[643	[323	[84	[80	[86	[47	5
H	[000	[002	[002	[005	[017	[048	[123	[266	[521	[14	[24	[40	[07	5
I	[001	[002	[006	[014	[037	[083	[185	[360	[653	[33	[49	[74	[243	5
J	[002	[013	[027	[050	[087	[169	[306	[550	[431	[750	[47	[81	[69	5
														15

*There are no sampling plans provided in this Standard for these code letters and AQL values.

FIG. A1.10 Table B-7 Limits of Estimated Lot Percent Defective for Reduced Inspection



TABLE B-7—Continued
Limits of Estimated Lot Percent Defective for Reduced Inspection

Sample size code letter	.04	.065	.10	.15	.25	.40	.65	Acceptable Quality Levels					Number of Lots	
								.0	.5	.4	.6	.5		
K	.004	.008	.017	.032	.069	.137	.270	.483	.821	1.57	2.79	4.96	8.15	12.88
	.017	.033	.059	.099	.186	.328	.577	.940	1.47	2.50	4.00	6.50	10.00	15.00
	.032	.058	.097	.15	.25	.40	.65	1.00	1.50	▲	▲	▲	▲	▲
L	.005	.011	.022	.040	.082	.157	.300	.525	.876	1.64	2.88	5.08	8.29	13.03
	.020	.038	.065	.108	.199	.343	.596	.961	1.49	2.50	4.00	6.50	10.00	15.00
	.035	.063	.10	.15	.25	.40	.65	1.00	1.50	▲	▲	▲	▲	▲
M	.008	.016	.030	.052	.102	.187	.345	.587	.959	1.76	3.03	5.27	8.50	13.25
	.025	.045	.075	.120	.215	.364	.621	.989	1.50	2.50	4.00	6.50	10.00	15.00
	.04	.065	.10	.15	.25	.40	.65	1.00	▲	▲	▲	▲	▲	▲
N	.014	.026	.044	.072	.134	.235	.414	.681	1.082	1.92	3.24	5.52	8.81	13.60
	.031	.054	.087	.136	.236	.389	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00
	.04	.065	.10	.15	.25	.40	▲	▲	▲	▲	▲	▲	▲	▲
O	.018	.032	.053	.085	.153	.261	.453	.733	1.149	2.01	3.36	5.67	8.98	13.80
	.034	.058	.093	.143	.245	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00
	.04	.065	.10	.15	.25	▲	▲	▲	▲	▲	▲	▲	▲	▲
P	.023	.039	.064	.101	.177	.296	.501	.799	1.237	2.13	3.52	5.87	9.22	14.07
	.038	.064	.10	.15	.25	.40	▲	▲	▲	▲	▲	▲	▲	▲
	.04	.065	▲	▲	▲	▲	▲	▲	▲	▲	▲	▲	▲	▲
Q	.025	.044	.069	.108	.188	.312	.525	.830	1.276	2.19	3.59	5.96	9.32	14.19
	.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00
	▲	▲	▲	▲	▲	▲	▲	▲	▲	▲	▲	▲	▲	▲

All AQL and table values, except those in the brackets, are in percent defective.

▼ Use the first figure in direction of arrow and corresponding number of lots. In each block the top figure refers to the preceding 5 lots, the middle figure to the preceding 10 lots, and the bottom figure to the preceding 15 lots.

Reduced inspection may be instituted when every estimated lot percent defective from the preceding 5, 10, or 15 lots is below the figure given in the table; reduced inspection for sampling plans marked (*#) in the table requires that the estimated lot percent defective is equal to zero for the number of consecutive lots indicated in brackets. In addition, all other conditions for reduced inspection, in Part III of Section B, must be satisfied.

All estimates of the lot percent defective are obtained from Table B-5.

FIG. A1.10 Table B-7 Limits of Estimated Lot Percent Defective for Reduced Inspection (continued)



TABLE B-8
Values of F for Maximum Standard Deviation (MSD)

Sample size code letter	Sample size	Acceptable Quality Levels (in percent defective)																				
		.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00							
B	3																					
C	4																					
D	5																					
E	7																					
F	10																					
G	15	.182	.188	.195	.202	.211	.214	.224	.235	.253	.266	.280	.295	.318	.339	.353	.374	.436	.453	.475	.502	.538
H	20	.177	.183	.190	.197	.206	.216	.222	.235	.248	.262	.276	.298	.324	.345	.381	.425	.472	.528	.558	.588	.628
I	25	.174	.180	.187	.193	.203	.212	.225	.238	.251	.277	.298	.324	.359	.381	.425	.472	.528	.558	.588	.628	.668
J	30	.173	.179	.185	.192	.201	.210	.223	.236	.249	.270	.295	.328	.369	.399	.439	.479	.519	.559	.599	.639	.679
K	35	.170	.176	.183	.189	.198	.208	.220	.232	.245	.270	.295	.328	.369	.399	.439	.479	.519	.559	.599	.639	.679
L	40	.169	.176	.182	.188	.198	.207	.219	.232	.245	.270	.295	.328	.369	.399	.439	.479	.519	.559	.599	.639	.679
M	50	.166	.172	.178	.184	.194	.203	.214	.227	.241	.261	.284	.317	.356	.396	.436	.476	.516	.556	.596	.636	.676
N	75	.162	.168	.174	.181	.189	.199	.211	.223	.235	.255	.279	.310	.348	.399	.438	.478	.518	.558	.598	.638	.678
O	100	.160	.166	.172	.179	.187	.197	.208	.220	.233	.253	.276	.307	.345	.395	.435	.475	.515	.555	.595	.635	.675
P	150	.158	.163	.170	.175	.185	.193	.206	.216	.230	.249	.271	.302	.341	.388	.428	.468	.508	.548	.588	.628	.668
Q	200	.157	.163	.168	.175	.183	.193	.203	.215	.228	.248	.269	.302	.338	.386	.426	.466	.506	.546	.586	.626	.666

The MSD may be obtained by multiplying the factor F by the difference between the upper specification limit U and lower specification limit L. The formula is $MSD = F(U-L)$. The MSD serves as a guide for the magnitude of the estimate of lot standard deviation when using plans for the double specification limit case, based on the estimate of lot standard deviation of unknown variability. The estimate of lot standard deviation, if it is less than the MSD, helps to insure, but does not guarantee, lot acceptability.

NOTE: There is a corresponding acceptability constant in Table B-1 for each value of F. For reduced inspection, find the acceptability constant of Table B-2 in Table B-1 and use the corresponding value of F.

FIG. A1.11 Table B-8 Values of F for Maximum Standard Deviation (MSD)



TABLE C-1
Master Table for Normal and Tightened Inspection for Plans Based on Variability Unknown
(Single Specification Limit—Form 1)

Sample size code letter	Sample size	Acceptable Quality Levels (normal inspection)													
		.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00
k	k	k	k	k	k	k	k	k	k	k	k	k	k	k	k
B	3														
C	4														
D	5														
E	7														
F	10														
G	15	1.09	1.04	.999	.958	.903	.850	.792	.738	.684	.610	.536	.452	.368	.276
H	25	1.14	1.10	1.05	1.01	.951	.896	.835	.779	.723	.647	.571	.484	.398	.305
I	30	1.15	1.10	1.06	1.02	.959	.904	.843	.787	.730	.654	.577	.490	.403	.310
J	35	1.16	1.11	1.07	1.02	.964	.908	.848	.791	.734	.658	.581	.494	.406	.313
K	40	1.18	1.13	1.08	1.04	.978	.921	.860	.803	.746	.668	.591	.503	.415	.321
L	50	1.19	1.14	1.09	1.05	.988	.931	.893	.812	.754	.676	.598	.510	.421	.327
M	60	1.21	1.16	1.11	1.06	1.00	.948	.885	.826	.768	.689	.610	.521	.432	.336
N	85	1.23	1.17	1.13	1.08	1.02	.962	.899	.839	.780	.701	.621	.530	.441	.345
O	115	1.24	1.19	1.14	1.09	1.03	.975	.911	.851	.791	.711	.631	.539	.449	.353
P	175	1.26	1.21	1.16	1.11	1.05	.994	.929	.868	.807	.726	.644	.552	.460	.363
Q	230	1.27	1.21	1.16	1.12	1.06	.996	.931	.870	.809	.728	.646	.553	.462	.364
	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00		

Acceptable Quality Levels (tightened inspection)

All AQL values are in percent defective.

Use first sampling plan below arrow, that is, both sample size as well as k value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.12 Table C-1 Master Table for Normal and Tightened Inspection (Form 1 - Single Limit)



Range Method

TABLE C-2
Master Table for Reduced Inspection for Plans Based on Variability Unknown
(Single Specification Limit—Form 1)

Sample size code letter	Sample size	Acceptable Quality Levels																				
		.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00								
k	k	k	k	k	k	k	k	k	k	k	k	k	k									
B	3									.587	.502	.401	.296	.178								
C	3									.587	.502	.401	.296	.178								
D	3									.587	.502	.401	.296	.178								
E	3									.587	.502	.401	.296	.178								
F	4									.598	.525	.450	.364	.276	.176							
G	5									.614	.565	.498	.431	.352	.272	.184						
H	7									.613	.569	.525	.465	.405	.336	.266	.189					
I	10									.659	.613	.569	.525	.465	.405	.336	.266	.189				
J	10									.702	.659	.613	.569	.525	.465	.405	.336	.266	.189			
K	15									.863	.811	.755	.703	.650	.579	.507	.424	.341	.252			
L	25									.916	.863	.811	.755	.703	.650	.579	.507	.424	.341	.252		
M	25									.958	.903	.850	.792	.738	.684	.610	.536	.452	.368	.276		
N	30									1.04	.999	.958	.903	.850	.792	.738	.684	.610	.536	.452	.368	.276
O	35									1.10	1.05	1.01	.951	.896	.835	.779	.723	.647	.571	.484	.398	.305
P	60									1.11	1.07	1.02	.964	.908	.848	.791	.734	.647	.571	.484	.398	.305
Q	85									1.16	1.11	1.06	1.00	.948	.885	.826	.768	.689	.610	.521	.432	.336
										1.17	1.13	1.08	1.02	.962	.899	.839	.780	.701	.621	.530	.441	.345

All AQL values are in percent defective.
 ↓ Use first sampling plan below arrow, that is, both sample size as well as k value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.13 Table C-2 Master Table for Reduced Inspection (Form 1 - Single Limit)



TABLE C-3
Master Table for Normal and Tightened Inspection for Plans Based on Variability Unknown
(Double Specification Limit and for Form 2—Single Specification Limit)

Sample size code letter	Sample size	c factor	.04	Acceptable Quality Levels (normal inspection)															
				.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00			
M	M	M	M	M	M	M	M	M	M	M	M	M	M	M	M	M			
B	3	1.910	↓						▼	▼	7.59	18.86	26.94	33.69	40.47				
C	4	2.234	↓	↓	↓	↓	↓	↓	▼	1.53	5.50	10.92	16.45	22.86	29.45	36.90			
D	5	2.474	↓	↓	↓	↓	↓	↓	1.42	3.44	5.93	9.90	14.47	20.27	26.59	33.95			
E	7	2.830	↓	↓	↓	↓	↓	↓	.89	1.99	3.46	5.32	8.47	12.35	17.54	23.50	30.66		
F	10	2.405	↓	↓	↓	↓	↓	↓	.23	.58	1.14	2.05	3.23	4.77	7.42	10.79	15.49	21.06	27.90
G	15	2.379	.061	.136	.253	.430	.786	.130	2.10	3.11	4.44	6.76	9.76	14.09	19.30	25.92			
H	25	2.358	.125	.214	.336	.506	.827	.127	1.95	2.82	3.96	5.98	8.65	12.59	17.48	23.79			
I	30	2.353	.147	.240	.366	.537	.856	.129	1.96	2.81	3.92	5.88	8.50	12.36	17.19	23.42			
J	35	2.349	.165	.261	.391	.564	.883	.133	1.98	2.82	3.90	5.85	8.42	12.24	17.03	23.21			
K	40	2.346	.160	.252	.375	.539	.842	.125	1.88	2.69	3.73	5.61	8.11	11.84	16.55	22.38			
L	50	2.342	.169	.261	.381	.542	.838	.125	1.60	2.63	3.64	5.47	7.91	11.57	16.20	22.26			
M	60	2.339	.158	.244	.356	.504	.781	.116	1.74	2.47	3.44	5.17	7.54	11.10	15.64	21.63			
N	85	2.335	.156	.242	.350	.493	.755	.112	1.67	2.37	3.30	4.97	7.27	10.73	15.17	21.05			
O	115	2.333	.153	.230	.333	.468	.718	.106	1.58	2.25	3.14	4.76	6.99	10.37	14.74	20.57			
P	175	2.331	.139	.210	.303	.427	.655	.972	1.46	2.08	2.93	4.47	6.60	9.89	14.15	19.88			
Q	230	2.330	.142	.215	.308	.432	.661	.976	1.47	2.08	2.92	4.46	6.57	9.84	14.10	19.82			
			.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00	15.00				

Acceptable Quality Levels (tightened inspection)

All AQL and table values are in percent defective.
 ↓ Use first sampling plan below arrow, that is, both sample size as well as M value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.14 Table C-3 Master Table for Normal and Tightened Inspection (Double Limit and Form 2 - Single Limit)



Range Method

TABLE C-4
Master Table for Reduced Inspection for Plans Based on Variability Unknown
(Double Specification Limit and Form 2—Single Specification Limit)

Sample size code letter	Sample size	c factor	Acceptable Quality Levels												
			.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00
M	M	M	M	M	M	M	M	M	M	M	M	M	M	M	
B	3	1.910								7.59	18.86	26.94	33.69	40.47	
C	3	1.910								7.59	18.86	26.94	33.69	40.47	
D	3	1.910								7.59	18.86	26.94	33.69	40.47	
E	3	1.910								7.59	18.86	26.94	33.69	40.47	
F	4	2.234								1.53	5.50	10.92	16.45	22.86	29.45
G	5	2.474								1.42	3.44	5.93	9.90	14.47	20.27
H	7	2.830								.89	1.99	3.46	5.32	8.47	12.35
I	10	2.405								.23	.58	1.14	2.05	3.23	4.77
J	10	2.405								.23	.58	1.14	2.05	3.23	4.77
K	15	2.379								.253	.430	.786	1.30	2.10	3.11
L	25	2.358								.214	.336	.506	.827	1.27	1.95
M	25	2.358								.214	.336	.506	.827	1.27	1.95
N	30	2.353								.240	.366	.537	.856	1.29	1.96
O	35	2.349								.261	.391	.564	.883	1.33	1.98
P	60	2.339								.244	.356	.504	.781	1.16	1.74
Q	85	2.335								.242	.350	.493	.755	1.12	1.67

All AQL and table values are in percent defective.

↓ Use first sampling plan below arrow, that is, both sample size as well as M value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.15 Table C-4 Master Table for Reduced Inspection (Double Limit and Form 2 - Single Limit)

TABLE C-5
Table for Estimating the Lot Percent Defective Using Range Method¹

Q _d	Sample Size												Sample Size																							
	3	4	5	7	10	15	25	30	35	40	50	60	85	115	175	200	Q _d	3	4	5	7	10	15	25	30	35	40	50	60	85	115	175	200			
0	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	50.00	.70	29.27	26.87	27.53	27.45	24.35	24.35	24.35	24.35	24.35	24.35	24.35	24.35	24.35	24.35	24.35	24.35	24.35		
.1	47.24	46.67	46.44	46.29	46.20	42.42	42.19	42.17	42.15	42.13	42.12	42.10	42.08	44.06	44.03	44.03	.71	26.92	26.43	26.43	26.43	26.43	26.43	26.43	26.43	26.43	26.43	26.43	26.43	26.43	26.43	26.43	26.43	26.43		
.2	44.48	43.23	42.50	42.40	42.42	42.16	42.15	42.17	42.15	42.13	42.12	42.10	42.08	44.06	44.03	44.03	.72	26.59	26.09	26.09	26.09	26.09	26.09	26.09	26.09	26.09	26.09	26.09	26.09	26.09	26.09	26.09	26.09	26.09		
.3	41.63	40.00	39.37	38.99	38.70	38.51	38.38	38.34	38.32	38.31	38.30	38.28	38.27	38.26	38.24	38.22	.73	26.20	25.09	25.09	25.09	25.09	25.09	25.09	25.09	25.09	25.09	25.09	25.09	25.09	25.09	25.09	25.09	25.09		
.4	38.45	36.33	35.13	34.87	34.78	34.69	34.60	34.59	34.58	34.57	34.56	34.55	34.54	34.53	34.52	34.51	.74	27.86	25.33	26.44	23.86	23.90	23.10	23.08	23.07	23.06	23.05	23.04	23.03	23.02	23.01	23.00	23.00	23.00		
.5	35.40	34.33	33.13	32.87	32.78	32.69	32.61	32.58	32.56	32.55	32.54	32.53	32.52	32.51	32.50	32.49	.75	27.50	25.00	24.11	23.55	23.22	22.86	22.86	22.78	22.74	22.72	22.71	22.69	22.68	22.67	22.66	22.65	22.64		
.6	32.91	30.00	27.78	26.97	26.59	26.43	26.29	26.19	26.09	26.07	26.05	26.03	25.99	25.97	25.95	25.93	.76	27.13	26.67	22.79	22.51	22.49	22.47	22.47	22.46	22.45	22.44	22.43	22.42	22.41	22.40	22.39	22.38	22.38		
.7	29.68	27.67	26.32	27.87	27.40	27.39	27.25	27.21	27.19	27.15	27.14	27.12	27.09	27.09	27.09	27.09	.77	26.77	26.33	23.67	23.47	23.39	23.39	23.39	23.38	23.38	23.37	23.37	23.37	23.37	23.37	23.37	23.37	23.37	23.37	
.8	26.58	26.07	25.73	25.78	25.55	25.59	25.50	25.48	25.46	25.45	25.43	25.42	25.41	25.40	25.39	25.38	.78	26.39	26.00	23.15	22.60	22.36	22.36	22.36	22.35	22.35	22.34	22.34	22.34	22.34	22.34	22.34	22.34	22.34	22.34	
.9	23.93	27.00	27.00	27.00	27.00	27.00	27.00	27.00	27.00	27.00	27.00	27.00	27.00	27.00	27.00	27.00	.79	26.02	25.67	22.93	22.29	21.99	21.66	21.60	21.58	21.57	21.56	21.55	21.54	21.53	21.52	21.50	21.49	21.49		
.10	20.74	26.67	35.88	35.26	35.03	34.82	34.66	34.62	34.59	34.56	34.53	34.51	34.49	34.46	34.43	34.40	.80	25.64	23.33	22.51	21.98	21.69	21.48	21.34	21.24	21.14	21.04	21.04	21.04	21.04	21.04	21.04	21.04	21.04		
.11	18.45	26.33	35.54	35.01	34.69	34.46	34.32	34.25	34.18	34.14	34.11	34.08	34.05	34.03	34.01	34.00	.81	25.25	23.00	22.19	21.68	21.39	21.18	21.04	21.01	20.99	20.93	20.93	20.93	20.93	20.93	20.93	20.93	20.93		
.12	16.25	26.00	35.19	34.65	34.33	34.20	33.93	33.69	33.46	33.23	33.00	32.80	32.78	32.75	32.72	32.70	.82	24.96	22.67	21.67	21.37	21.09	20.69	20.68	20.66	20.64	20.64	20.64	20.64	20.64	20.64	20.64	20.64	20.64		
.13	13.85	25.67	34.85	34.20	33.96	33.74	33.57	33.53	33.44	33.44	33.44	33.43	33.43	33.43	33.43	33.43	.83	24.47	22.33	21.56	20.59	20.46	20.43	20.43	20.42	20.41	20.41	20.40	20.39	20.39	20.39	20.39	20.39	20.39		
.14	11.76	33.33	34.50	33.95	33.88	33.88	33.88	33.88	33.88	33.88	33.88	33.88	33.88	33.88	33.88	33.88	.84	24.07	22.00	21.24	20.76	20.49	20.30	20.17	20.13	20.13	20.12	20.10	20.09	20.08	20.08	20.08	20.08	20.08		
.15	9.76	33.25	34.16	33.46	33.27	33.02	32.85	32.85	32.85	32.85	32.85	32.85	32.85	32.85	32.85	32.85	.85	23.67	22.67	21.67	20.93	20.51	20.30	20.20	20.19	20.18	20.18	20.17	20.17	20.17	20.17	20.17	20.17	20.17		
.16	7.66	24.67	33.61	32.91	32.66	32.49	32.49	32.49	32.49	32.49	32.49	32.49	32.49	32.49	32.49	32.49	.86	22.26	21.33	20.62	20.16	19.90	19.56	19.56	19.55	19.54	19.54	19.54	19.54	19.54	19.54	19.54	19.54	19.54		
.17	5.67	22.89	32.56	32.31	32.13	32.09	32.06	32.06	32.06	32.06	32.06	32.06	32.06	32.06	32.06	32.06	.87	22.64	21.00	20.31	19.86	19.61	19.31	19.29	19.28	19.27	19.26	19.25	19.25	19.25	19.25	19.25	19.25	19.25		
.18	3.62	20.55	32.21	31.96	31.78	31.74	31.74	31.74	31.74	31.74	31.74	31.74	31.74	31.74	31.74	31.74	.88	22.42	20.67	20.00	19.57	19.31	19.06	19.06	18.98	18.97	18.97	18.96	18.95	18.95	18.95	18.95	18.95	18.95		
.19	2.60	23.67	32.78	32.20	31.86	31.40	31.42	31.42	31.42	31.42	31.42	31.42	31.42	31.42	31.42	31.42	.89	21.99	20.33	19.69	19.27	19.04	18.77	18.75	18.74	18.73	18.72	18.71	18.70	18.69	18.68	18.68	18.68	18.68		
.20	0.50	33.75	32.44	31.85	31.25	31.07	31.03	31.00	30.98	30.95	30.93	30.90	30.88	30.86	30.84	30.82	.90	21.55	20.00	19.38	18.94	18.75	18.60	18.50	18.44	18.43	18.42	18.41	18.41	18.41	18.41	18.41	18.41	18.41		
.21	33.44	33.00	31.31	31.16	30.72	30.63	30.63	30.63	30.63	30.63	30.63	30.63	30.63	30.63	30.63	30.63	.91	21.11	19.67	19.07	18.69	18.47	18.23	18.12	18.02	17.91	17.80	17.79	17.78	17.77	17.76	17.75	17.74	17.74		
.22	35.13	32.67	31.76	31.16	30.61	30.35	30.37	30.33	30.30	30.26	30.21	30.19	30.18	.92	20.66	19.33	18.77	18.40	18.19	18.02	17.96	17.95	17.93	17.92	17.92	17.91	17.90	17.89	17.88	17.87	17.87					
.23	34.82	32.33	31.42	30.82	30.46	30.21	30.22	30.22	30.22	30.22	30.22	30.22	30.22	30.22	30.22	30.22	.93	20.20	19.00	18.46	18.11	17.91	17.76	17.66	17.65	17.64	17.63	17.62	17.62	17.62	17.62	17.62	17.62	17.62	17.62	
.24	34.51	32.30	31.08	30.47	30.12	29.86	29.66	29.66	29.66	29.66	29.66	29.66	29.66	29.66	29.66	29.66	.94	19.74	18.67	18.16	17.67	17.43	17.42	17.41	17.40	17.39	17.38	17.37	17.36	17.36	17.36	17.36	17.36	17.36		
.25	31.20	21.67	20.74	20.13	19.79	19.44	19.18	18.91	18.65	18.40	18.15	17.90	17.65	17.40	17.15	16.90	.95	19.25	15.33	17.54	17.54	17.54	17.54	17.54	17.54	17.54	17.54	17.54	17.54	17.54	17.54	17.54	17.54	17.54	17.54	
.26	31.88	31.33	30.40	29.79	29.44	29.18	28.99	28.99	28.99	28.99	28.99	28.99	28.99	28.99	28.99	28.99	.96	18.76	16.00	17.56	17.26	17.09	16.98	16.91	16.90	16.89	16.88	16.88	16.87	16.86	16.86	16.86	16.86	16.86	16.86	16.86
.27	33.97	31.51	30.06	29.45	29.09	28.63	28.63	28.63	28.63	28.63	28.63	28.63	28.63	28.63	28.63	28.63	.97	18.25	17.67	17.23	16.87	16.52	16.22	16.02	15.82	15.62	15.42	15.22	15.02	14.82	14.62	14.42	14.22	14.02		
.28	33.25	30.47	29.73	29.11	28.76	28.29	28.31	28.27	28.26	28.22	28.19	28.15	28.13	28.12	28.11	28.10	.98	17.76	17.33	16.96	16.70	16.53	16.38	16.28	16.18	16.08	15.98	15.88	15.78	15.68	15.58	15.48	15.38	15.28	15.18	
.29	32.93	30.33	29.39	28.42	28.16	27.97	27.97	27.93	27.93	27.93	27.93	27.93	27.93	27.93	27.93	27.93	.99	17.21	17.00	16.66	16.42	16.28	16.14	16.12	16.11	16.11	16.11	16.11	16.11	16.11	16.11	16.11	16.11	16.11	16.11	
.30	32.61	30.00	29.09	26.44	26.08	27.42	27.44	27.40	27.40	27.40	27.40																									

TABLE C-5—Continued
Table for Estimating the Lot Percent Defective Using Range Method

Sample Size		Sample Size																	
of	Q _u	3	4	5	7	10	12	20	30	35	40	50	60	85	115	175	200		
1.10	9.66	12.33	12.48	12.50	12.49	12.50	12.52	12.52	12.51	12.51	12.51	12.51	12.51	12.51	12.51	12.51	12.51	12.51	
1.11	8.69	13.00	13.20	13.24	13.25	13.27	13.29	13.30	13.31	13.31	13.32	13.32	13.32	13.32	13.32	13.32	13.32	13.32	
1.12	7.82	12.49	12.93	12.99	13.02	13.04	13.07	13.08	13.09	13.10	13.10	13.12	13.12	13.12	13.12	13.12	13.12	13.12	13.12
1.13	6.60	12.33	12.65	12.74	12.78	12.81	12.85	12.86	12.86	12.87	12.87	12.89	12.89	12.90	12.91	12.91	12.91	12.91	12.91
1.14	5.08	12.00	12.37	12.49	12.55	12.59	12.63	12.64	12.65	12.66	12.67	12.67	12.67	12.67	12.67	12.67	12.67	12.67	12.67
1.15	4.29	12.10	12.40	12.51	12.53	12.55	12.55	12.55	12.55	12.55	12.55	12.55	12.55	12.55	12.55	12.55	12.55	12.55	12.55
1.16	3.00	11.33	11.43	12.00	12.15	12.21	12.25	12.25	12.25	12.25	12.25	12.25	12.25	12.25	12.25	12.25	12.25	12.25	12.25
1.17	2.00	11.00	11.56	11.76	11.93	12.00	12.03	12.03	12.03	12.03	12.03	12.03	12.03	12.03	12.03	12.03	12.03	12.03	12.03
1.18	1.67	11.29	11.58	11.74	11.88	11.96	11.96	11.96	11.96	11.96	11.96	11.96	11.96	11.96	11.96	11.96	11.96	11.96	11.96
1.19	0.90	10.33	11.02	11.29	11.50	11.56	11.60	11.63	11.63	11.63	11.63	11.63	11.63	11.63	11.63	11.63	11.63	11.63	11.63
1.20	0.00	10.76	11.05	11.19	11.29	11.38	11.40	11.41	11.43	11.43	11.43	11.43	11.43	11.43	11.43	11.43	11.43	11.43	11.43
1.21	0.00	9.47	10.50	10.82	10.97	11.08	11.15	11.20	11.21	11.21	11.24	11.26	11.27	11.29	11.30	11.30	11.30	11.30	11.30
1.22	0.00	9.23	10.39	10.76	10.85	10.96	11.00	11.06	11.06	11.06	11.09	11.10	11.10	11.10	11.10	11.10	11.10	11.10	11.10
1.23	0.00	9.00	9.97	10.36	10.54	10.74	10.80	10.82	10.82	10.85	10.89	10.90	10.91	10.91	10.91	10.91	10.91	10.91	10.91
1.24	0.00	8.47	9.72	10.33	10.47	10.53	10.61	10.64	10.64	10.67	10.70	10.73	10.73	10.73	10.73	10.73	10.73	10.73	10.73
1.25	0.00	8.23	9.46	9.91	10.12	10.27	10.39	10.42	10.44	10.47	10.49	10.51	10.54	10.54	10.54	10.54	10.54	10.54	10.54
1.26	0.00	8.00	9.00	9.21	9.49	9.92	10.06	10.20	10.24	10.26	10.30	10.33	10.34	10.36	10.36	10.36	10.36	10.36	10.36
1.27	0.00	7.67	8.76	9.47	9.71	9.88	10.01	10.05	10.07	10.09	10.11	10.13	10.15	10.18	10.18	10.18	10.18	10.18	10.18
1.28	0.00	7.33	8.71	9.25	9.31	9.49	9.53	9.67	9.71	9.75	9.77	9.81	9.83	9.87	9.91	9.93	9.97	9.99	10.00
1.29	0.00	7.00	8.46	9.04	9.21	9.50	9.64	9.68	9.71	9.72	9.75	9.77	9.79	9.81	9.83	9.85	9.87	9.89	9.90
1.30	0.00	6.87	8.21	8.43	8.73	8.97	9.13	9.32	9.47	9.51	9.53	9.55	9.58	9.62	9.64	9.65	9.67	9.68	9.69
1.31	0.00	6.33	7.97	8.62	8.92	9.13	9.29	9.33	9.35	9.37	9.40	9.42	9.45	9.47	9.48	9.49	9.51	9.52	9.53
1.32	0.00	5.97	7.73	8.43	8.75	9.05	9.11	9.13	9.18	9.20	9.25	9.30	9.31	9.31	9.31	9.31	9.31	9.31	9.31
1.33	0.00	5.57	7.49	8.20	8.54	8.77	8.86	8.86	8.86	8.86	8.91	8.94	8.96	8.96	8.96	8.96	8.96	8.96	8.96
1.34	0.00	5.33	7.25	8.00	8.35	8.59	8.77	8.81	8.84	8.86	8.89	8.91	8.94	8.96	8.96	8.96	8.96	8.96	8.96
1.35	0.00	5.00	7.02	7.80	8.16	8.41	8.60	8.64	8.67	8.69	8.73	8.75	8.76	8.82	8.82	8.85	8.85	8.85	8.85
1.36	0.00	4.47	6.79	7.98	8.26	8.43	8.68	8.83	8.96	9.01	9.12	9.25	9.36	9.46	9.46	9.47	9.47	9.47	9.47
1.37	0.00	4.33	6.26	7.40	7.80	8.07	8.27	8.31	8.34	8.37	8.40	8.43	8.46	8.50	8.50	8.53	8.53	8.53	8.53
1.38	0.00	4.00	6.33	7.21	7.62	7.90	8.11	8.15	8.18	8.21	8.25	8.26	8.30	8.34	8.35	8.37	8.37	8.37	8.37
1.39	0.00	3.67	6.10	7.02	7.45	7.73	7.95	8.02	8.05	8.09	8.11	8.14	8.17	8.19	8.19	8.21	8.21	8.21	8.21
1.40	0.00	3.33	5.88	6.83	7.27	7.37	7.79	7.84	7.88	7.90	7.93	7.96	8.00	8.02	8.04	8.04	8.04	8.04	8.04
1.41	0.00	3.00	5.66	6.45	7.10	7.41	7.63	7.68	7.71	7.76	7.81	7.87	7.89	7.91	7.91	7.91	7.91	7.91	7.91
1.42	0.00	2.67	5.44	6.46	6.93	7.25	7.48	7.53	7.56	7.60	7.72	7.74	7.76	7.77	7.77	7.77	7.77	7.77	7.77
1.43	0.00	2.33	5.23	6.28	6.76	7.09	7.33	7.36	7.41	7.44	7.57	7.59	7.60	7.63	7.63	7.63	7.63	7.63	7.63
1.44	0.00	2.00	5.01	6.10	6.60	6.93	7.28	7.24	7.28	7.30	7.34	7.43	7.46	7.46	7.46	7.46	7.46	7.46	7.46
1.45	0.00	1.67	4.83	5.39	6.44	6.78	7.03	7.09	7.13	7.17	7.22	7.27	7.32	7.32	7.32	7.32	7.32	7.32	7.32
1.46	0.00	1.33	4.60	5.75	6.26	6.43	6.74	6.80	6.85	6.87	6.92	6.95	7.01	7.04	7.04	7.04	7.04	7.04	7.04
1.47	0.00	1.00	4.39	5.38	6.10	6.60	6.80	6.86	6.91	6.95	6.99	7.03	7.07	7.10	7.10	7.10	7.10	7.10	7.10
1.48	0.00	0.67	4.19	5.41	5.96	6.24	6.60	6.71	6.73	6.78	6.83	6.87	6.90	6.93	6.93	6.93	6.93	6.93	6.93
1.49	0.00	0.33	3.99	5.24	5.81	6.39	6.67	6.93	6.97	7.03	7.09	7.13	7.17	7.22	7.22	7.22	7.22	7.22	7.22

FIG. A1.16 Table C-5 Table for Estimating the Lot Percent Defective (continued)

TABLE C-5—Continued
Table for Estimating the Lot Percent Defective Using Range Method

FIG. A1.16 Table C-5 Table for Estimating the Lot Percent Defective (continued)



TABLE C-5—Continued
Table for Estimating the Lot Percent Defective Using Range Method

FIG. A1.16 Table C-5 Table for Estimating the Lot Percent Defective (continued)

TABLE C-6

Range Method

Values of T for Tightened Inspection

Sample size code letter	Acceptable Quality Levels (in percent defective)														Number of Lots
	.04	.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	4.0	6.5	10.0	15.0	
B	*	*	*	*	*	*	*	*	*	2 4 5	3 5 6	4 6 8	4 6 9	4 7 11	5 10 15
C	*	*	*	*	*	*	*	2 3 5	2 4 6	3 5 7	3 6 8	4 7 9	4 7 10	4 8 11	5 10 15
D	*	*	*	*	*	*	2 4 5	3 4 6	3 5 7	3 6 8	4 6 9	4 7 10	4 7 10	4 8 11	5 10 15
E	*	*	*	*	2 3 4	2 4 5	3 4 6	3 5 7	3 5 8	4 6 9	4 7 10	4 7 10	4 7 11	4 8 11	5 10 15
F	*	*	*	2 4 5	3 4 5	3 5 6	3 5 7	3 5 8	4 6 9	4 6 9	4 7 10	4 7 11	4 8 11	4 8 11	5 10 15
G	2 4 5	2 4 5	3 4 5	3 5 6	3 5 7	3 5 8	4 6 8	4 6 9	4 6 9	4 6 10	4 7 11	4 8 11	4 8 11	4 8 11	5 10 15
H	3 5 6	3 5 7	3 5 7	3 6 8	4 6 8	4 6 9	4 7 9	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	5 10 15
I	3 5 7	3 5 7	3 6 8	4 6 8	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	5 10 15
J	3 5 7	3 6 8	4 6 8	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
K	3 6 7	4 6 8	4 6 8	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
L	4 6 8	4 6 8	4 6 9	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
M	4 6 8	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
N	4 7 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
O	4 7 9	4 7 10	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15

*There are no sampling plans provided in this Standard for these code letters and AQL values.

FIG. A1.17 Table C-6 Values of T for Tightened Inspection

TABLE C-6—Continued
Values of T for Tightened Inspection

Range Method

Sample size code letter	Acceptable Quality Levels (in percent defective)														Number of Lots
	.04	.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	4.0	6.5	10.0	15.0	
P	4	4	4	4	4	4	4	4	4	4	4	4	4	4	5
	7	7	7	7	7	8	8	8	8	8	8	8	8	8	10
	10	10	10	10	10	11	11	11	11	11	11	11	11	12	15
Q	4	4	4	4	4	4	4	4	4	4	4	4	4	4	5
	7	7	7	8	8	8	8	8	8	8	8	8	8	8	10
	10	10	10	10	11	11	11	11	11	11	11	11	11	12	15

The top figure in each block refers to the preceding 5 lots, the middle figure to the preceding 10 lots and the bottom figure to the preceding 15 lots.

Tightened inspection is required when the number of lots with estimates of percent defective above the AQL from the preceding 5, 10, or 15 lots is greater than the given value of T in the table, and the process average from these lots exceeds the AQL.

All estimates of the lot percent defective are obtained from Table C-5.

FIG. A1.17 Table C-6 Values of T for Tightened Inspection (continued)

TABLE C-7
Limits of Estimated Lot Percent Defective for Reduced Inspection

Sample size code letter	Acceptable Quality Levels										Number of Lots
	.04	.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	
B	*	*	*	*	*	*	*	*	*	[42]**	[18]** [12]** [9]**
C	*	*	*	*	*	*	[45]**	[31]**	[22]**	[15]**	[10]** [7]** .77 5 10 15
D	*	*	*	*	*	*	[33]**	[25]**	[18]**	[13]** [9]**	0.00 0.74 6.06 5 10 15
E	*	*	*	*	*	*	[30]**	[23]**	[17]**	[10]**	.35 4.40 9.96 15.00 10 15
F	*	*	*	*	[19]**	[14]**	[11]**	[1.08]	.000 .040 .148 .536	.00 0.79 3.52 8.45 5 10 15	
G	[12]**	[10]**	[8]**	.000	.000	.006	.040	.148	.322 3.01 6.06 10.00 15.00 10 15		
H	.000	.000	.002	.004	.014	.042	.112	.248	.498 1.12 2.20 4.27 7.40 12.13 5 10 15		
I	.001	.002	.004	.010	.028	.069	.162	.326	.608 1.27 2.42 4.52 7.68 12.43 5 10 15		
J	.001	.004	.007	.017	.042	.094	.202	.386	.691 1.39 2.57 4.71 7.91 12.65 5 10 15		
	.010	.021	.042	.075	.151	.281	.516	.867	.1.39 2.47 4.00 6.50 10.00 15.00 10 15		
	.022	.044	.079	.133	.248	.40	.65	1.00	1.50 2.50		

* There are no sampling plans provided in this Standard for these code letters and AQL values.

FIG. A1.18 Table C-7 Limits of Estimated Lot Percent Defective for Reduced Inspection



TABLE C-7—Continued
Limits of Estimated Lot Percent Defective for Reduced Inspection

Sample size code letter	.04	Acceptable Quality Levels										Number of Lots	
		.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	4.0	6.5	
K	.002	.005	.012	.024	.056	.114	.235	.435	.758	1.48	2.69	4.86	8.06
	.013	.027	.049	.087	.167	.302	.544	.899	1.43	2.50	4.00	6.50	10.00
	.026	.050	.088	.144	.25	.40	.65	1.00	1.50	▲	▲	▲	▲
L	.004	.010	.020	.036	.076	.148	.288	.509	.857	1.62	2.86	5.07	8.31
	.018	.036	.062	.102	.190	.332	.581	.942	1.47	2.50	4.00	6.50	10.00
	.033	.059	.099	.15	.25	.40	.65	1.00	1.50	▲	▲	▲	▲
M	.007	.014	.026	.046	.092	.174	.326	.562	.927	1.72	2.99	5.22	8.48
	.023	.041	.069	.112	.206	.352	.604	.968	1.50	2.50	4.00	6.50	10.00
	.036	.064	.10	.15	.25	.40	.65	1.00	1.50	▲	▲	▲	▲
N	.012	.022	.038	.064	.122	.216	.389	.648	1.041	1.87	3.19	5.46	8.76
	.028	.051	.082	.129	.226	.378	.636	1.00	1.50	2.50	4.00	6.50	10.00
	.042	.065	.10	.15	.25	.40	.65	1.00	1.50	▲	▲	▲	▲
O	.015	.029	.048	.078	.144	.246	.434	.709	1.119	1.98	3.32	5.63	8.95
	.033	.056	.089	.139	.238	.393	.65	1.00	1.50	2.50	4.00	6.50	10.00
	.04	.065	.10	.15	.25	.40	▲	▲	▲	▲	▲	▲	▲
P	.021	.036	.059	.093	.166	.280	.480	.771	1.199	2.08	3.46	5.80	9.15
	.036	.061	.095	.146	.248	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00
	.04	.065	.10	.15	.25	▲	▲	▲	▲	▲	▲	▲	▲
Q	.024	.040	.065	.103	.179	.300	.507	.808	1.248	2.15	3.54	5.90	9.27
	.038	.063	.099	.149	.25	.40	.65	1.00	1.50	2.50	4.00	6.50	10.00
	.04	.065	.10	.15	▲	▲	▲	▲	▲	▲	▲	▲	▲

All AQL and table values, except those in the brackets, are in percent defective.

▲Use the first figure in direction of arrow and corresponding number of lots. In each block the top figure refers to the preceding 5 lots, the middle figure to the preceding 10 lots, and the bottom figure to the preceding 15 lots.

Reduced inspection may be instituted when every estimated lot percent defective from the preceding 5, 10, or 15 lots is below the figure given in the table; reduced inspection for sampling plans marked (**) in the table requires that the estimated lot percent defective is equal to zero for the number of consecutive lots indicated in brackets. In addition, all other conditions for reduced inspection, in Part III of Section C, must be satisfied.

All estimates of the lot percent defective are obtained from Table C-5.

FIG. A1.18 Table C-7 Limits of Estimated Lot Percent Defective for Reduced Inspection (continued)



TABLE C-8
Values of f for Maximum Average Range (MAR)

Sample size code letter	Sample size	Acceptable Quality Levels (in percent defective)											
		.04	.065	.10	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50
B	3												
C	4												
D	5												
E	7												
F	10												
G	15	.444	.460	.477	.493	.517	.542	.572	.602	.637	.688	.748	.830
H	25	.416	.432	.447	.463	.486	.509	.537	.567	.600	.649	.707	.785
I	30	.411	.426	.442	.457	.480	.503	.531	.560	.593	.642	.699	.776
J	35	.408	.423	.438	.454	.476	.499	.527	.556	.588	.637	.694	.771
K	40	.402	.417	.432	.447	.469	.492	.519	.548	.580	.628	.684	.761
L	50	.396	.411	.426	.441	.463	.486	.503	.542	.573	.621	.676	.752
M	60	.390	.405	.419	.434	.455	.478	.505	.533	.564	.608	.666	.740
N	85	.382	.398	.412	.427	.448	.470	.497	.525	.555	.602	.656	.729
O	115	.378	.392	.406	.421	.442	.464	.490	.517	.548	.594	.648	.720
P	175	.371	.384	.399	.413	.434	.455	.481	.508	.538	.584	.637	.708
Q	230	.369	.384	.397	.412	.432	.454	.480	.507	.536	.582	.633	.706

The MAR may be obtained by multiplying the factor f by the difference between the upper specification limit U and lower specification limit L . The formula is $\text{MAR} = f(U-L)$. The MAR serves as a guide for the magnitude of the average range of the sample when using plans for the double specification limit case, based on the average range of the sample of unknown variability. The average range of the sample, if it is less than the MAR, helps to insure, but does not guarantee, lot acceptability.

NOTE: There is a corresponding acceptability constant in Table C-1 for each value of f . For reduced inspection, find the acceptability constant of Table C-2 in Table C-1 and use the corresponding value of f .

FIG. A1.19 Table C-8 Values of f for Maximum Average Range (MAR)



TABLE D-1
Master Table for Normal and Tightened Inspection for Plans Based on Variability Known
(Single Specification Limit—Form 1)

Sample size code letter	Acceptable Quality Levels (normal inspection)												Acceptable Quality Levels (tightened inspection)		
	.04	.065	.10			.15			.25			.40	.65		
n	k	n	k	n	k	n	k	n	k	n	k	n	k	n	k
B															
C															
D															
E															
F															
G	3	2.58	3	2.49	4	2.39	4	2.30	4	2.14	5	2.05	5	1.88	
H	4	2.65	4	2.55	5	2.46	5	2.34	6	2.23	6	2.08	7	1.95	
I	5	2.69	6	2.59	6	2.49	6	2.37	7	2.25	8	2.13	8	1.96	
J	6	2.72	6	2.58	7	2.50	7	2.38	8	2.26	9	2.13	10	1.99	
K	7	2.77	7	2.63	8	2.54	9	2.45	9	2.29	10	2.16	11	2.01	
L	8	2.77	8	2.64	9	2.54	10	2.45	11	2.31	12	2.18	13	2.03	
M	10	2.83	11	2.72	11	2.59	12	2.49	13	2.35	14	2.21	16	2.07	
N	14	2.88	15	2.77	16	2.65	17	2.54	19	2.41	21	2.27	23	2.12	
O	19	2.92	20	2.80	22	2.69	23	2.57	25	2.43	27	2.29	30	2.14	
P	27	2.96	30	2.84	31	2.72	34	2.62	37	2.47	40	2.33	44	2.17	
Q	37	2.97	40	2.85	42	2.73	45	2.62	49	2.48	54	2.34	59	2.18	
	.065		.10		.15		.25		.40		.65		.00		

All AQL values are in percent defective.

↓ Use first sampling plan below arrow, that is, both sample size as well as k value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.20 Table D-1 Master Table for Normal and Tightened Inspection (Form 1 - Single Limit)



TABLE D-1—Continued
Master Table for Normal and Tightened Inspection for Plans Based on Variability Known
(Single Specification Limit—Form 1)

Sample size code letter	Acceptable Quality Levels (normal inspection)												15.00				
	1.00			1.50			2.50			4.00			6.50			10.00	
n	k	n	k	n	k	n	k	n	k	n	k	n	k	n	k	n	k
B																	
C	2	1.36	2	1.25	2	1.09	2	.936	3	.755	3	.573	3	.344			
D	2	1.42	2	1.33	3	1.17	3	1.01	3	.825	4	.641	4	.429			
E	3	1.56	3	1.44	4	1.28	4	1.11	5	.919	5	.728	6	.515			
F	4	1.69	4	1.53	5	1.39	5	1.20	6	.991	7	.797	8	.584			
G	6	1.78	6	1.62	7	1.45	8	1.28	9	1.07	11	.877	12	.649			
H	7	1.80	8	1.68	9	1.49	10	1.31	12	1.11	14	.906	16	.685			
I	9	1.83	10	1.70	11	1.51	13	1.34	15	1.13	17	.924	20	.706			
J	11	1.86	12	1.72	13	1.53	15	1.35	18	1.15	21	.942	24	.719			
K	12	1.88	14	1.75	15	1.56	18	1.38	20	1.17	24	.964	27	.737			
L	14	1.89	15	1.75	18	1.57	20	1.38	23	1.17	27	.965	31	.741			
M	17	1.93	19	1.79	22	1.61	25	1.42	29	1.21	33	.995	38	.770			
N	25	1.97	28	1.84	32	1.65	36	1.46	42	1.24	49	1.03	56	.803			
O	33	2.00	36	1.86	42	1.67	48	1.48	55	1.26	64	1.05	75	.819			
P	49	2.03	54	1.89	61	1.69	70	1.51	82	1.29	95	1.07	111	.841			
Q	65	2.04	71	1.89	81	1.70	93	1.51	109	1.29	127	1.07	147	.845			
	1.50	2.50		4.00		6.50		10.00		15.00							
															Acceptable Quality Levels (tightened inspection)		

All AQL values are in percent defective.
 Use first sampling plan below arrow, that is, both sample size as well as k value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.20 Table D-1 Master Table for Normal and Tightened Inspection (Form 1 - Single Limit) (continued)



TABLE D-2
Master Table for Reduced Inspection for Plans Based on Variability Known
 (Single Specification Limit—Form 1)

Sample size code letter	Acceptable Quality Levels						
	.04	.065	.10	.15	.25	.40	.65
n	k	n	k	n	k	n	k
B							
C							
D							
E							
F							
G							
H							
I							
J							
K	3 2.49	4 2.39	4 2.30	4 2.14	5 2.05	5 1.88	6 1.78
L	4 2.55	5 2.46	5 2.34	6 2.23	6 2.08	7 1.95	7 1.80
M	4 2.55	5 2.46	5 2.34	6 2.23	6 2.08	7 1.95	7 1.80
N	6 2.59	6 2.49	6 2.37	7 2.25	8 2.13	8 1.96	9 1.83
O	6 2.58	7 2.50	7 2.38	8 2.26	9 2.13	10 1.99	11 1.86
P	11 2.72	11 2.59	12 2.49	13 2.35	14 2.21	16 2.07	17 1.93
Q	15 2.77	16 2.65	17 2.54	19 2.41	21 2.27	23 2.12	25 1.97

All AQL values are in percent defective.

Use first sampling plan below arrow, that is, both sample size as well as k value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.21 Table D-2 Master Table for Reduced Inspection (Form 1 - Single Limit)



TABLE D-2—Continued
Master Table for Reduced Inspection for Plans Based on Variability Known
(Single Specification Limit—Form 1)

Sample size code letter	Acceptable Quality Levels											
	1.00		1.50		2.50		4.0		6.5		10.00	
	n	k	n	k	n	k	n	k	n	k	n	k
B												
C												
D												
E												
F	2	1.25	2	1.09	2	.936	3	.755	3	.573	4	.344
G	2	1.33	3	1.17	3	1.01	3	.825	4	.641	4	.429
H	3	1.44	4	1.28	4	1.11	5	.919	5	.728	6	.515
I	4	1.53	5	1.39	5	1.20	6	.991	7	.797	8	.584
J	4	1.53	5	1.39	5	1.20	6	.991	7	.797	8	.584
K	6	1.62	7	1.45	8	1.28	9	1.07	11	.877	12	.649
L	8	1.68	9	1.49	10	1.31	12	1.11	14	.906	16	.685
M	8	1.68	9	1.49	10	1.31	12	1.11	14	.906	16	.685
N	10	1.70	11	1.51	13	1.34	15	1.13	17	.924	20	.706
O	12	1.72	13	1.53	15	1.35	18	1.15	21	.942	24	.719
P	19	1.79	22	1.61	25	1.42	29	1.21	33	.995	38	.770
Q	28	1.84	32	1.65	36	1.46	42	1.24	49	1.03	56	.803

All AQL values are in percent defective.

Use first sampling plan below arrow, that is, both sample size as well as k value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.21 Table D-2 Master Table for Reduced Inspection (Form 1 - Single Limit) (continued)



TABLE D-3
Master Table for Normal and Tightened Inspection for Plans Based on Known Variability
(Double Specification Limit and Form 2-Single Specification Limit)

Sample size code letter	Acceptable Quality Levels (normal inspection)						Acceptable Quality Levels (tightened inspection)														
	.04	.065	.10	.15	.25	.40	.65	.04	.065	.10	.15	.25	.40	.65							
n	M	v	n	M	v	n	M	v	n	M	v	n	M	v							
B																					
C																					
D																					
E																					
F																					
G	3	.079	1.225	3	.114	1.225	4	.290	1.155	4	.399	1.155	4	.681	1.155	5	1.09	1.118	5	1.76	1.118
H	4	.111	1.115	4	.161	1.155	5	.296	1.118	5	.445	1.118	6	.721	1.095	6	1.14	1.095	7	1.75	1.080
I	5	.130	1.118	6	.230	1.095	6	.321	1.095	6	.478	1.095	7	.756	1.080	8	1.14	1.069	8	1.80	1.069
J	6	.145	1.095	6	.234	1.095	7	.343	1.080	7	.507	1.080	8	.791	1.069	9	1.13	1.061	10	1.79	1.054
K	7	.141	1.080	7	.226	1.080	8	.330	1.069	9	.469	1.061	9	.760	1.061	10	1.14	1.054	11	1.73	1.049
L	8	.153	1.069	8	.243	1.069	9	.351	1.061	10	.494	1.054	11	.768	1.049	12	1.15	1.045	13	1.74	1.041
M	10	.141	1.054	11	.217	1.049	11	.326	1.049	12	.461	1.045	13	.721	1.041	14	1.08	1.038	16	1.62	1.003
N	14	.138	1.038	15	.211	1.035	16	.308	1.033	17	.438	1.031	19	.673	1.027	21	1.00	1.025	23	1.51	1.023
O	19	.134	1.027	20	.207	1.026	22	.296	1.024	23	.423	1.023	25	.655	1.021	27	.980	1.019	30	1.47	1.017
P	27	.129	1.019	30	.193	1.017	31	.283	1.017	34	.397	1.015	37	.615	1.014	40	.921	1.013	44	1.39	1.012
Q	37	.130	1.014	40	.196	1.013	42	.285	1.012	45	.402	1.011	49	.620	1.010	54	.920	1.009	59	1.39	1.009
		.065			.10			.15		.25		.40		.65			.40		.65		1.00

Acceptable Quality Levels (tightened inspection)

All AQL and table values are in percent defective.
 ↓ Use first sampling plan below arrow, that is, both sample size as well as M value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.22 Table D-3 Master Table for Normal and Tightened Inspection (Double Limit and Form 2 - Single Limit)



TABLE D-3—Continued
Master Table for Normal and Tightened Inspection for Plans Based on Known Variability
(Double Specification Limit and Form 2—Single Specification Limit)

Sample size code letter	Acceptable Quality Levels (normal inspection)												Acceptable Quality Levels (tightened inspection)											
	1.00			1.50			2.50			4.00			6.50			10.00			15.00					
n	M	v	n	M	v	n	M	v	n	M	v	n	M	v	n	M	v	n	M	v	n	M	v	
B	2.73	1.414	2	3.90	1.414	2	6.11	1.414	6	9.27	1.414	3	17.74	1.225	3	24.22	1.225	4	33.67	1.155	4	33.67	1.155	
C	2	2.23	1.414	2	3.00	1.414	3	7.56	1.225	3	10.79	1.225	3	15.60	1.225	4	22.97	1.155	4	31.01	1.155	4	31.01	1.155
D	2	2.23	1.414	2	3.00	1.414	3	7.56	1.225	3	10.79	1.225	3	15.21	1.118	5	20.80	1.118	6	28.64	1.095	8	26.64	1.069
E	3	2.76	1.225	3	3.85	1.225	4	6.99	1.155	4	9.97	1.155	5	13.89	1.095	7	19.46	1.080	8	26.64	1.069	8	26.64	1.069
F	4	2.58	1.155	4	3.87	1.155	5	6.05	1.118	5	8.92	1.118	6	13.89	1.095	7	17.05	1.031	20	23.43	1.026	20	23.43	1.026
G	6	2.57	1.095	6	3.77	1.095	7	5.83	1.080	8	8.62	1.069	9	12.88	1.061	11	17.88	1.049	12	24.88	1.045	12	24.88	1.045
H	7	2.62	1.080	8	3.68	1.069	9	5.68	1.061	10	8.43	1.054	12	12.35	1.045	14	17.36	1.038	16	23.96	1.033	16	23.96	1.033
I	9	2.59	1.061	10	3.63	1.054	11	5.60	1.049	13	8.13	1.041	15	12.04	1.035	17	17.05	1.031	20	23.43	1.026	20	23.43	1.026
J	11	2.57	1.049	12	3.61	1.045	13	5.58	1.041	15	8.13	1.035	18	11.88	1.029	21	16.71	1.025	24	23.13	1.022	24	23.13	1.022
K	12	2.49	1.045	14	3.43	1.038	15	5.34	1.035	18	7.72	1.029	20	11.57	1.026	24	16.23	1.022	27	22.63	1.019	27	22.63	1.019
L	14	2.51	1.038	15	3.54	1.035	18	5.29	1.029	20	7.80	1.026	23	11.56	1.023	27	16.27	1.019	31	22.57	1.017	31	22.57	1.017
M	17	2.35	1.031	19	3.28	1.027	22	4.98	1.024	25	7.34	1.021	39	10.93	1.018	33	15.61	1.016	38	21.77	1.013	38	21.77	1.013
N	25	2.19	1.021	28	3.05	1.018	32	4.68	1.016	36	6.95	1.014	42	10.40	1.012	49	14.87	1.010	56	20.90	1.009	56	20.90	1.009
O	33	2.12	1.016	36	2.99	1.014	42	4.55	1.012	48	6.75	1.011	55	10.17	1.009	64	14.58	1.008	75	20.48	1.007	75	20.48	1.007
P	49	2.00	1.010	54	2.82	1.009	61	4.35	1.008	70	6.48	1.007	82	9.76	1.006	95	14.09	1.005	111	19.90	1.005	111	19.90	1.005
Q	65	2.00	1.008	71	2.82	1.007	81	4.34	1.006	93	6.46	1.005	109	9.73	1.005	127	14.02	1.004	147	19.84	1.003	147	19.84	1.003
	1.50		2.50		4.00		6.50		10.00		10.00		15.00											

All AQL and table values are in percent defective.

Use first sampling plan below arrow, that is, both sample size as well as M value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.22 Table D-3 Master Table for Normal and Tightened Inspection (Double Limit and Form 2 - Single Limit) (continued)



TABLE D-4
Master Table for Reduced Inspection for Plans Based on Known Variability
(Double Specification Limit and Form 2—Single Specification Limit)

Sample size code letter	Acceptable Quality Levels											
	.04	.065	.10	.15	.25	.40	.65					
n	M	v	n	M	v	n	M	v	n	M	v	
B												
C												
D												
E												
F												
G												
H												
I												
J												
K	3 .114	1.225	4 .290	1.155	4 .399	1.155	4 .681	1.155	5 .09	1.118	5 .176	1.118
L	4 .161	1.155	5 .296	1.118	5 .445	1.118	6 .721	1.095	6 .14	1.095	7 .75	1.080
M	4 .161	1.155	5 .296	1.118	5 .445	1.118	6 .721	1.095	6 .14	1.095	7 .75	1.080
N	6 .230	1.095	6 .321	1.095	6 .478	1.095	7 .756	1.080	8 .14	1.069	8 .180	1.069
O	6 .234	1.095	7 .343	1.080	7 .507	1.080	8 .791	1.069	9 .18	1.061	10 .79	1.054
P	11 .217	1.049	11 .326	1.049	12 .461	1.045	13 .721	1.041	14 .08	1.038	16 .62	1.033
Q	15 .211	1.035	16 .308	1.033	17 .438	1.031	19 .673	1.027	21 .00	1.025	23 .51	1.023

All AQL and table values are in percent defective.

Use first sampling plan below arrow, that is, both sample size as well as M value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1.23 Table D-4 Master Table for Reduced Inspection (Double Limit and Form 2 - Single Limit)



TABLE D-4—Continued
Master Table for Reduced Inspection for Plans Based on Known Variability
(Double Specification Limit and Form 2—Single Specification Limit)

Sample size code letter	Acceptable Quality Levels																	
	1.00			1.50			2.50			4.0			6.5			10.00		
n	M	v	n	M	v	n	M	v	n	M	v	n	M	v	n	M	v	
B																		
C																		
D																		
E																		
F	2	3.90	1.414	2	6.11	1.414	2	9.27	1.414	3	17.74	1.225	3	24.22	1.225	4	33.67	1.225
G	2	3.00	1.414	3	7.56	1.225	3	10.79	1.225	3	15.60	1.225	4	22.97	1.155	4	31.01	1.155
H	3	3.85	1.225	4	6.99	1.155	4	9.97	1.155	5	15.21	1.118	5	20.80	1.118	6	28.64	1.095
I	4	3.87	1.155	5	6.05	1.118	5	8.92	1.118	6	13.89	1.095	7	19.46	1.080	8	26.64	1.069
J	4	3.87	1.155	5	6.05	1.118	5	8.92	1.118	6	13.89	1.095	7	19.46	1.080	8	26.64	1.069
K	6	3.77	1.095	7	5.83	1.080	8	8.62	1.069	9	12.88	1.061	11	17.88	1.049	12	24.88	1.045
L	8	3.68	1.069	9	5.68	1.061	10	8.43	1.054	12	12.35	1.045	14	17.36	1.038	16	23.96	1.033
M	8	3.68	1.069	9	5.68	1.061	10	8.43	1.054	12	12.35	1.045	14	17.36	1.038	16	23.96	1.033
N	10	3.63	1.054	11	5.60	1.049	13	8.13	1.041	15	12.04	1.035	17	17.05	1.031	20	23.43	1.026
O	12	3.61	1.045	13	5.58	1.041	15	8.13	1.035	18	11.88	1.029	21	16.71	1.025	24	23.13	1.022
P	19	3.28	1.027	22	4.98	1.024	25	7.34	1.021	29	10.93	1.018	33	15.61	1.016	38	21.77	1.013
Q	28	3.05	1.018	32	4.68	1.016	36	6.95	1.014	42	10.40	1.012	49	14.87	1.010	56	20.90	1.009

All AQL and table values are in percent defective.
 ↓ Use first sampling plan below arrow, that is, both sample size equals as well as M value. When sample size equals or exceeds lot size, every item in the lot must be inspected.

FIG. A1-23 Table D-4 Master Table for Reduced Inspection (Double Limit and Form 2—Single Limit) (continued)



TABLE D-5
Table for Estimating the Lot Percentage Defective for Plans Based on Known Variability¹

Q_U or Q_L													
.00	.50,000												
.01	.49,601	.26	.39,743	.51	.30,203	.76	.22,363	1.01	.15,625	1.26	.10,383	1.51	.06,522
.02	.49,202	.27	.39,358	.52	.30,153	.77	.22,065	1.02	.15,386	1.27	.10,204	1.52	.06,426
.03	.48,803	.28	.38,974	.53	.29,806	.78	.21,770	1.03	.15,150	1.28	.10,027	1.53	.06,301
.04	.48,405	.29	.38,591	.54	.29,460	.79	.21,476	1.04	.14,917	1.29	.10,853	1.54	.06,178
.05	.48,006	.30	.38,209	.55	.29,116	.80	.21,186	1.05	.14,686	1.30	.10,680	1.55	.06,097
.06	.47,608	.31	.37,828	.56	.28,774	.81	.20,897	1.06	.14,457	1.31	.09,510	1.56	.05,938
.07	.47,210	.32	.37,448	.57	.28,434	.82	.20,611	1.07	.14,231	1.32	.09,342	1.57	.05,821
.08	.46,812	.33	.37,070	.58	.28,096	.83	.20,327	1.08	.14,007	1.33	.09,176	1.58	.05,705
.09	.46,414	.34	.36,693	.59	.27,760	.84	.20,045	1.09	.13,786	1.34	.09,012	1.59	.05,592
.10	.46,017	.35	.36,317	.60	.27,425	.85	.19,766	1.10	.13,567	1.35	.08,651	1.60	.05,480
.11	.45,620	.36	.35,942	.61	.27,093	.86	.19,489	1.11	.13,320	1.36	.08,691	1.61	.05,370
.12	.45,224	.37	.35,569	.62	.26,763	.87	.19,215	1.12	.13,136	1.37	.08,534	1.62	.05,262
.13	.44,828	.38	.35,197	.63	.26,435	.88	.18,943	1.13	.12,924	1.38	.08,379	1.63	.05,155
.14	.44,433	.39	.34,827	.64	.26,109	.89	.18,673	1.14	.12,724	1.39	.08,226	1.64	.05,050
.15	.44,038	.40	.34,458	.65	.25,785	.90	.18,406	1.15	.12,507	1.40	.08,076	1.65	.04,947
.16	.43,644	.41	.34,090	.66	.25,463	.91	.18,141	1.16	.12,302	1.41	.07,927	1.66	.04,846
.17	.43,251	.42	.33,724	.67	.25,143	.92	.17,879	1.17	.12,100	1.42	.07,780	1.67	.04,746
.18	.42,858	.43	.33,360	.68	.24,825	.93	.17,619	1.18	.11,900	1.43	.07,636	1.68	.04,648
.19	.42,465	.44	.32,997	.69	.24,510	.94	.17,361	1.19	.11,702	1.44	.07,493	1.69	.04,551
.20	.42,074	.45	.32,636	.70	.24,196	.95	.17,106	1.20	.11,507	1.45	.07,353	1.70	.04,457
.21	.41,683	.46	.32,276	.71	.23,885	.96	.16,853	1.21	.11,314	1.46	.07,214	1.71	.04,363
.22	.41,294	.47	.31,918	.72	.23,576	.97	.16,602	1.22	.11,123	1.47	.07,078	1.72	.04,272
.23	.40,905	.48	.31,561	.73	.23,270	.98	.16,354	1.23	.10,935	1.48	.06,944	1.73	.04,182
.24	.40,517	.49	.31,207	.74	.22,965	.99	.16,109	1.24	.10,749	1.49	.06,811	1.74	.04,093
.25	.40,129	.50	.30,854	.75	.22,663	1.00	.15,866	1.25	.10,565	1.50	.06,681	1.75	.04,006

¹Values tabulated are read in percent.

FIG. A1.24 Table D-5 Table for Estimating the Lot Percent Defective

TABLE D-6

Variability Known

Values of T for Tightened Inspection

Sample size code letter	Acceptable Quality Levels (in percent defective)														Number of Lots
	.04	.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	4.0	6.5	10.0	15.0	
B	*	*	*	*	*	*	*	*	*	*	*	*	*	*	
C	*	*	*	*	*	*	*	3 5 6	3 5 6	3 5 7	3 6 7	4 7 9	4 7 10	4 7 10	5 10 15
D	*	*	*	*	*	*	3 4 6	3 5 6	3 5 6	4 6 8	4 6 9	4 7 9	4 7 10	4 7 10	5 10 15
E	*	*	*	*	2 4 5	3 4 6	3 5 7	3 6 7	3 6 8	4 6 9	4 7 9	4 7 10	4 7 10	4 8 11	5 10 15
F	*	*	*	3 5 6	3 5 7	3 5 8	4 6 8	4 6 8	4 6 9	4 7 9	4 7 10	4 7 10	4 7 11	4 8 11	5 10 15
G	3 4 6	3 4 6	3 5 7	3 5 7	3 6 8	4 6 8	4 6 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 8 11	4 8 11	5 10 15
H	3 5 6	3 5 7	3 6 7	3 6 8	4 6 9	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 8 11	4 8 11	5 10 15
I	3 5 7	4 6 8	4 6 8	4 6 8	4 6 9	4 7 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 8 11	4 8 11	5 10 15
J	3 6 8	4 6 8	4 6 8	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
K	4 6 8	4 6 9	4 6 9	4 6 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
L	4 6 8	4 6 9	4 6 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
M	4 6 9	4 7 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
N	4 7 9	4 7 9	4 7 9	4 7 9	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	4 8 11	4 8 11	4 8 11	4 8 11	5 10 15
O	4 7 10	4 7 10	4 7 10	4 7 10	4 7 11	4 7 11	4 8 11	5 10 15							

*There are no sampling plans provided in this Standard for these code letters and AQL values.

FIG. A1.25 Table D-6 Values of T for Tightened Inspection

TABLE D-6—Continued

Variability Known

Values of T for Tightened Inspection

Sample size code letter	Acceptable Quality Levels (in percent defective)														Number of Lots
	.04	.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	4.0	6.5	10.0	15.0	
P	4	4	4	4	4	4	4	4	4	4	4	4	4	4	5
	7	7	7	7	8	8	8	8	8	8	8	8	8	8	10
	10	10	10	10	11	11	11	11	11	11	11	11	11	11	15
Q	4	4	4	4	4	4	4	4	4	4	4	4	4	4	5
	7	7	8	8	8	8	8	8	8	8	8	8	8	8	10
	10	10	11	11	11	11	11	11	11	11	11	11	11	11	15

The top figure in each block refers to the preceding 5 lots, the middle figure to the preceding 10 lots and the bottom figure to the preceding 15 lots.

Tightened inspection is required when the number of lots with estimates of percent defective above the AQL from the preceding 5, 10, or 15 lots is greater than the given value of T in the table, and the process average from these lots exceeds the AQL.

All estimates of the lot percent defective are obtained from Table D-5.

FIG. A1.25 Table D-6 Values of T for Tightened Inspection (continued)



TABLE D-7
Limits of Estimated Lot Percent Defective for Reduced Inspection

Sample size code letter	Acceptable Quality Levels										Number of Lots			
	.04	.065	.10	.15	.25	.40	.65	1.0	1.5	2.5	4.0	6.5	10.0	15.0
B	*	*	*	*	*	*	*	*	*	*	*	*	*	*
C	*	*	*	*	*	*	*	*	*	*	*	*	*	*
D	*	*	*	*	*	*	*	*	*	*	*	*	*	*
E	*	*	*	*	*	*	*	*	*	*	*	*	*	*
F	*	*	*	*	*	*	*	*	*	*	*	*	*	*
G	.001 .004 .010	.007 .029 .056	.013 .049 .090	.026 .093 .167	.078 .217 .347	.147 .385 .602	.322 .718 .900	.533 .139 1.50	.1136 2.141 2.50	.2166 3.698 4.00	.3225 3.250 6.50	.6114 5.958 10.00	10.436 9.806 15.00	5 10 15
H	.002 .009 .018	.004 .017 .033	.013 .041 .071	.022 .067 .114	.057 .147 .227	.103 .252 .382	.223 .478 .65	.375 .773 1.00	.677 1.270 1.50	.1326 2.277 2.50	.4453 3.831 4.00	7.502 10.00 10.00	12.054 11.478 15.00	5 10 15
I	.004 .014 .025	.011 .031 .051	.018 .051 .082	.030 .081 .129	.070 .164 .244	.142 .298 .40	.252 .508 .65	.457 .847 1.00	.778 1.346 1.50	.4761 2.359 2.50	4.719 3.942 4.00	7.786 6.50 10.00	12.427 10.00 15.00	5 10 15
J	.006 .018 .030	.011 .031 .051	.023 .058 .090	.038 .092 .140	.082 .177 .25	.158 .313 .40	.298 .549 .65	.516 .892 1.00	.853 1.394 1.50	.562 2.412 2.50	2.758 3.987 4.00	8.055 10.00 10.00	12.693 12.693 10.00	5 10 15
K	.008 .021 .033	.014 .036 .056	.028 .064 .096	.051 .108 .15	.091 .188 .25	.171 .326 .40	.317 .564 .65	.540 .908 1.00	.910 1.427 1.50	.641 2.449 2.50	2.891 4.00 4.00	8.205 12.848 10.00	12.848 10.00 15.00	5 10 15

*There are no sampling plans provided in this Standard for these code letters and AQL values.

FIG. A1.26 Table D-7 Limits of Estimated Lot Percent Defective for Reduced Inspection



TABLE D-7—Continued
Limits of Estimated Lot Percent Defective for Reduced Inspection

Sample size code letter	.04	.065	.10	.15	.25	.40	.65	Acceptable Quality Levels				Number of Lots
								.0	.5	1.0	1.5	
L	.009	.017	.032	.056	.107	.193	.348	.581	.934	1.732	2.960	5.131
	.023	.040	.069	.113	.203	.344	.586	.934	1.440	2.486	4.00	6.50
	.036	.060	.10	.15	.25	.40	.65	1.00	1.50	2.50	4	▲
M	.012	.023	.038	.064	.120	.211	.383	.627	1.010	1.821	3.093	5.310
	.027	.048	.076	.121	.214	.357	.608	.959	1.475	2.50	4.00	6.50
	.039	.065	.10	.15	.25	.40	.65	1.00	1.50	▲	▲	▲
N	.017	.030	.049	.080	.146	.251	.435	.705	1.113	1.959	3.272	5.546
	.032	.054	.086	.134	.232	.382	.635	.994	1.50	2.50	4.00	6.50
	.04	.065	.10	.15	.25	.40	.65	1.00	▲	▲	▲	▲
O	.020	.035	.058	.091	.161	.272	.467	.750	1.168	2.041	3.386	5.685
	.035	.058	.092	.141	.241	.392	.648	1.00	1.50	2.50	4.00	6.50
	.04	.065	.10	.15	.25	.40	.65	▲	▲	▲	▲	▲
P	.024	.041	.066	.103	.180	.299	.505	.803	1.239	2.132	3.509	5.852
	.037	.062	.087	.147	.249	.40	.65	1.00	1.50	2.50	4.00	6.50
	.04	.065	.10	.15	.25	▲	▲	▲	▲	▲	▲	▲
Q	.027	.045	.071	.110	.191	.316	.528	.834	1.278	2.188	3.583	5.949
	.039	.064	.099	.15	.25	.40	.65	1.00	1.50	2.50	4.00	6.50
	.04	.065	.10	▲	▲	▲	▲	▲	▲	▲	▲	▲

All AQL and table values are in percent defective.

▲Use the first figure in direction of arrow and corresponding number of lots. In each block the top figure refers to the preceding 5 lots, the middle figure to the preceding 10 lots, and the bottom figure to the preceding 15 lots.

Reduced inspection may be instituted when every estimated lot percent defective from the preceding 5, 10, or 15 lots is below the figure given in the table. In addition, all other conditions for reduced inspection, in Part III of Section D, must be satisfied.

All estimates of the lot percent defective are obtained from Table D-5.

FIG. A1.26 Table D-7 Limits of Estimated Lot Percent Defective for Reduced Inspection (continued)

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